

308

Q200304070001

Scientific Notebook # 531: Polarization
Resistance Measurements (Continues in S/N
#520)

LABORATORY NOTEBOOK

CNWRA/SwRI

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CONTROLLED
COPY 531

NOTEBOOK NO. _____

ISSUED TO PARRELL DUNN *Parrell Dunn PD*

ON _____

DEPARTMENT _____

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20.01402.571

Brian K. Derby - *B-K Derby* - BKD

JONATHAN BOST - *John Bost* - JB

—SCIENTIFIC NOTEBOOK CO.—
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INSTRUCTIONS

1. The primary purpose of this notebook is to protect your and the Company's Patent-Rights by keeping records of all original work in a form acceptable as evidence if any legal conflict arises.
2. When starting a page, enter the title, project number, and book number.
 - Use ink for permanence -- avoid pencil.
 - Record your work as you progress, including any spur-of-the-moment ideas which may be developed later.
 - Avoid making notes on loose paper to be recopied.
 - Record your work in such a manner that a co-worker can continue from where you stop. You might be ill and to protect your priority it could be urgent that the work continue while you are absent.
3. Give a complete account of your experiments and the results, both positive and negative, including your observations.
 - Record all diagrams, layouts, plans, procedures, new ideas, or anything pertinent to your work including the details of any discussions with suppliers, or other people outside the Company.
 - Do not try to erase any incorrect entries; draw lines deleting them, note the corrections, sign and date the changes. This extra care is worthwhile because of the necessity of original data to prove priority of new discoveries.
4. After entering your data, sign and date the entries.
 - Explain your work to at least two wit-

nesses who are not co-inventors, and have them sign and date the pages in the place provided.

- Record the names of operators and witnesses present during any demonstration and have at least two witnesses sign the page. If no witnesses are present during an experiment of importance, repeat it in the presence of two witnesses.

5. Since computer programs can be patented these instructions apply to the development of computer software. In this case a description of the structure and operation of the program should be recorded in the notebook, together with a basic flow diagram which illustrates the essential features of the program. In the course of developing the code, the number of lines of code written each day should be recorded in the notebook, together with a statement of the portion of the flow diagram to which the section of code is directed.

6. This notebook and its contents are the exclusive property of the Company. It is confidential and the contents are not to be disclosed to anyone unless authorized by the Company. You must return it when completed, upon request, or upon termination of employment. It should be kept in a protected place. If loss occurs, notify your supervisor immediately, and make a written report describing the circumstances of the loss.

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Continued testing from Notebook #520 and 528

Copied from Notebook #528

Initial Scientific notebook entry for polarization resistance measurements

Title: Polarization Resistance Tests

Tests Performed by: Darrell S. Dunn, Brian Derby, Div. 18, Jonathan Bost
Division 20 Summer Student

Objectives: Determine uniform corrosion rate of passive alloys such as Alloy 22
using polarization resistance

Equipment: Keithley 614/617. Solartron 1287 Potentiostat and CorrWare and
CorrView Software or equivalent, Electrochemical test cell.

Materials: Alloy C-22, heat 2277-8-3175. Other materials and heats to be
added and identified prior to testing.

Specimen specifications: Specimens will be equivalent to 20.01402.571.006
unless otherwise specified.

Measurement Parameters: Temperature, Potential, and Current of specimen
during test.

Required level of accuracy: Temperature ± 2 °C, Potentials ± 1 mV, Current
 ± 0.01 microamp.

Uncertainty and Sources of Error: Anodic current assumed to be from anodic
dissolution. Current from capacitive charging of the oxide film may interfere with
corrosion rate measurement.

John Bost 7/15/02

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continued testing from Notebook 520 and 528

Copied from Notebook #528

Initial Scientific notebook entry for electrochemical impedance measurements

Title: Electrochemical Impedance Tests

Tests Performed by: Darrell S. Dunn, Brian Derby, Div. 18, Jonathan Bost Division 20 Summer Student

Objectives: Determine uniform corrosion rate of passive alloys such as Alloy 22 using electrochemical impedance

Equipment: Keithley 614/617. Solartron 1287 Potentiostat, Solartron 1260 Impedance/Gain-Phase Analyzer, and ZPlot and ZView Software or equivalent, Electrochemical test cell.

Materials: Alloy C-22, heat 2277-8-3175. Other materials and heats to be added and identified prior to testing.

Specimen specifications: Specimens will be equivalent to 20.01402.571.006 unless otherwise specified.

Measurement Parameters: Temperature, Potential, and Current of specimen during test.

Required level of accuracy: Temperature $\pm 2^\circ\text{C}$, Potentials $\pm 1\text{mV}$, Current $\pm 0.01\text{ microamp}$.

Uncertainty and Sources of Error: Models for oxide solution interface. Multiple models exist and may be applicable. Models used will be identified.

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continued testing from Notebook #366, #485, #520, #528

Copied from Notebook #528

Initial Scientific notebook entry for repassivation potential measurements

Title: Alloy 22 Repassivation Tests

Tests Performed by: Darrell S. Dunn, Letai Yang, Div 20; Brian Derby, Div. 18

Objectives: Determine the effect of thermal aging time and temperature on the localized corrosion susceptibility of Alloy 22.

Equipment: Laboratory oven for exposure of test specimens at 600 to 900 $^\circ\text{C}$, Thermocouple and thermocouple meter. Keithley 614/617. Solartron 1287 Potentiostat and CorrView Software or equivalent, Electrochemical test cell.

Materials: Alloy C-22, heat 2277-8-3175. Other materials and heats to be added and identified prior to testing.

Specimen specifications: Specimens will be equivalent to 20.01402.571.006 unless otherwise specified.

Measurement Parameters: Temperature and time of exposure, Potential and Current of specimen during test.

Required level of accuracy: Temperature $\pm 2^\circ\text{C}$, Time of exposure $\pm 1\text{ minute}$, Potentials $\pm 1\text{mV}$, Current $\pm 0.01\text{ microamp}$.

Uncertainty and Sources of Error: Current measurement error can occur for localized corrosion processes because the actively corroding area is not the same as the surface area of the test specimen.

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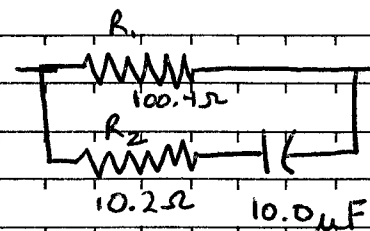
Performance Verification of Solatron 1260 Impedance Analyzer

Objective: evaluate performance of Solatron 1260 Impedance Analyzer

Test Performed by: JONATHAN BOST, Division 20 summer student
And Darrell S. Dunn

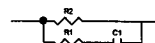
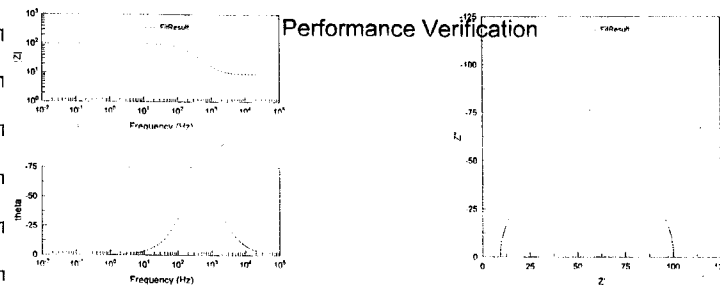
Materials and Equipment: Equipment (i.e. circuits) specified as used

Test 1: Circuit used:



$R_1 = 100.4\Omega$ Fluke 87 III RMS Multimeter
 $R_2 = 10.2\Omega$ S/N 73980493 cal: 12/21/01

Data:



Element	Freedom	Value	Error	Error %
R2	Free(+)	100.3	0.0036328	0.0036213
R1	Free(+)	10.06	0.00081811	0.0081323
C1	Free(+)	1.0095E-6	8.9011E-10	0.0095459

Chi-Squared: 2.6980E-6
Weighted Sum of Squares: 0.00034247

Data File: D:\Comsol Data\Performance Verification\15_3A_V_02.z
Circuit Model File: Run Fitting / Freq. Range (1E-5 - 20000)
Mode: 100
Maximum Iterations: 0
Optimization Iterations: 0
Type of Fitting: Complex
Type of Weighting: Calc. Modulus

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Data Consistent with model used

Continued on pg. 5

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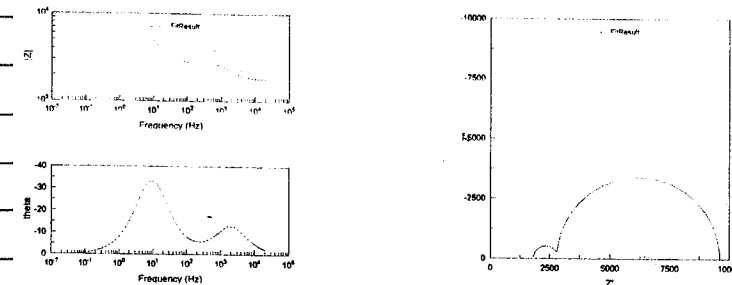
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Performance Verification of Solatron 1260 Impedance Analyzer (continued from pg. 4)

Test 2: Used circuit: Solatron 12861 ECI Test Module

Data



Performance Verification
Solatron 12861 ECI Test Module



Element	Freedom	Value	Error	Error %
R1	Free(+)	1861	0.50612	0.028102
R2	Free(+)	6785	1.0007	0.022237
C1	Free(+)	4.7539E-6	2.3725E-9	0.049908
R3	Free(+)	1000	0.87768	0.087768
C2	Free(+)	1.0078E-7	1.8156E-10	0.18031

Chi-Squared: 8.3388E-6
Weighted Sum of Squares: 0.0010423

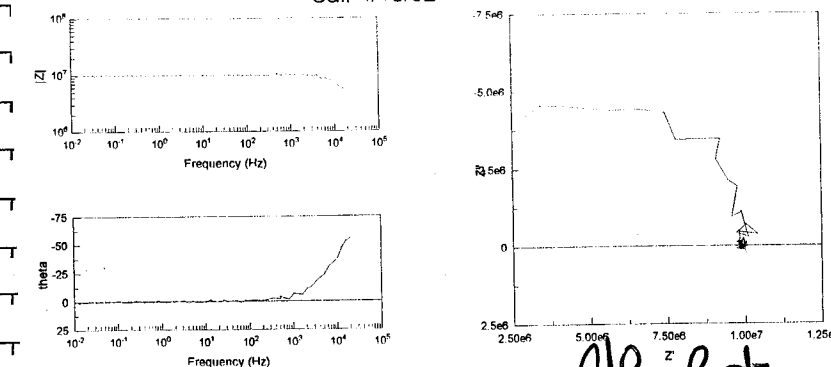
Data File: D:\Comsol Data\Performance Verification\15_3A_V_02.z
Circuit Model File: Run Fitting / Freq. Range (1E-5 - 20000)
Mode: 100
Maximum Iterations: 0
Optimization Iterations: 0
Type of Fitting: Complex
Type of Weighting: Calc. Modulus

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7/15/02

Data Consistent with values provided on the 12861 test Module

Test 3: Circuit used: 10 M Ohm Resistor

Data



Performance Verification
10 M Ohm Resistor S/N: 007243
Cal: 4/18/02

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Data consistent with the circuit.

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Polarization Resistance Test for Alloy C-22

Objective: Same as pg. 1

Specimen: C-22 Heat: ^{337146/01} 2275-2277-8-3175 polished to a 600 grit Finish

Start wt: 12.44580 g Santaricus Genius S/N 12809099 cal 6/4/02

End wt: 12.44530 g

Same test specimen as Notebook 520, pg. 8

Solution: 0.028M NaCl

3.296g NaCl Lot: 020814

+DI H₂O up to 2000ml

pH start: 5.659 Fisher Accumet 950 meter S/N 3340 cal 7/24/01

pH End: 7.023 pH probe # 13-620-296 S/N 1100208

Potentiostat: Solartron 1287

Counter Electrode: Pt flag

Reference: Fisher 13-620-52 S/N 0052132

Temperature: 40°C Hg Thermometer S/N 498-162 cal: 4/22/02

E_{me}: -136.22mV Keithley Model 614 S/N 704936 cal 5/26/02E_{pt}: 80.8 mVSolution aerated with "zero" air (79% N₂, 21% O₂, and 0% CO₂)

Specimen Examination: No staining or localized corrosion visible

continued on pg 7

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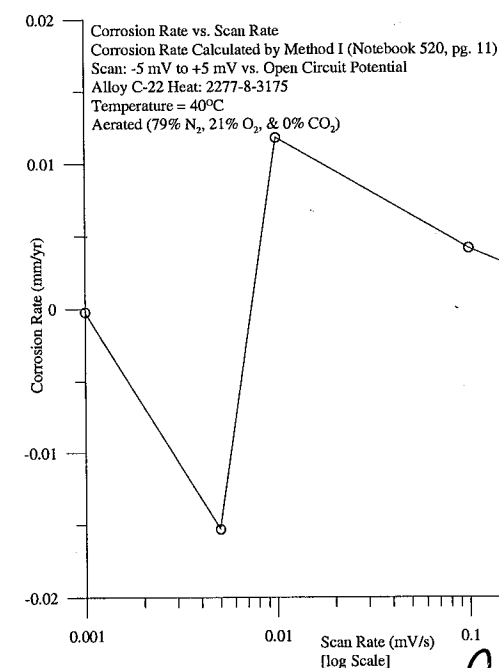
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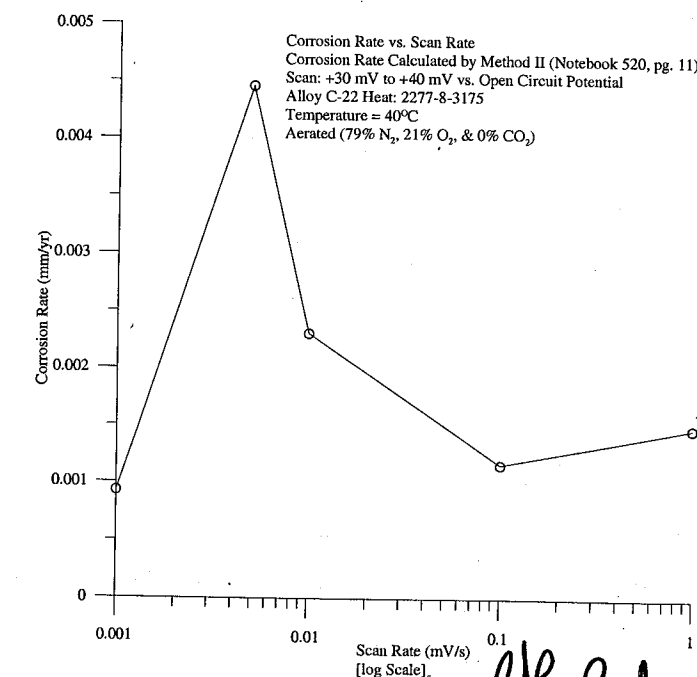
Polarization Resistance Test for Alloy C-22 continued from pg. 6

Data: Method I

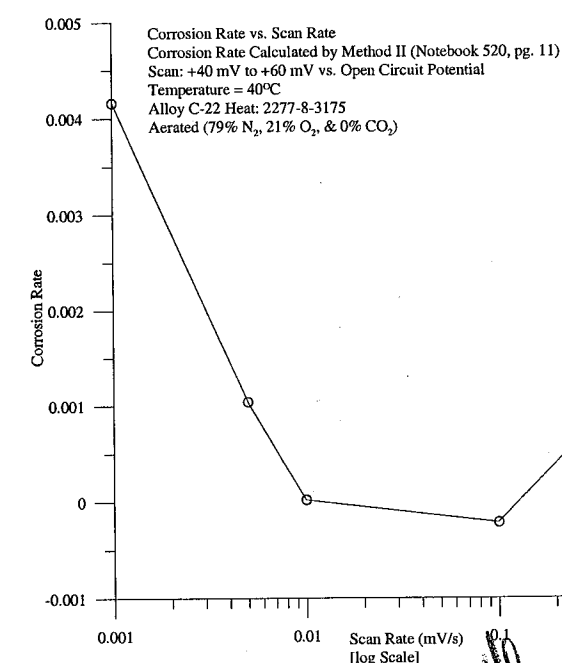


J. H. Bost 7/17/02

Method II



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Polarization Resistance Test for Alloy C-22 (continued from pg. 7)

Test: C22 lpr 66

Scan: -15 mV to +60 mV vs. open circuit potential

Scan rate: 1 mV/s

 $E_{\text{corr}} = 0.1140 \text{ V vs. SCE}$

Results: Method I (see formulas pg. 11, Note book 520)

$$(dE/dI)_{E_{\text{corr}}} = -2.90446 \times 10^{-6}$$

$$R_p = -3.4430 \times 10^5 \Omega \cdot \text{cm}^2$$

$$i_{\text{corr}} = -1.5126 \times 10^{-7} \text{ A/cm}^2$$

$$\text{C.R.} = -0.00148 \text{ mm/yr}$$

Method II (see formula in Note book 520, pg. 11)

A. For Data: +30 mV to +40 mV vs. open circuit potential
($0.1140 < E < 0.1540$)

$$b = -4.66213 \times 10^{-7}$$

$$m = 5.41149 \times 10^{-6}$$

$$i_{\text{corr}} = 1.50697 \times 10^{-7} \text{ A/cm}^2$$

$$\text{C.R.} = 1.48 \times 10^{-3} \text{ mm/yr} = 0.00148 \text{ mm/yr}$$

B. Data: +40 mV to +60 mV vs. open circuit potential
($E > 0.1540$)

$$b = -3.00492 \times 10^{-7}$$

$$m = 4.26444 \times 10^{-6}$$

$$i_{\text{corr}} = 1.85654 \times 10^{-7} \text{ A/cm}^2$$

$$\text{C.R.} = 0.00182 \text{ mm/yr}$$

Data: C22 lpr 66 (Method I) pg. 9

C22 lpr 66 (Method II) pg. 9

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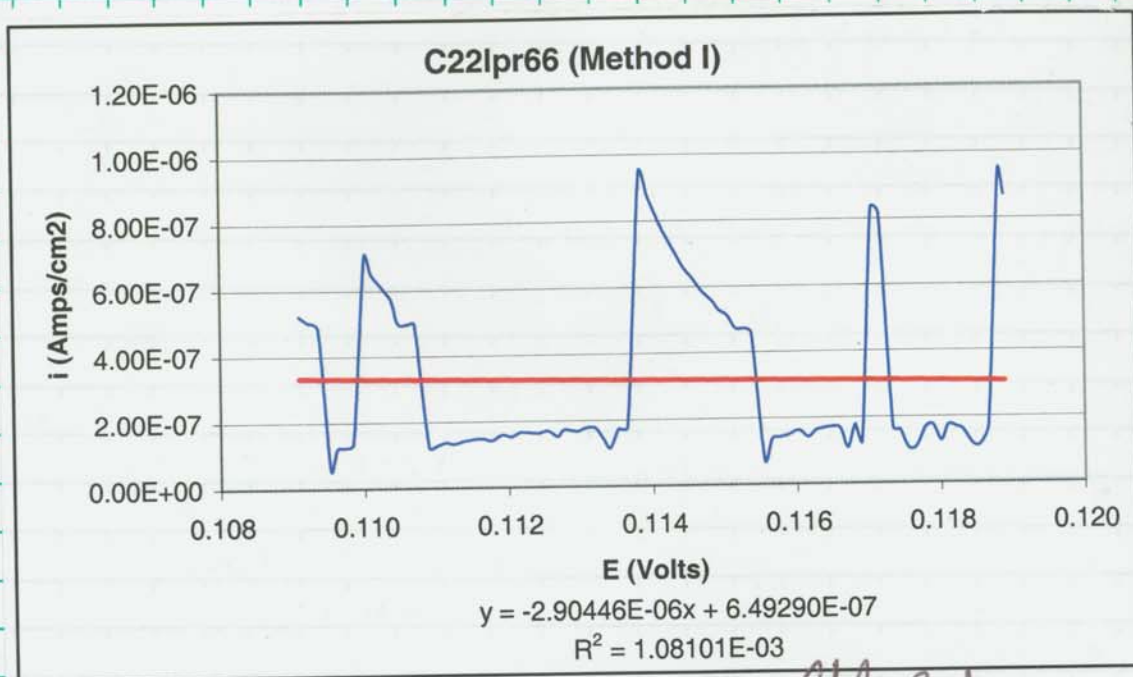
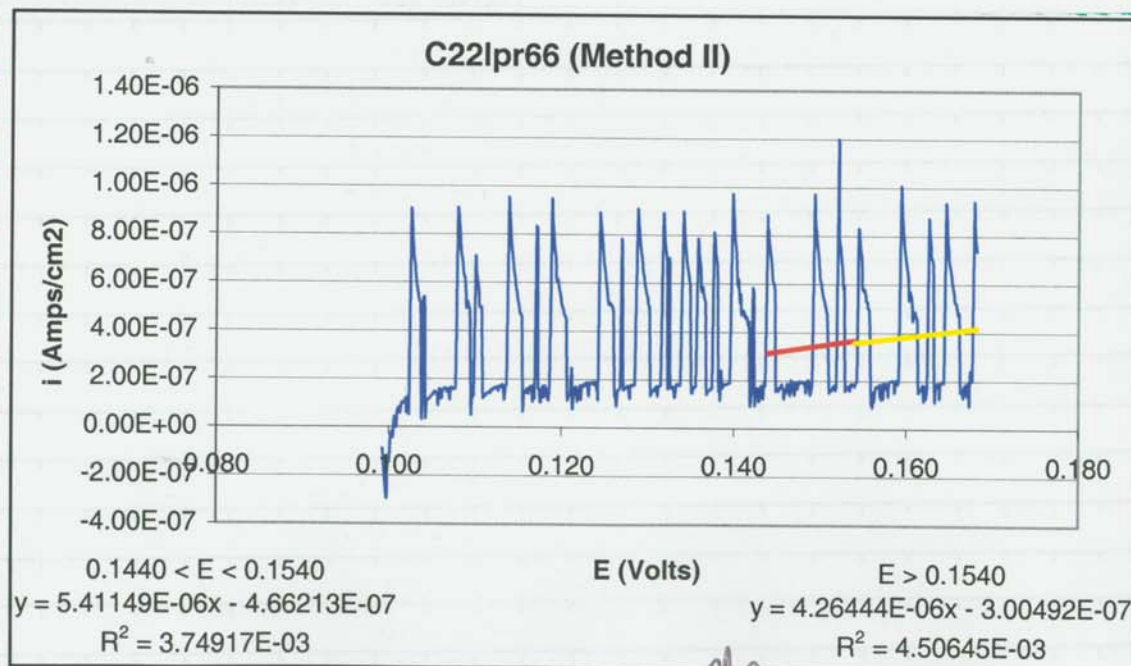
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Polarization Resistance Test for Alloy C-22 (continued from pg. 8)

Data:

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Jth Best 7/16/02

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Polarization Resistance Test for Alloy C-22 (continued from pg. 9)

Test: C22 Apr 67

Scan: -15 mV to +60 mV vs. open circuit potential

Scan rate: 0.1 mV/second

E_{corr}: 0.1267 V vs. SCE

Results: Method I (see formulas in Notebook 520, pg. 11)

$$(dE/dI)_{E_{corr}} = 8.04763 \times 10^{-6}$$

$$R_p = 1.2426 \times 10^5 \Omega \cdot \text{cm}^2$$

$$i_{corr} = 4.1912 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00411 \text{ cm}^2 \text{ mm/yr}$$

5/37/62

Method II (see formulas in Notebook 520, pg. 11)

A. Data: +30 mV to +40 mV vs. open circuit potential
(0.1567 < E < 0.1667)

$$b = -5.92628 \times 10^{-7}$$

$$m = 5.61063 \times 10^{-6}$$

$$i_{corr} = 1.18239 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00116 \text{ mm/yr}$$

B. Data: +40 mV to +60 mV vs. open circuit potential
(E > 0.1667)

$$b = -9.04723 \times 10^{-7}$$

$$m = 5.63714 \times 10^{-6}$$

$$i_{corr} = -2.20408 \times 10^{-8} \text{ A/cm}^2$$

$$C.R. = -0.000216 \text{ mm/yr}$$

Data: C22 Apr 67 (Method I) pg. 11

C22 Apr 67 (Method II) pg. 11

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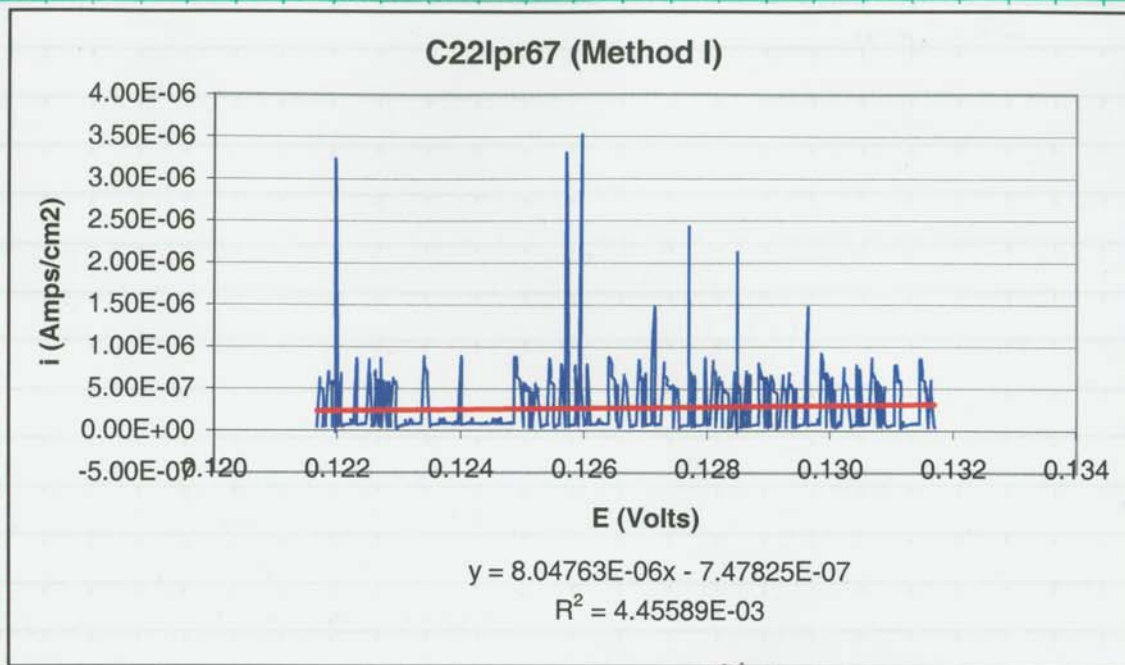
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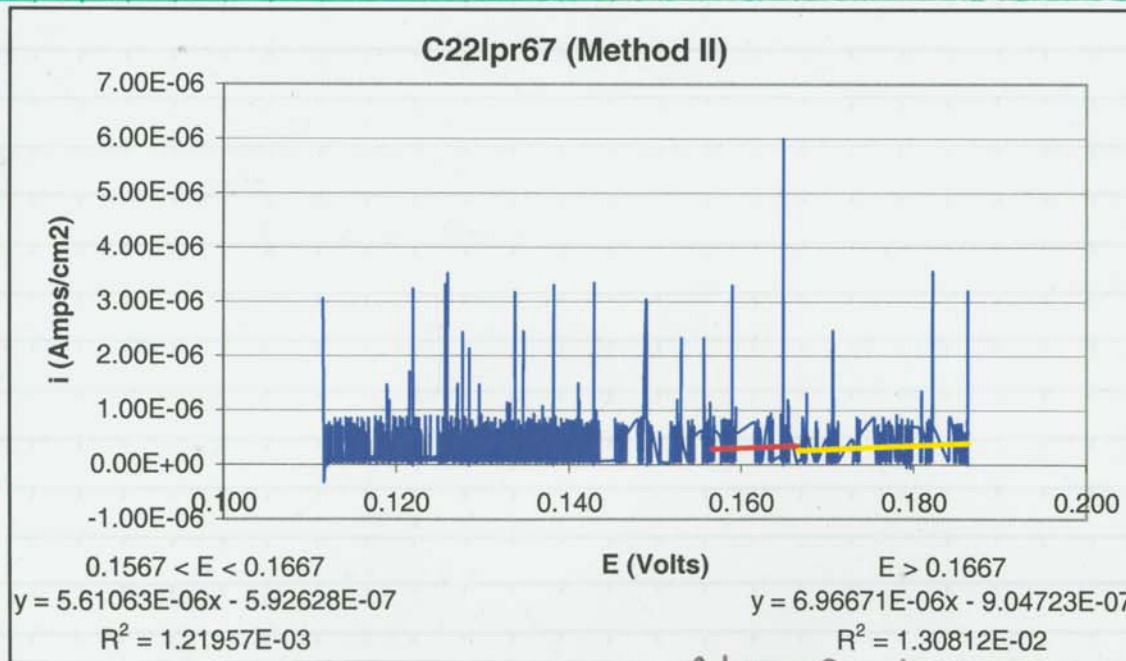
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Polarization Resistance Test for Alloy C22 (continued from pg. 10)

Data:



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Polarization Resistance Test For Alloy C-22 (continued from pg 11)

Test: C22 pr 68

Scan: -15 mV to +60 mV vs. open circuit potential

Scan Rate: 0.01 mV/second

 $E_{corr} = 0.1398 \text{ V vs. SCE}$

Results: Method I (see formulas in Notebook 520, pg. 11)

$$(dE/dI)_{E_{corr}} = 2.3151 \times 10^{-5}$$

$$R_p = 4.3194 \times 10^{-4} \Omega \cdot \text{cm}^2$$

$$i_{corr} = 1.2057 \times 10^{-6} \text{ A/cm}^2$$

$$C.R. = 0.0118 \text{ mm/yr}$$

Method II (see formulas in Notebook 520, pg. 11)

A. Data: +30 mV to +40 mV vs. open circuit potential
($0.1698 < E < 0.1798$)

$$b = -1.4415 \times 10^{-7}$$

$$m = 2.71017 \times 10^{-6}$$

$$i_{corr} = 2.34799 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00230 \text{ mm/yr}$$

B. Data: +40 mV to +60 mV vs. open circuit potential
($E > 0.1798$)

$$b = -4.97473 \times 10^{-7}$$

$$m = 2.57371 \times 10^{-6}$$

$$i_{corr} = 2.13166 \times 10^{-9} \text{ A/cm}^2$$

$$C.R. = 0.0000209 \text{ mm/yr}$$

Data: C22 pr 68 (Method I) pg 13
C22 pr 68 (Method II) pg 13

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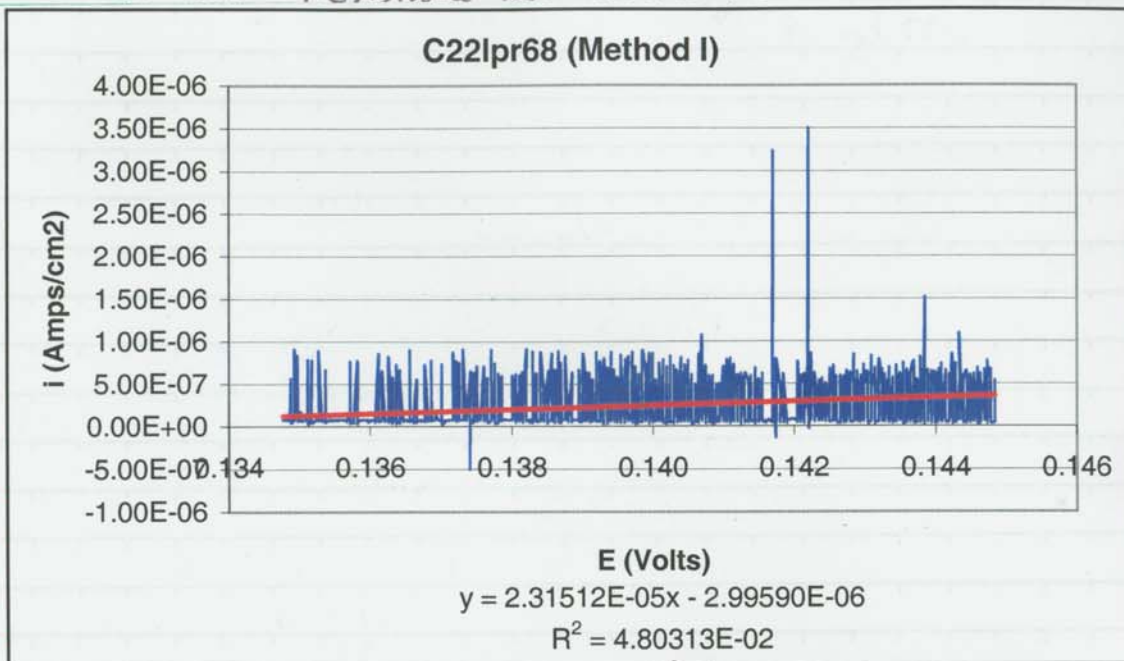
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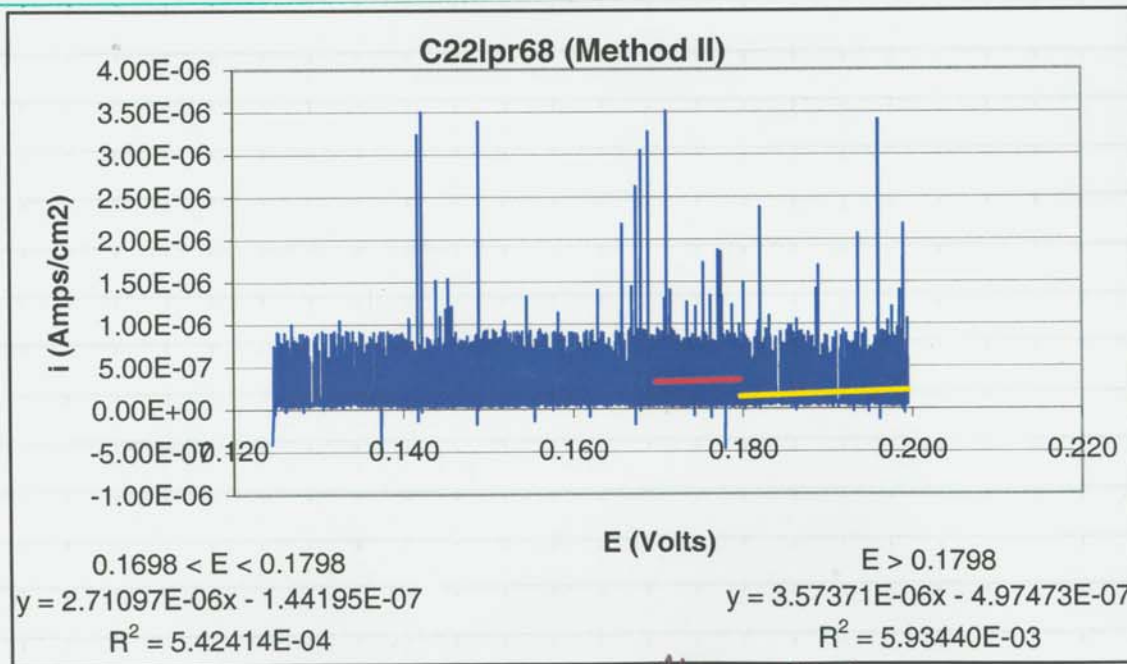
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~~Resistance Test for Alloy J3~~ 7/16/02 (Continued from pg. 12)
Polarization Resistance Test for Alloy C-22

Data:



John Bat 7/16/02



John Bat 7/16/02

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Polarization Resistance Test for Alloy C22 (continued from pg. 13)

Test: C22 Lpr 69

Scan: -15 mV to +60 mV vs. open circuit potential

Scan rate: 0.005 mV/second

 $E_{\text{app}} = 0.1555 \text{ V vs. SCE}$

Results: Method I (see formulae in Notebook 520, pg. 11)

$$(\partial E / \partial I)_{E_{\text{corr}}} = -3.00242 \times 10^{-5}$$

$$R_p = -3.3366 \times 10^4 \Omega \cdot \text{cm}^2$$

$$i_{\text{corr}} = -1.5637 \times 10^{-6} \text{ A/cm}^2$$

$$\text{C.R.} = 0.0153 \text{ mm/yr}$$

Method II (see formulae in Notebook 520, pg. 11)

A. Data: +30 mV to +40 mV vs. open circuit potential
(0.1855 < E < 0.1955)

$$b = 1.58265 \times 10^{-6}$$

$$m = -7.25739 \times 10^{-6}$$

$$i_{\text{corr}} = 4.54126 \times 10^{-7} \text{ A/cm}^2$$

$$\text{C.R.} = 0.00445 \text{ mm/yr}$$

B. Data: +40 mV to +60 mV vs. open circuit potential
(E > 0.1955)

$$b = -5.14373 \times 10^{-7}$$

$$m = 3.99228 \times 10^{-6}$$

$$i_{\text{corr}} = 1.06427 \times 10^{-7} \text{ A/cm}^2$$

$$\text{C.R.} = 0.00104 \text{ mm/yr}$$

Data: C22 Lpr 69 (Method I) pg. 15
C22 Lpr 69 (Method II) pg. 15

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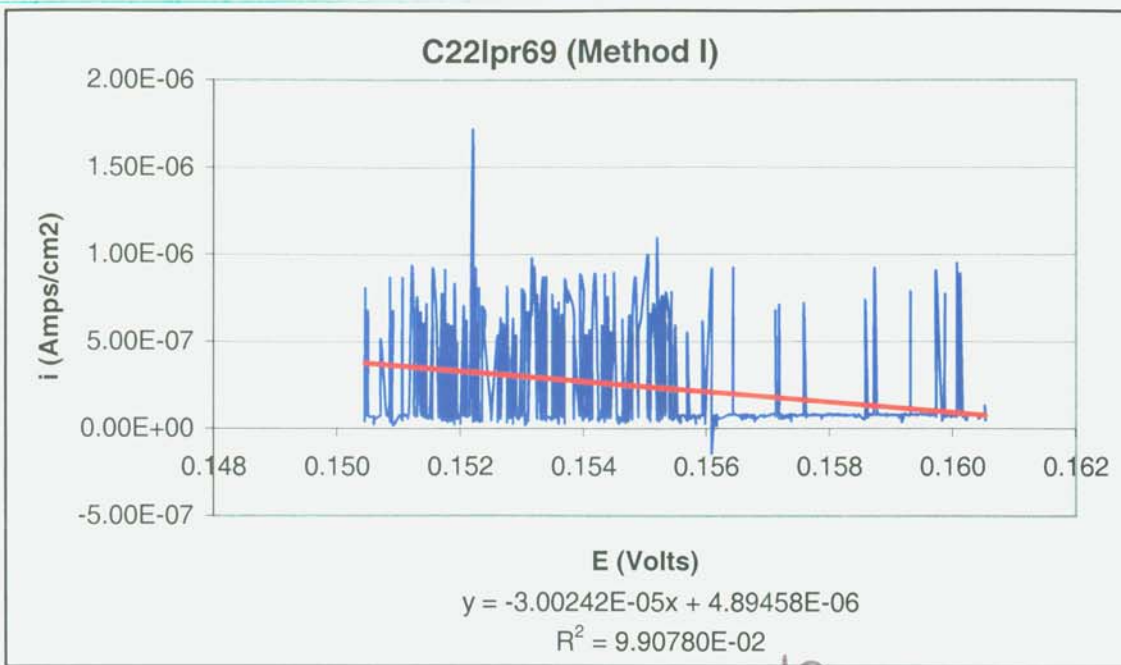
Jth Best

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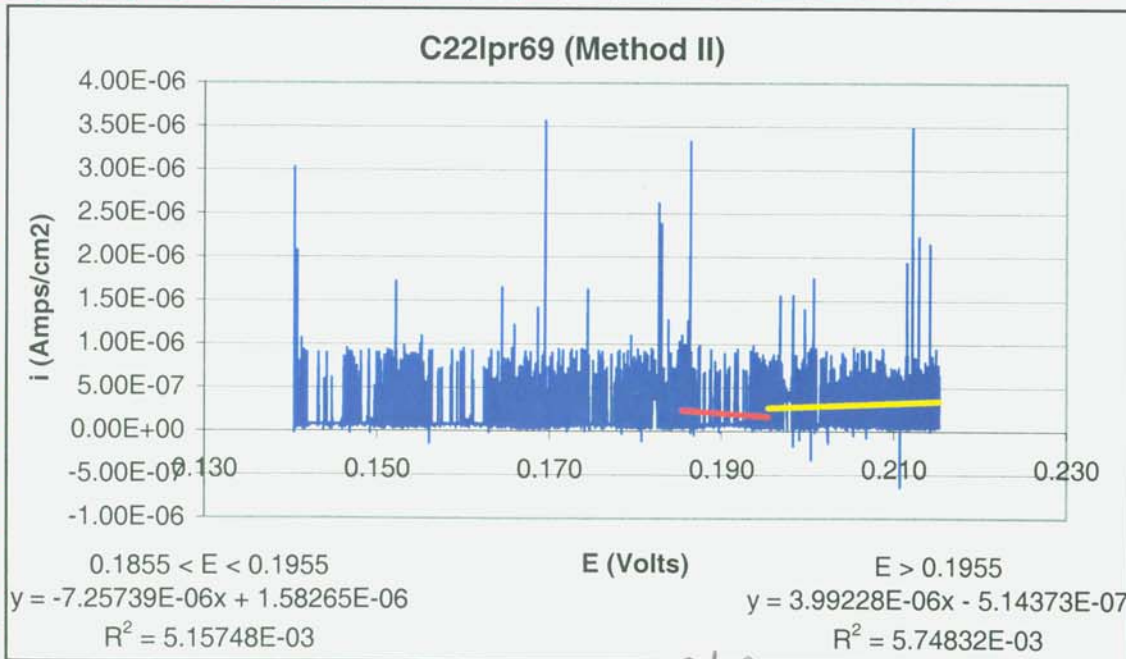
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Polarization Resistance Test for Alloy C-22 (continued from pg. 14)

Data:



John Best 7/16/02



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continued on pg. 16 7/16/02

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Polarization Resistance Test for Alloy C-22 (Continued from pg. 15)

Test: C22 Apr 70

Scan: -15 mV to +60 mV vs. open circuit potential

Scan Rate: 0.001 mV/second

 E_{corr} : 0.1717 V vs. SCE

Results: Method I (see formulas in Notebook 520, pg. 11)

$$\left(\frac{\partial E}{\partial I}\right)_{E_{corr}} = -4.4014 \times 10^{-7}$$

$$R_p = -2.2720 \times 10^6 \Omega \cdot \text{cm}^2$$

$$i_{corr} = -2.2923 \times 10^{-8} \text{ A/cm}^2$$

$$C.R. = -0.000225 \text{ mm/yr}$$

Method II (see formulas in Notebook 520, pg. 11)

A. Data: +30 mV to +40 mV vs. open circuit potential
(0.2017 < E < 0.2117)

$$b = -6.70550 \times 10^{-7}$$

$$m = 4.45657 \times 10^{-6}$$

$$i_{corr} = 9.46431 \times 10^{-8} \text{ A/cm}^2$$

$$C.R. = 0.000927 \text{ mm/yr}$$

B. Data: +40 mV to +60 mV vs. open circuit potential
(E > 0.2117)

$$b = 1.00144 \times 10^{-6}$$

$$m = -3.36108 \times 10^{-6}$$

$$i_{corr} = 4.24343 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00416 \text{ mm/yr}$$

Data: C22 Apr 70 (Method I) pg. 17

C22 Apr 70 (Method II) pg. 17

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John Boock

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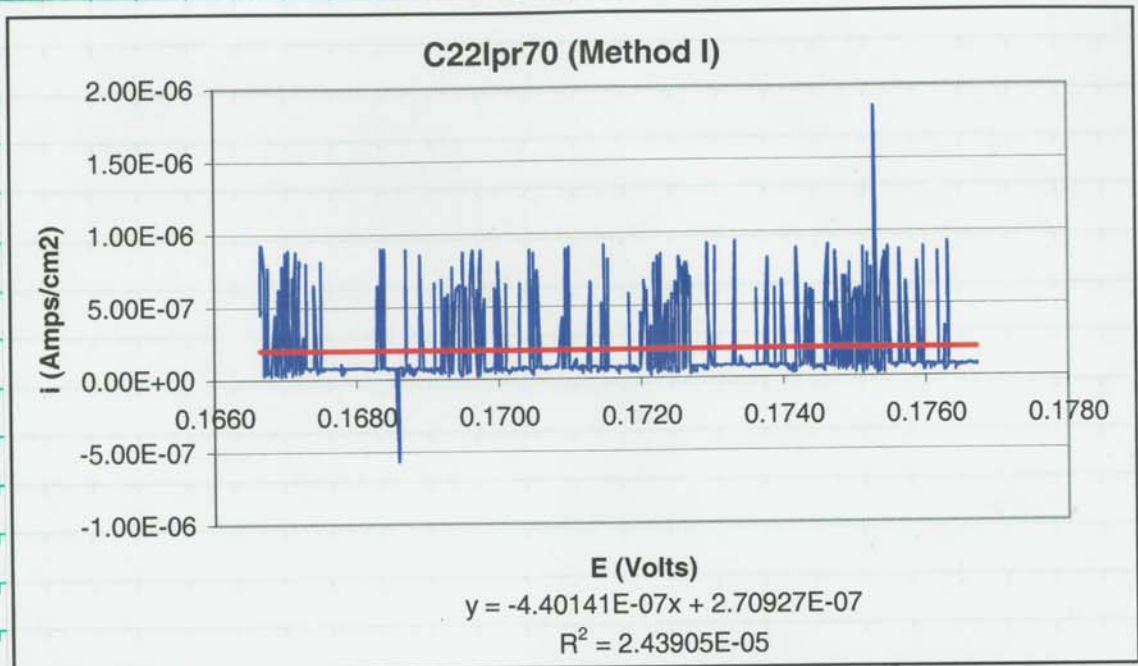
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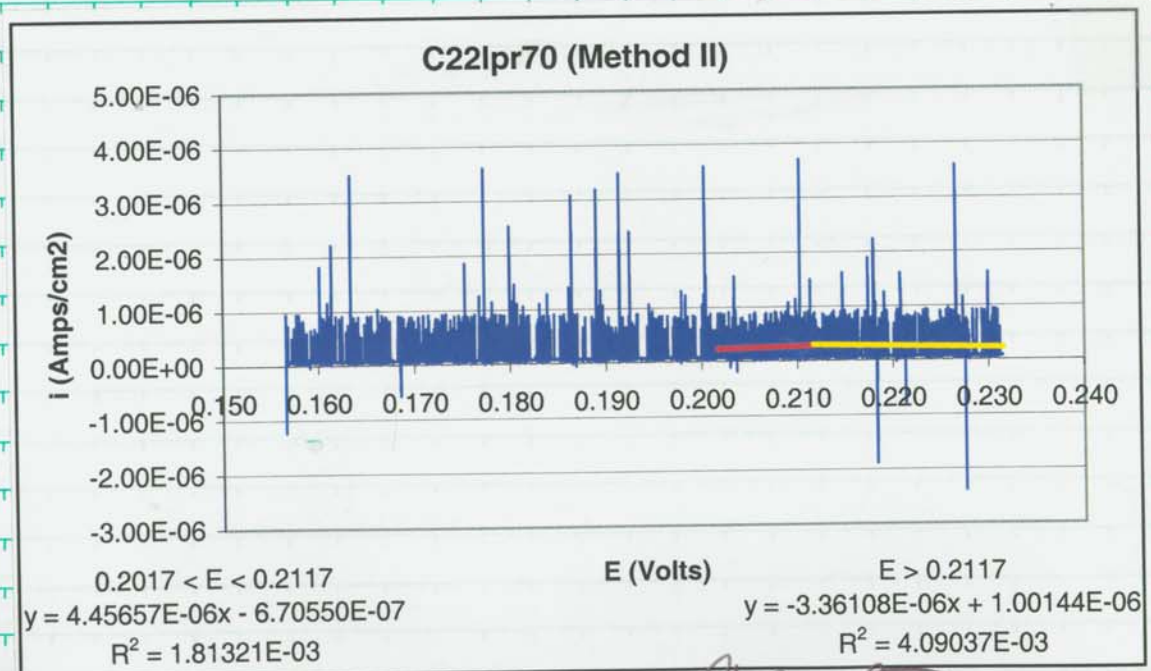
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Polarization Resistance Test for Alloy C-22 (continued from pg 16)

Data:



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From Page No. _____ Polarization Resistance Test for Alloy C-22

objective: Same as pg 1

specimen: C-22 Heat: 2277-8-3175 Polished to a 600 grit finish

start wt: 12.44580 g Sartorius Gorius S/N 12805099 cal 6/4/02

End wt: 12.44530 g

Same test specimen as Notebook 520, pg. 8

Solution: 0.028 M NaCl

3.296 g NaCl Lit: 020814

+ DI H₂O up to 2000 ml

pH start: 5.659 Fisher Accumet 450 meter S/N 3340 cal 7/21/01

pH End: 7.023 pH probe #13-620-294 S/N 1100208

Potentiostat: Solartron 1287

Counter Electrode: Pt plug

Reference: Fisher 13-620-52 S/N 0052132

Temperature: 25°C H₂ Thermometer S/N H98-162 cal 4/22/02

E_{corr} = -136.22 mV Keithley Model 614 S/N 704 936 cal 5/26/02

E_{pt} = 80.8 mV

Solution Aerated with "Zero" Air (79% N₂, 21% O₂, & 0% CO₂)

Specimen Examination: No staining or localized corrosion visible

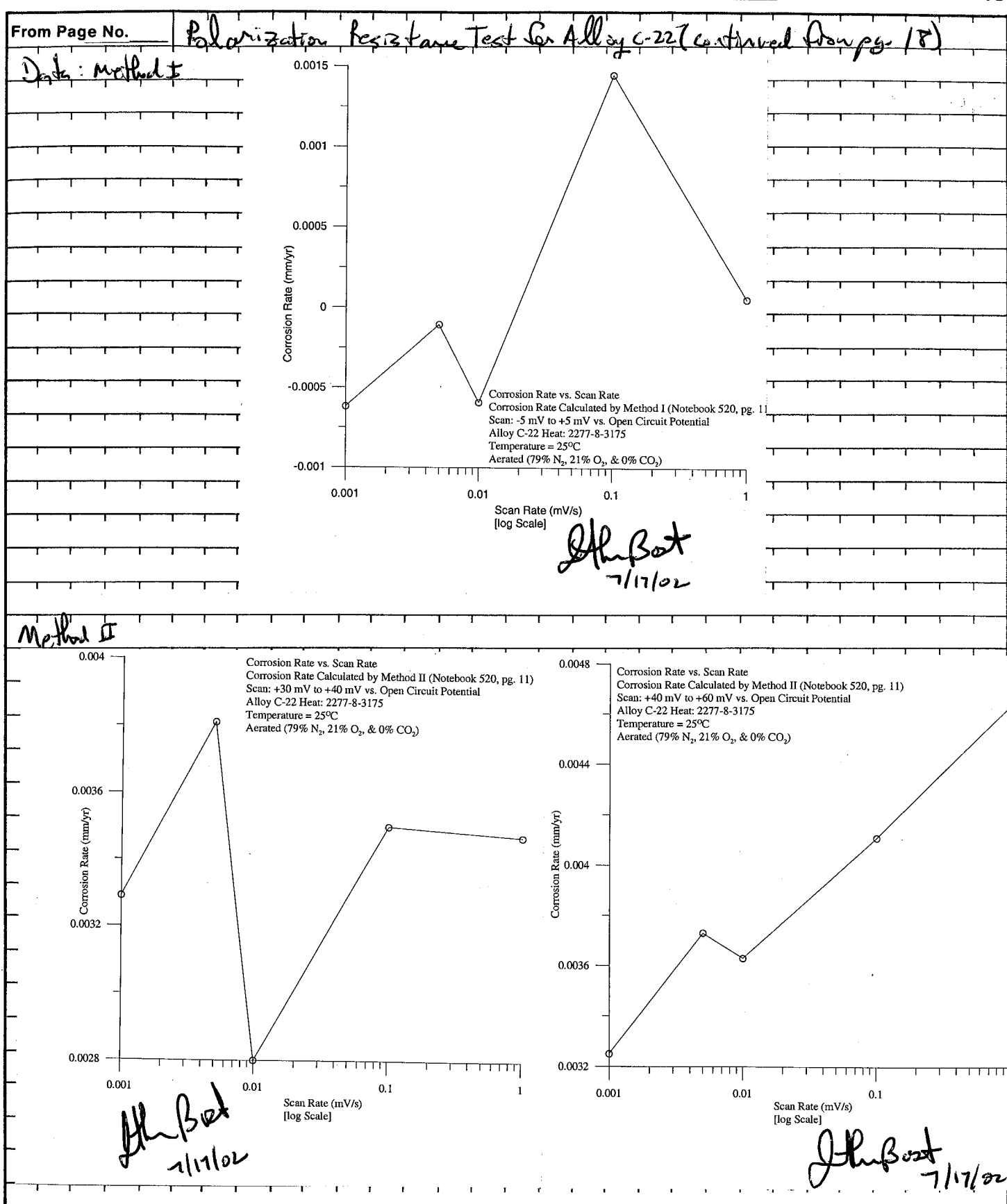
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Polarization Resistance Test for Alloy C22 (continued from pg. 19)

Test: C22 pr 71

Scan: -15 mV to +60 mV vs. open circuit potential

Scan Rate: 1 mV / second

 $E_{oc} = 0.0901 \text{ V vs. SCE}$

Results: Method I (see formulas in Notebook 520, pg. 11)

$$(DE/IE)_{E_{oc}} = 1.07111 \times 10^{-7}$$

$$R_p = 9.3361 \times 10^6 \Omega \cdot \text{cm}^2$$

$$i_{cor} = 5.5783 \times 10^{-9} \text{ A/cm}^2$$

$$C.R. = 0.0000547 \text{ mm/yr}$$

Method II (see formulas in Notebook 520, pg. 11)

A. Data: +30 mV to +40 mV vs. open circuit potential
($0.1207 < E < 0.1307$)

$$b = 8.38959 \times 10^{-8}$$

$$m = 2.98429 \times 10^{-6}$$

$$i_{cor} = 3.59571 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00347 \text{ mm/yr}$$

B. Data: +40 mV to +60 mV vs. open circuit potential
($E > 0.1307$)

$$b = -3.93933 \times 10^{-7}$$

$$m = 5.09353 \times 10^{-7}$$

$$i_{cor} = 4.73623 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00464 \text{ mm/yr}$$

Data: C22 pr 71 (Method I) pg. 21

C22 pr 71 (Method II) pg. 21

Continued on pg. 21

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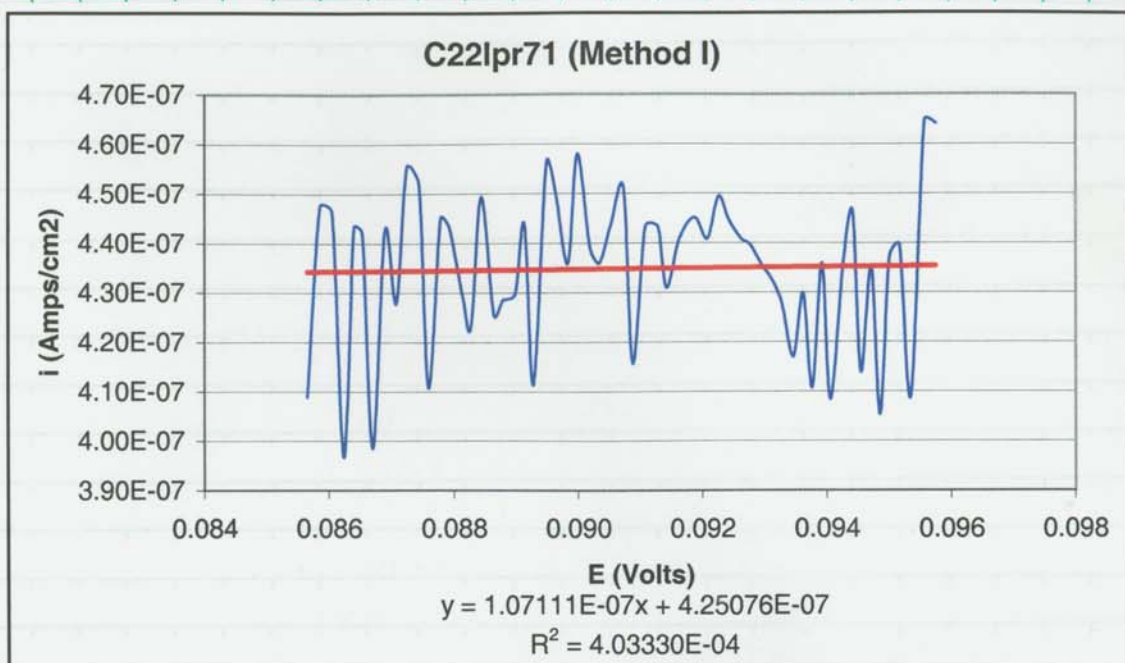
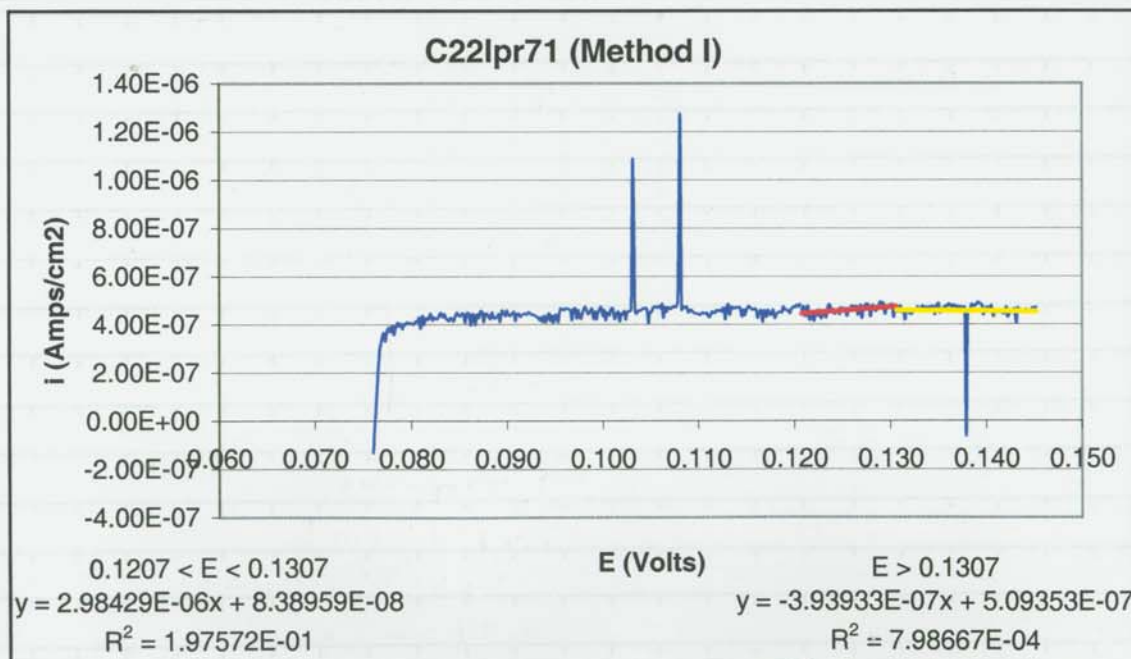
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Polarization Resistance Test for Alloy C-22 (continued from page 20)

Data:

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7/16/02John Bost
7/14/02

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Polarization Resistance Test for Alloy C22 (continued from pg. 21)

Test: C22 Apr 72

Scan: -15mV to +40mV vs. open circuit Potential

Scan Rate: 0.1 mV/second

 $E_{corr} = 0.1165 \text{ V vs. SCE}$

Results: Method I (see formulas in Notebook 520, pg. 11)

$$\Delta E / \Delta I \quad E_{corr} = 2.84824 \times 10^{-6}$$

$$R_p = 3.5109 \times 10^5 \Omega \cdot \text{cm}^2$$

$$i_{corr} = 1.4834 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00145 \text{ mm/yr}$$

Method II (see formulas in Notebook 520, pg. 11)

A. Data: +30mV to +40mV vs. open circuit potential
($0.1165 < E < 0.1565$)

$$b = 2.59670 \times 10^{-7}$$

$$m = 8.36665 \times 10^{-7}$$

$$i_{corr} = 3.57141 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00350 \text{ mm/yr}$$

B. Data: +40mV to 60mV vs. open circuit potential
($E > 0.1565$)

$$b = 4.89031 \times 10^{-7}$$

$$m = -5.93133 \times 10^{-7}$$

$$i_{corr} = 4.14931 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00411 \text{ mm/yr}$$

Data: C22 Apr 72 (Method I) pg. 23

C22 Apr 72 (Method II) pg. 23

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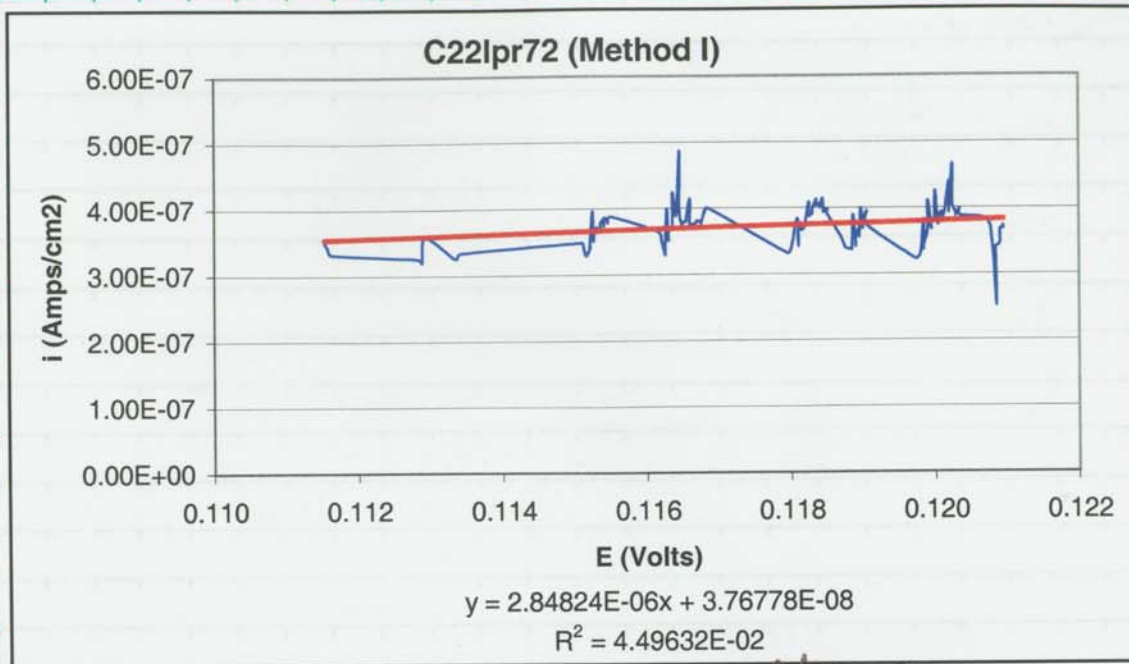
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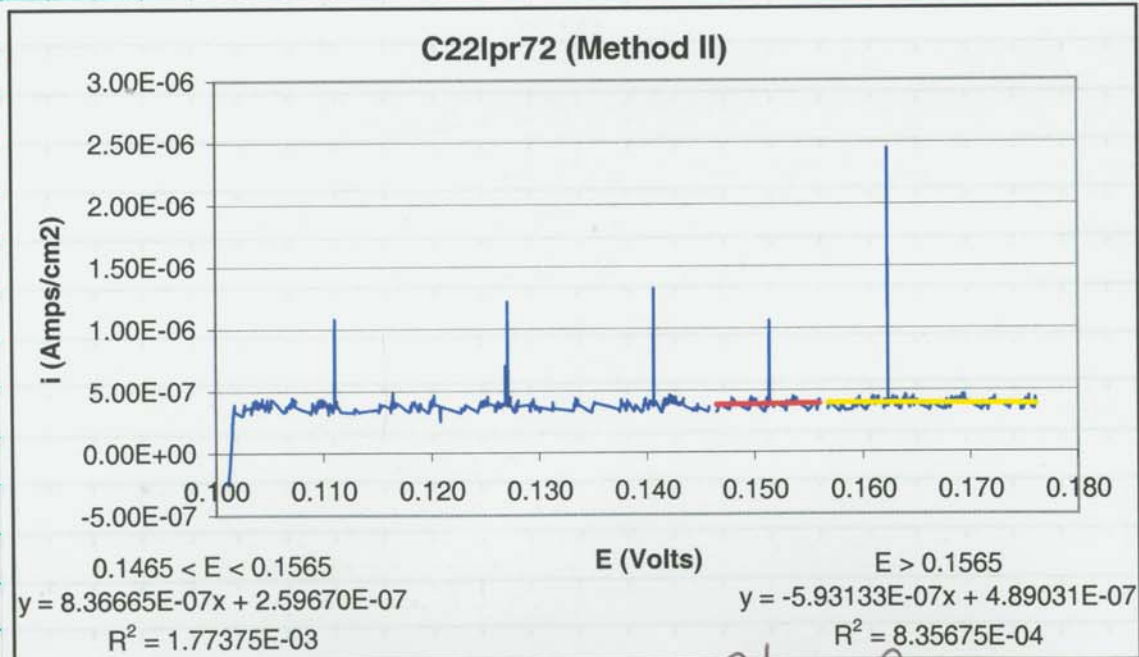
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Polarization Resistance Test for Alloy C-22 (continued from pg. 22)

Data:



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Polarization Resistance Test for Alloy C-22 (continued from pg. 23)

Test: C22 Apr 73

Scan: -15 mV to +60 mV vs. open circuit potential

Scan Rate: 0.01 mV/sec

 $E_{corr} = 0.1462V$ vs. SCE

Results: Method I (see formula in Notebook 520, pg. 11)

$$(\partial E / \partial I)_{E_{corr}} = -1.16143 \times 10^{-6}$$

$$R_p = -8.6101 \times 10^5 \Omega \cdot \text{cm}^2$$

$$i_{corr} = -6.0487 \times 10^{-8} \text{ A/cm}^2$$

$$C.R. = -0.000593 \text{ mm/yr}$$

Method II (see formula in Notebook 520, pg. 11)

A. Data: +30 mV to +40 mV vs. open circuit potential
(0.1712 < E < 0.1812)

$$b = -7.81632 \times 10^{-8}$$

$$m = 2.47633 \times 10^{-6}$$

$$i_{corr} = 2.75738 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00280 \text{ mm/yr}$$

B. Data: +40 mV to +60 mV vs. open circuit potential

(E > 0.1712) (E > 0.1812)

$$b = 3.87550 \times 10^{-7}$$

$$m = -1.18533 \times 10^{-7}$$

$$i_{corr} = 3.7022 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00363 \text{ mm/yr}$$

Data: C22 Apr 73 (Method I) pg. 25

C22 Apr 73 (Method II) pg. 25

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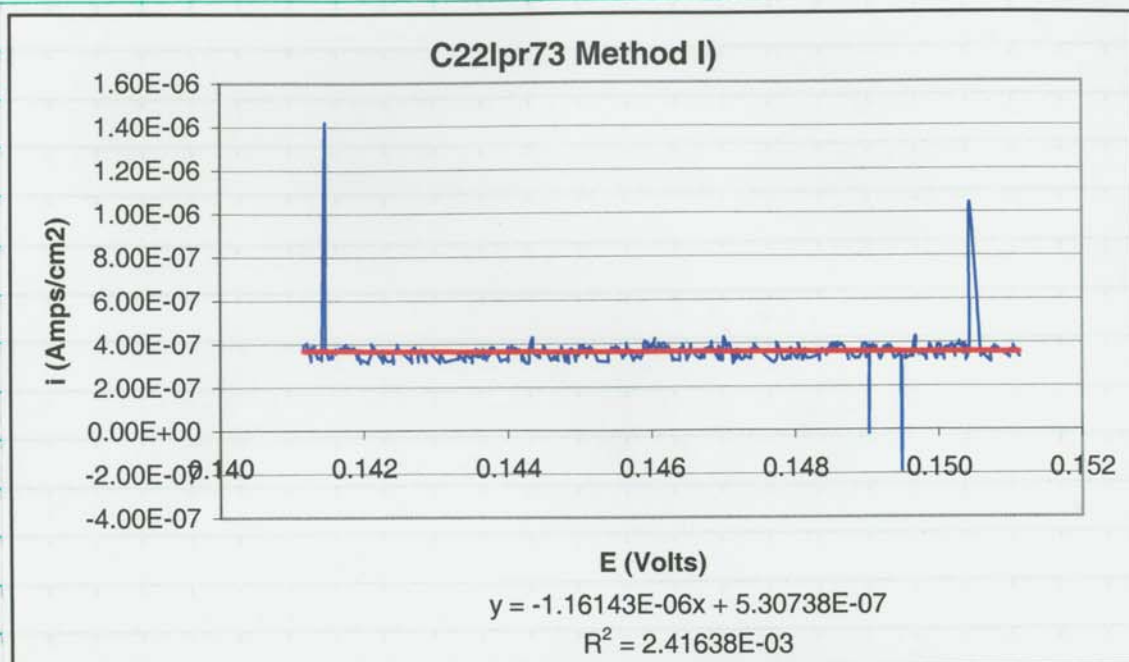
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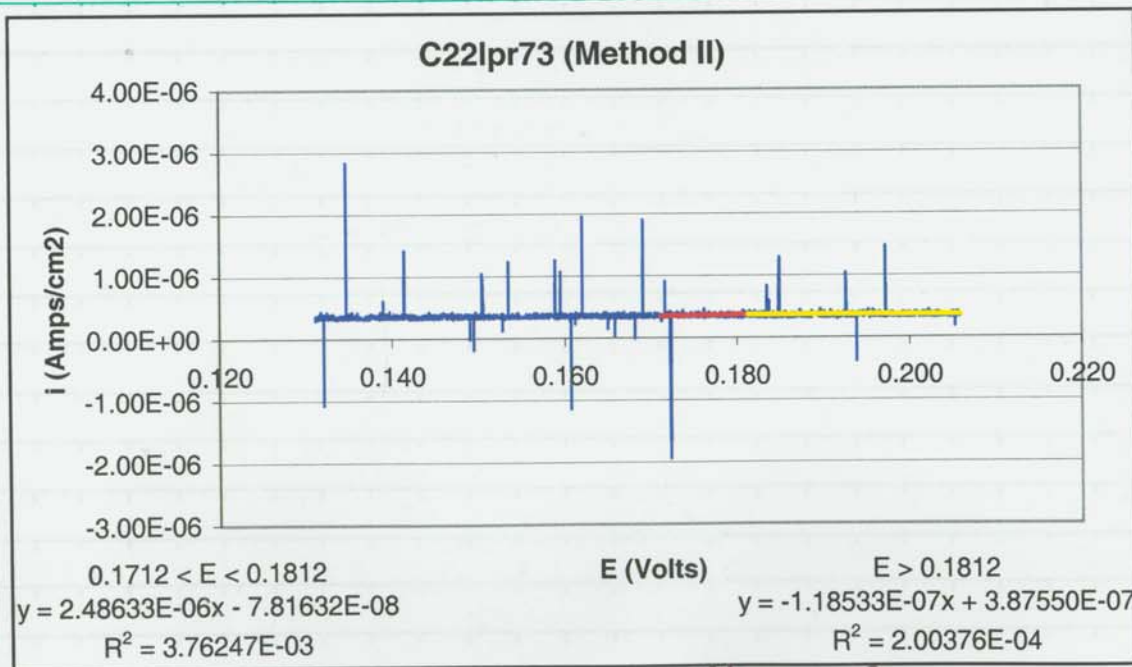
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Polarization Resistance Test for Alloy C-22 (continued from pg. 24)

Data:



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Polarization Resistance Test for Alloy C-22 (continued from pg. 25)

Test: C22 pg 74

Scan: -15mV to +60mV vs. open circuit potential

Scan rate: 0.005 mV/second

 $E_{corr} = 0.1826$ V vs. SCE

Results: Method I (see formulas in Notebook 520, pg. 11)

$$(\partial E / \partial I)_{E_{corr}} = 2.05652 \times 10^{-7}$$

$$R_p = 4.8626 \times 10^{-16} \Omega \cdot \text{cm}^2$$

$$i_{corr} = 1.0710 \times 10^{-8} \text{ A/cm}^2$$

$$C.R. = 0.000105 \text{ mm/yr}$$

Method II (see formulas in Notebook 520, pg. 11)

A. Data: +30mV to +40mV vs. open circuit potential
(0.2121 < E < 0.2226)

$$b = 4.70945 \times 10^{-7}$$

$$m = -4.51962 \times 10^{-7}$$

$$i_{corr} = 3.88467 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00381 \text{ mm/yr}$$

B. Data: +40mV to +60mV vs. open circuit potential
(E > 0.2226)

$$b = 4.35085 \times 10^{-7}$$

$$m = -2.98498 \times 10^{-7}$$

$$i_{corr} = 3.80579 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00373 \text{ mm/yr}$$

Data: C22 pg 74 (Method I) pg 27

C22 pg 74 (Method II) pg 27

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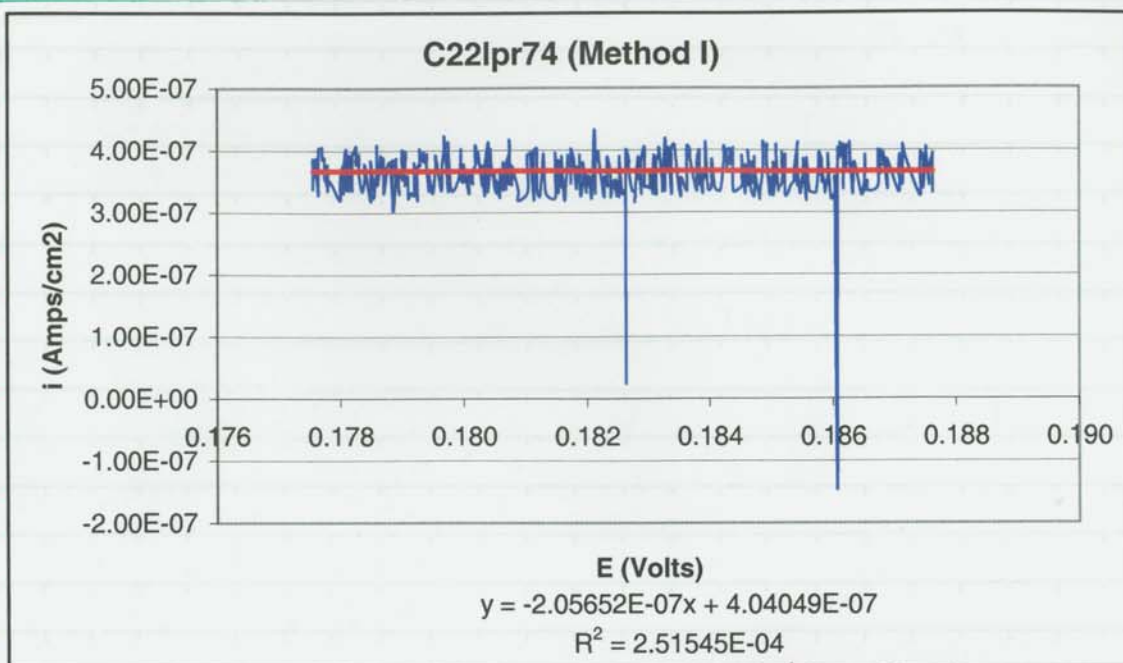
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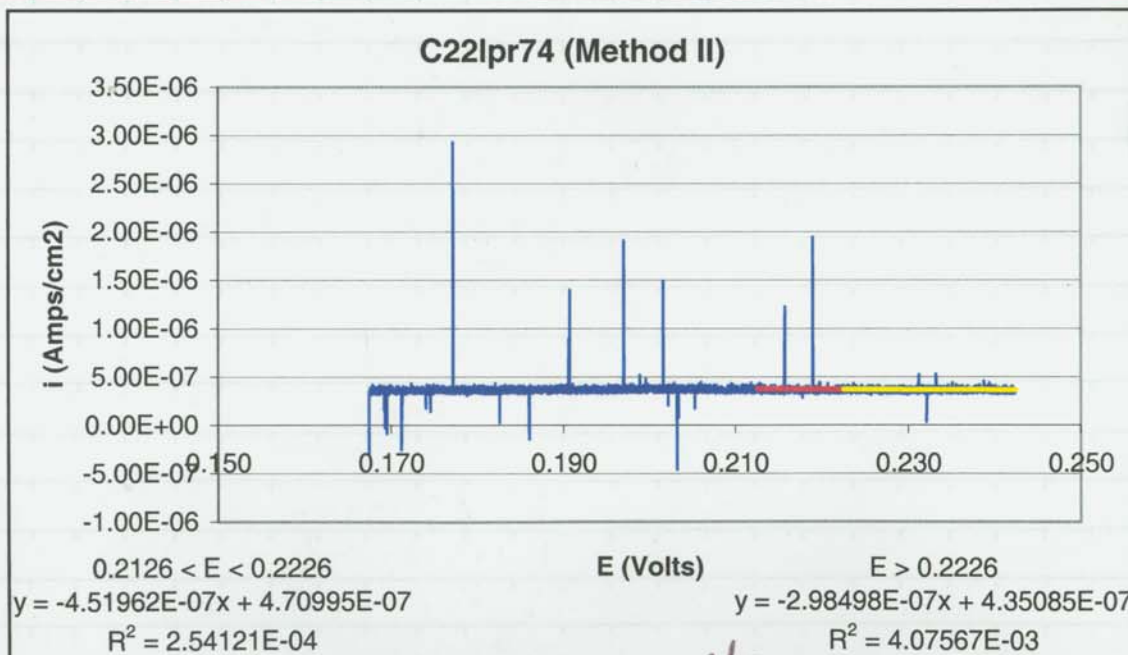
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Polarization Resistance Test for Alloy C-22 (continued from pg. 26)

Data:



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Polarization Resistance Test for Alloy C-22 (continued from pg. 27)

Test: C22 pr 75

Scan: -15mV to +60mV vs. open circuit potential

Scan Rate: 0.001 mV vs. ~~SE~~ J3 7/16/02 $E_{corr} = 0.2208$ V vs. SCE

Results Method I (see formulas in Notebook 520, pg. 11)

$$(2E/\Delta E) E_{corr} = -1.21271 \times 10^{-6}$$

$$R_p = -8.2460 \times 10^5 \frac{\Omega \cdot \text{cm}^2}{\text{A/cm}^2} \quad \text{J3 7/16/02}$$

$$i_{corr} = -6.3158 \times 10^{-8} \text{ A/cm}^2$$

$$C.R. = -0.000619 \text{ mm/yr}$$

Method II (see formulas in Notebook 520, pg. 11)

A. Data: +30mV to +40mV vs. open circuit potential
(0.2508 < E < 0.2608)

$$b = 3.62041 \times 10^{-7}$$

$$m = -1.18201 \times 10^{-7}$$

$$i_{corr} = 3.35942 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00329 \text{ mm/yr}$$

B. Data: +40mV to +60mV vs. open circuit potential

(~~E < 0.2608~~) (E > 0.2608) DD 4/03/03

$$2.92312 \times 10^{-7}$$

$$b = 2.92312 \times 10^{-7} \quad \text{DD 4/3/03}$$

$$m = 1.76210 \times 10^{-7}$$

$$i_{corr} = 3.31215 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00325 \text{ mm/yr}$$

Data: C22 pr 75 (Method I) pg. 29

C22 pr 75 (Method II) pg. 29

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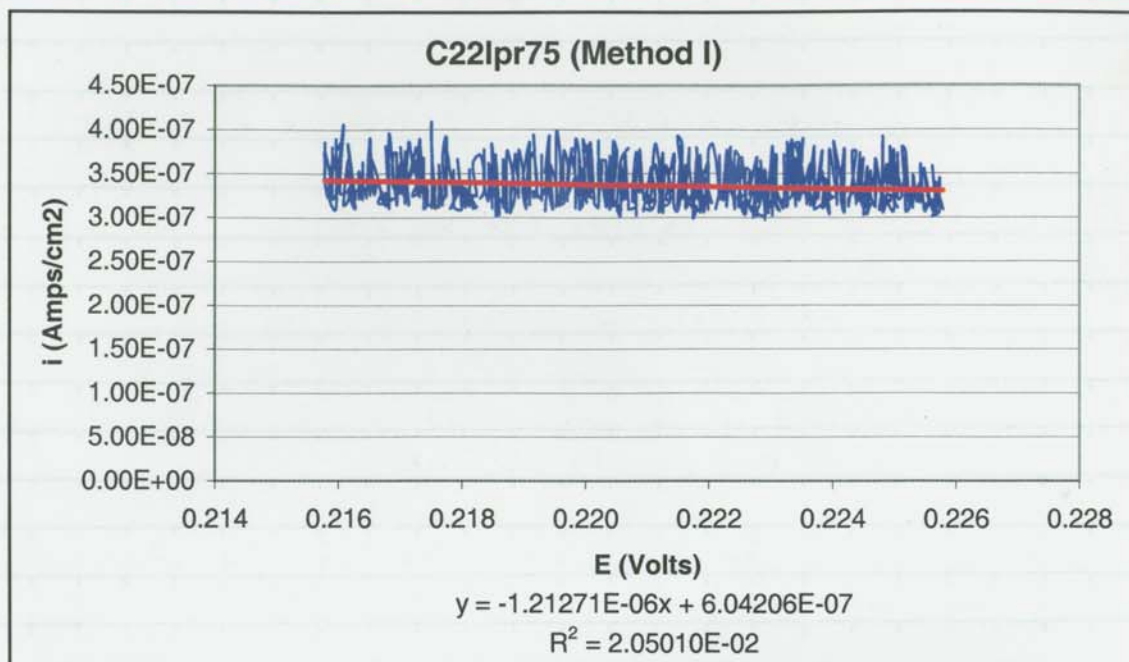
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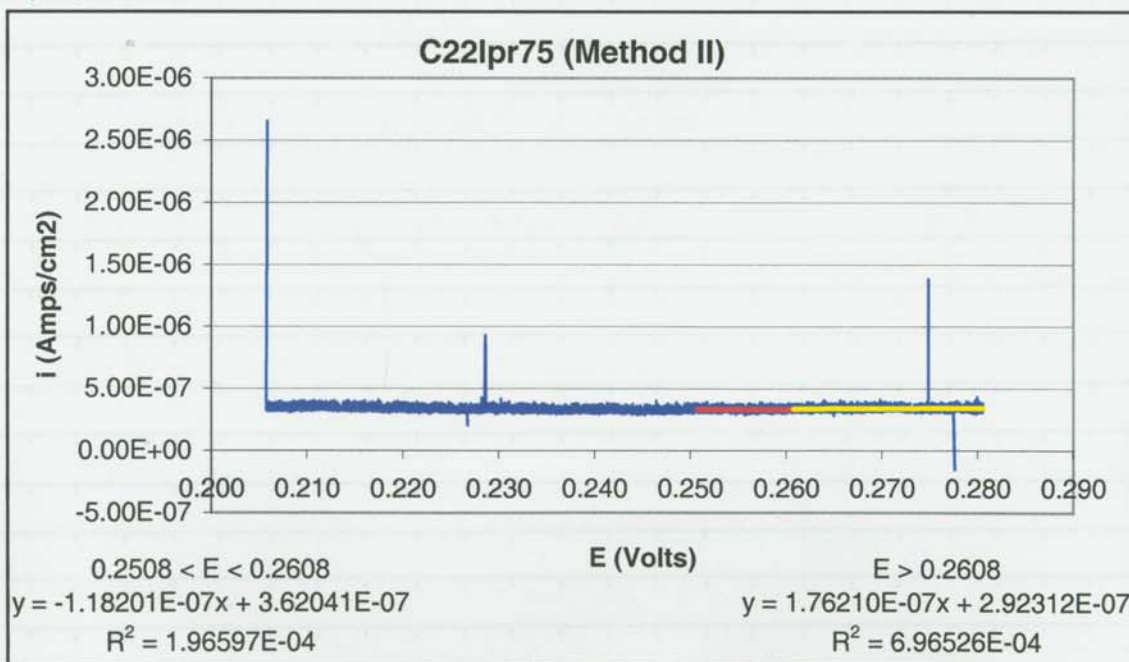
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Polarization Resistance Test for Alloy C-22 (Continued from pg. 28)

Data:



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Electrochemical Impedance Test for Alloy C-22

Objective: same as pg 2

Specimen: C-22 heat: 2277-8-3175 Polished to a 600grit finish

Start wt: 12.44580 g Scribner Genius S/N 12809099 cal 6/4/02

End wt: 12.44530 g

Same test specimen as Notebook 520 pg. 8

Solution: 0.028M NaCl

3.296g NaCl Lot: 020814

+ DI H₂O up to 2000ml

pH start: 6.015 Fisher Accumet 950 meter S/N 3340 cal 7/29/01

pH End: 6.447 pH probe # 13-620-246 S/N 1160 208

Impedance Analyzer: Solartron 1260

Counter Electrode: Pt Slug

Reference: Fisher 13-620-52 S/N 0052132

Temperature: 95°C Hg Thermometer S/N H48-162 cal 4/22/02

E_{corr}: -314 mV Keithley Model 614 S/N 704932 cal 5/26/02E_{pk}: 127.5 mVSolution Deaerated with 99.999% N₂

Specimen Examination: No staining or localized corrosion visible

Cell info: Area: 8 cm²
 Density: 8.69 g/cm³
 Equivalent weight: 26.04 g/B 7/17/02

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John Boett

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Electrochemical Impedance Test for Alloy C-22 (from pg. 30)

Test: C22 eis 44

Initial Frequency: 20000 Hz

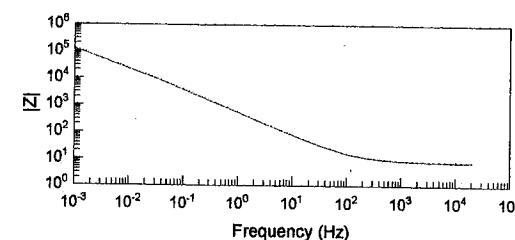
Final Frequency: 0.001 Hz

10 steps per decade

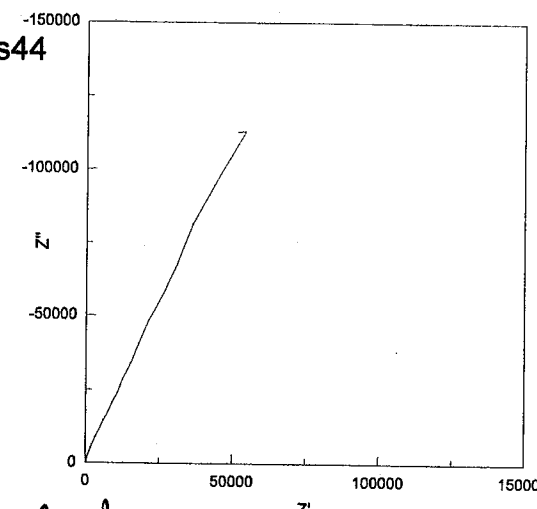
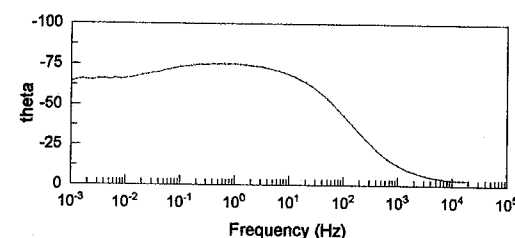
Integration Time: 5 seconds

Delay: 2 seconds

Data: C22 eis 44



C22eis44



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Electrochemical Impedance Test for Alloy C-22 (From pg. 31)

Test: C22 eis 45

Initial frequency: 20000 Hz

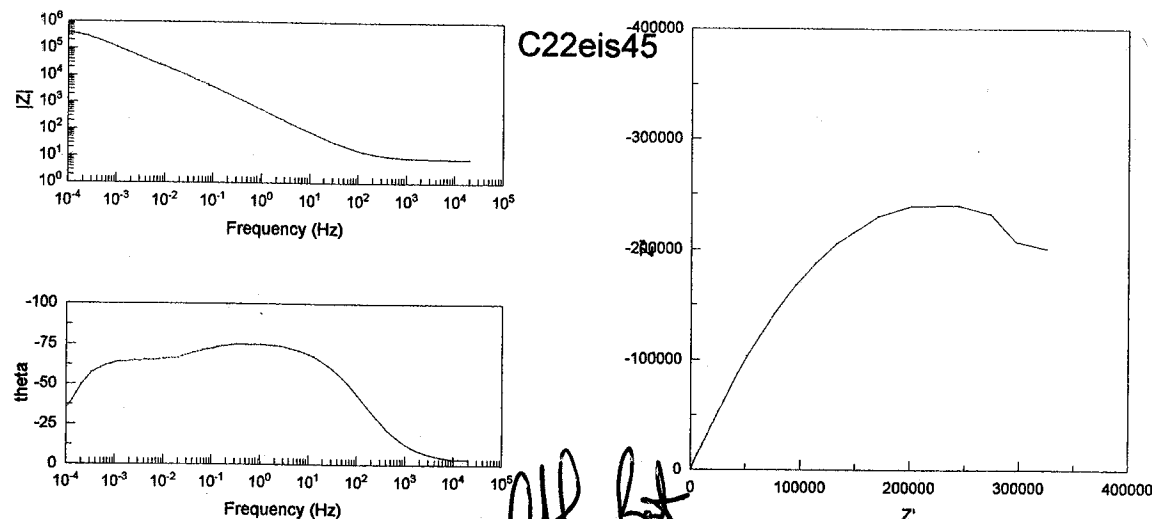
Final frequency: 0.0001 Hz

10 steps per decade

Integration time: 5 seconds

Delay: 2 seconds

Data: C22eis 45

JH Best
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Electrochemical Impedance Test for Alloy C-22

Objective: same as pg 2

Specimen: C-22 heat: 2277-8-3175 polished to a 600 grit finish

Start wt: 12.44570 g Santarus Genius s/n 12701099 cal 6/4/02

End wt: 12.44530 g

Same test specimen as Notebook 520, pg. 8

Solution: 0.028 M NaCl

3.296 g NaCl Lot # 020814

+ DI H₂O up to 2000 ml

pH start: 6.015 Fisher Accumet 950 meter s/n 3340 cal 7/21/01

pH end: 6.447 pH probe # 13-620-246 s/n 1100208

cell info: Area: 8 cm²Density: 8.69 g/cm³

Equivalent wt: 26.04

Impedance Analyzer: Solartron 1260

Counter Electrode: Pt flag

Reference: Fisher 13-620-58

Temperature: 80°C Hg Thermometer s/n 498-162 cal 4/22/02

E_{corr}: -319 mV Keithley Model 614 704936 cal 5/26/02E_{Pt}: 127.5 mVSolution Deaerated with 99.999% N₂

Specimen Examination: No staining or localized corrosion visible

continued on pg. 34

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Electrochemical Impedance Test for Alloy C-22 (from pg 33)

Test: C22eis46

Initial Frequency: 20000 Hz

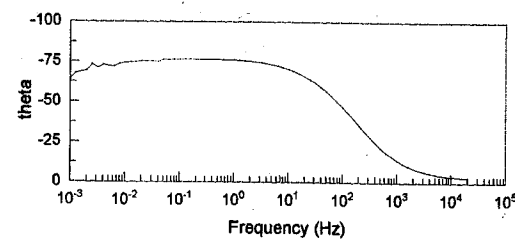
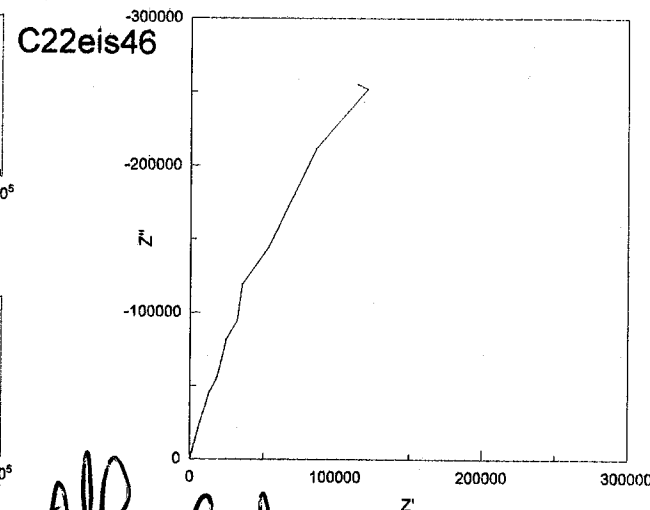
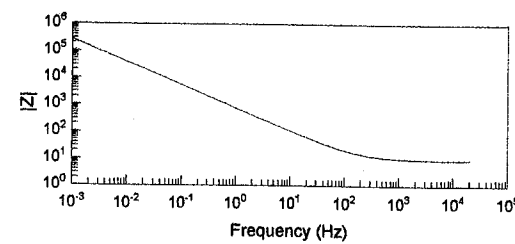
Final Frequency: 0.001 Hz

10 steps per decade

Integration time: 5 seconds

Delay: 2 seconds

Data: C22eis46



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Electrochemical Impedance Test for alloy C-22 (from pg 34)

Test: C22eis47

Initial Frequency: 20000 Hz

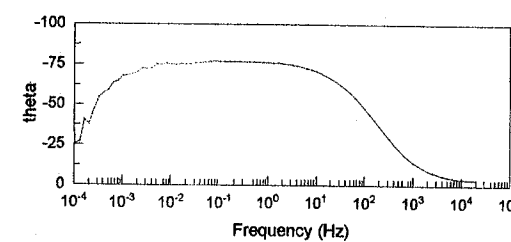
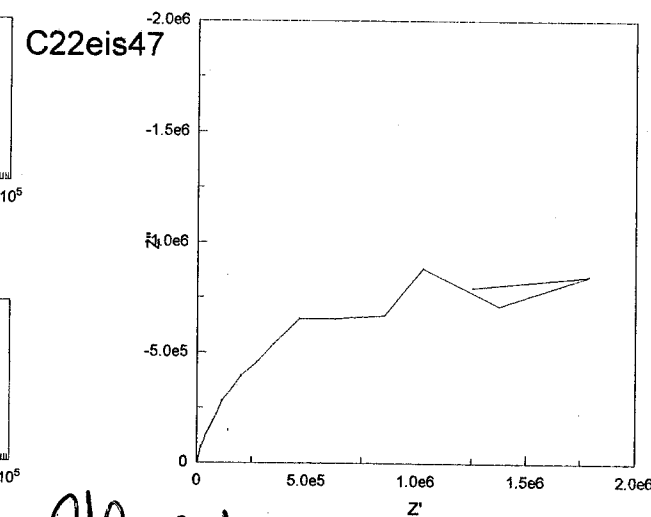
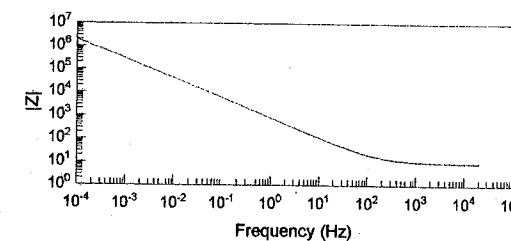
Final Frequency: 0.0001 Hz

10 steps per decade

Integration Time 5 seconds

Delay: 2 seconds

Data: C22eis47



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From Page No. _____ Electrochemical Impedance Test for Alloy C-22

Objective: same as pg. 2

specimen: C-22 heat: 2277-8-3175 Polished to a 600 grit finish

start wt: 12.44580 g Sartorius Gearing s/n 12801099 cald 6/4/02

End wt: 12.44530 g

Solution: $\frac{1}{2}$ M Same test specimen as Notebook 52, pg. 8

0.028M NaCl

3.296 g NaCl Lot # 020811

+DI H₂O up to 2000 ml

pH start: 6.015 Fisher Accumet 950 meter s/n 3340 cald 7/24/01

pH End: 6.447 pH probe # 13-620-296 s/n 11002208

cell info: Area 8 cm²
 Density: 8.69 g/cm³
 Equivalent wt: 26.04

Impedance Analyzer: Solartron 1260

Counter Electrode: Pt Filig

Reference: Fisher 13-620-52 s/n 0052132

Temperature: 60°C Hg Thermometer s/n H98-162 cald 4/22/02

E_{corr} = -315 mV Keithley 614 s/n 704936 cald 5/26/02E_{pt} = 127.5 mVSolution Deaerated with 99.999% N₂

Specimen Examination: No staining or localized corrosion

continued on pg 37

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Recorded by

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From Page No. _____ Electrochemical Impedance Test for Alloy C-22 (from pg 36)

Test: C22eis48

3 7/19/02

Scan

Initial frequency: 20000 Hz

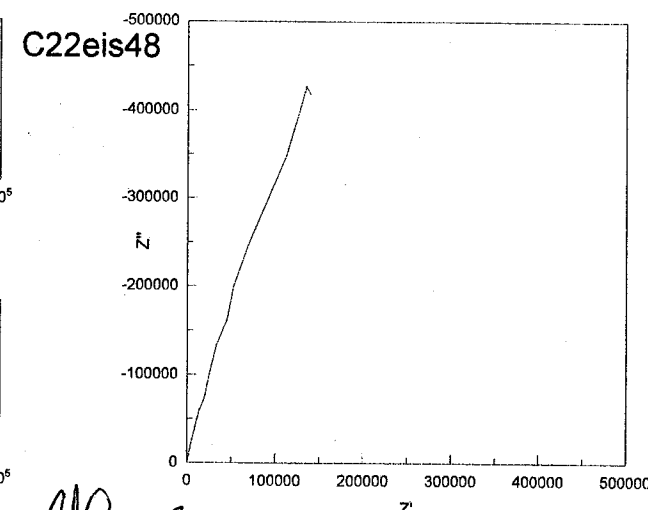
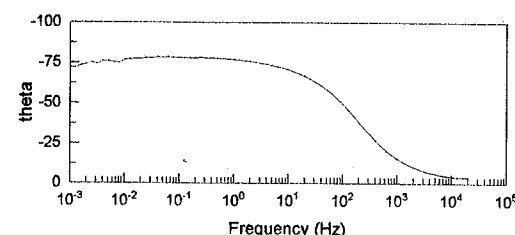
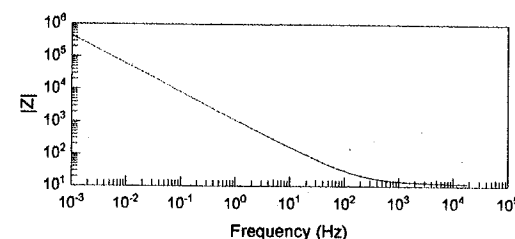
Final frequency: 0.001 Hz

10 steps per Decade

Integration Time: 5 seconds

Delay: 2 seconds

Data: C22eis48



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Invented by

Date

Recorded by

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Electrochemical Impedance Test for Alloy C-22 (From pg. 37)

Test: C22 eis 49

Initial Frequency: 20000 Hz

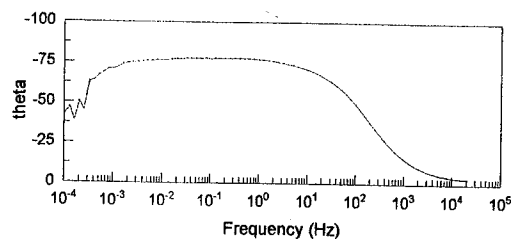
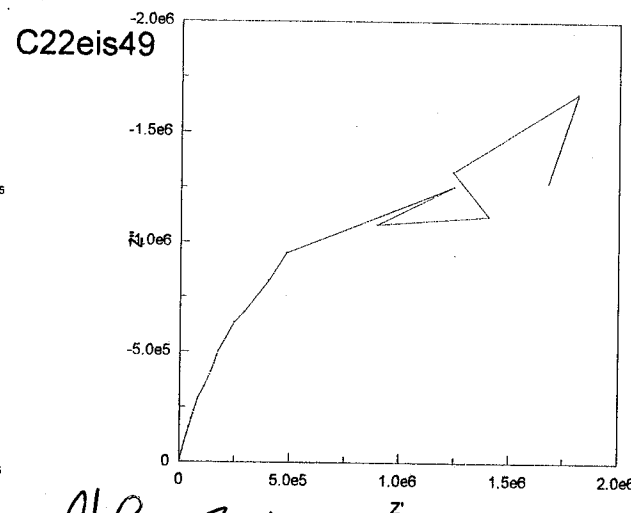
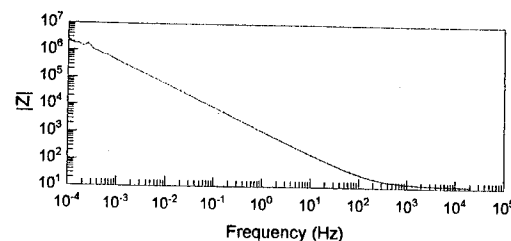
Final frequency: 0.0001 Hz

10 steps per decade

Integration time: 5 seconds

Delay: 2 seconds

Data: C22 eis 49



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7/22/02

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Witnessed & Understood by me, _____

Date _____

Invented by _____

Date _____

Recorded by _____

7/14/02

TITLE _____

From Page No. _____

Electrochemical Impedance Test for Alloy C-22 7/15/02

Objective: same as pg. 2

specimen: C-22 Inert: 2277-8-3175 polished to a 600 grit finish

start wt: 12.44580 g Sartorius Genius s/n 12809099 cal 6/4/02

End wt: 12.44530 g

Same test specimen 520, pg. 8

Solution: 0.028M NaCl

3.296 g NaCl Lot: 020814

+ DI H₂O up to 2000 ml

pH start: 6.015 Fisher Accumet 950meter s/n 3340 cal 7/24/01

pH End: 6.417 pH probe #13-620-246 s/n 1100208

cell info: Area: 8 cm²
Density: 8.69 g/cm³
Equivalent wt: 26.09

Impedance Analyzer: Solartron 1260

Counter Electrode: Pt flag

Reference: Fisher 13-620-52 s/n 0052132

Temperature: 40°C Hg Thermometer s/n H98-162 cal 4/22/02

E_{corr} = -319 mV Keithley Model 614 s/n 704936 cal 5/26/02E_{pb} = 127.5 mVSolution Deaerated with 99.999% N₂

Specimen Examination: No staining or localized corrosion visible

continued on pg. 40

To Page No. _____

Witnessed & Understood by me, _____

Date _____

Invented by _____

Date _____

Recorded by _____

7/14/02

From Page No. _____

Electrochemical Impedance Test for Alloy C-22 (From pg. 39)

Test: C22eis50

Initial Frequency: 20000 Hz

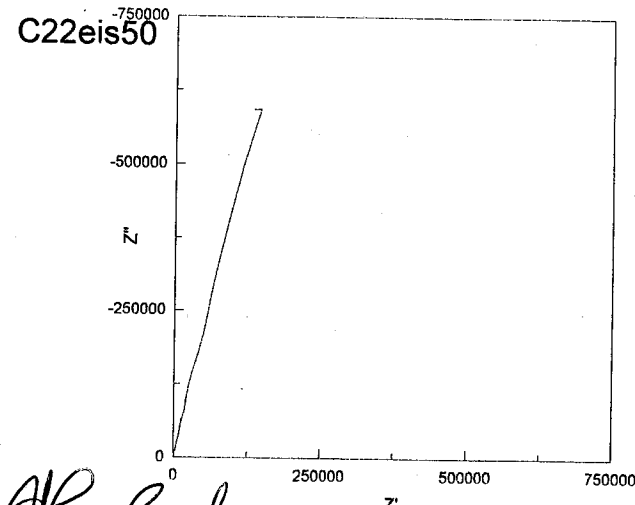
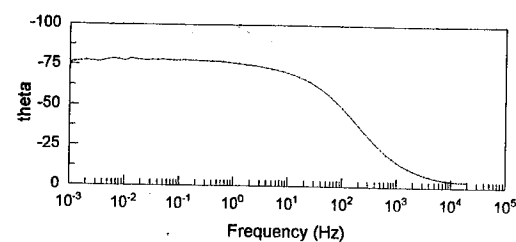
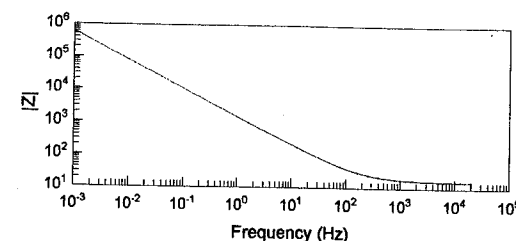
Final Frequency: 0.001 Hz

10 steps per Decade

Integration Time: 5 seconds

Delay: 2 seconds

Data: C22eis50

JHR Bab
7/12/02

continued on pg 41

Witnessed & Understood by me, _____

Date _____

Invented by _____

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From Page No. _____

Electrochemical Impedance Test for Alloy C-22 (From pg. 40)

Test: C22eis51

Initial Frequency: 20000 Hz

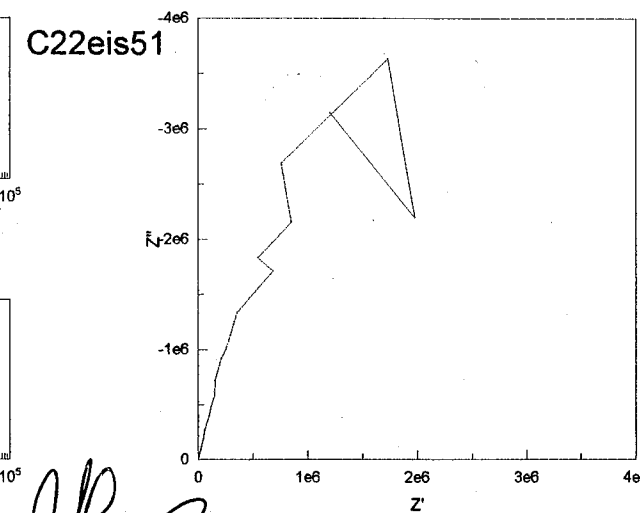
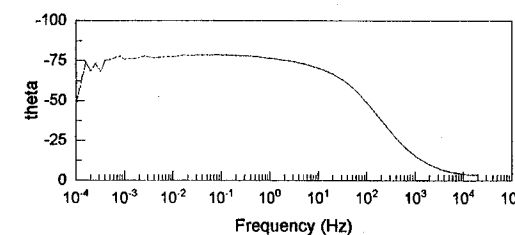
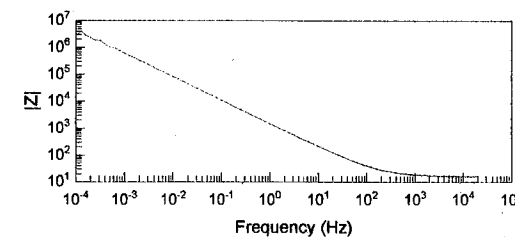
Final Frequency: 0.0001 Hz

10 steps per decade

Integration Time: 5 seconds

Delay: 2 seconds

Data: C22eis51

JHR Bab
7/12/02

Witnessed & Understood by me, _____

Date _____

Invented by _____

Date _____

Recorded by _____

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To Page No. _____

From Page No. _____ Electrochemical Impedance Test for Alloy C-22

Objectize: same as pg 2

Specimen: C22 bar: 2277-8-3175 Polished to a 600 grit finish

Start wt: 12.44580g Sartorius Series S/N 12809099 cal 6/4/02

End wt: 12.44530g

Same test specimen as Notebook 520, pg. 8

Solution: 0.028 M NaCl
3.296g NaCl Lot: 020819
+DI H₂O up to 2000ml

pH start: 6.015 Fisher Accumet 950 meter s/n 3340 cal 7/24/01

pH End: 6.447 pH probe # 13-620-256 s/n 1100208

Cell info: Area: 8cm²
Density: 8.65 g/cm³
Equivalent wt: 26.04

Impedance Analyzer Solution 1260

Counter Electrode: Pt Plug

Reference: Fisher 13-620-52 s/n 0052132

Temperature 25°C H₂ Thermometer s/n H98-162 cal 4/22/02E_{corr}: -315mV Keithley 614 s/n 704936 cal 5/26/02E_{pot}: 127.5mVSolution Deaerated with 99.999% N₂

Specimen Examination: No staining or localized corrosion visible

continued on pg 43

Witnessed & Understood by me,

Date

Invented by

Date

Recorded by

John Best

7/22/02

To Page No. _____

From Page No. _____ Electrochemical Impedance Test for Alloy C-22 (continued from pg 42)

Test: C22eis52

Initial frequency: 20000 Hz

Final frequency: 0.001 Hz

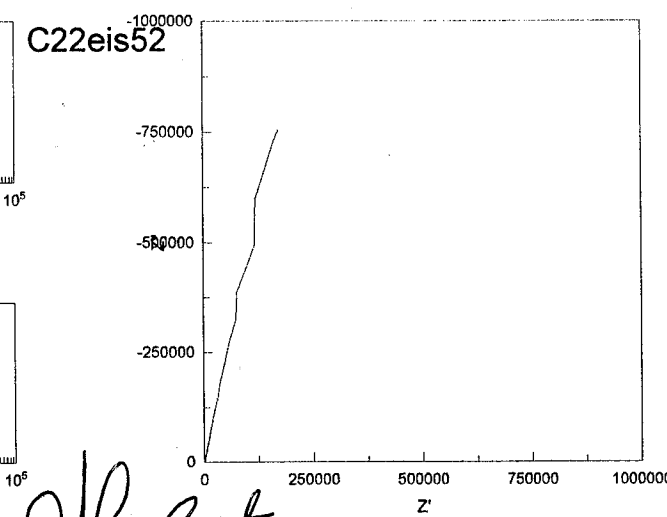
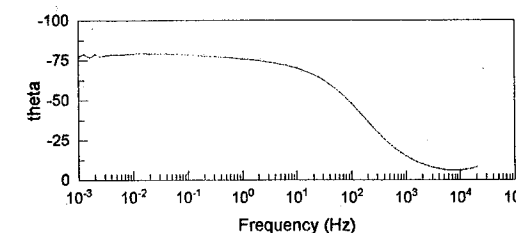
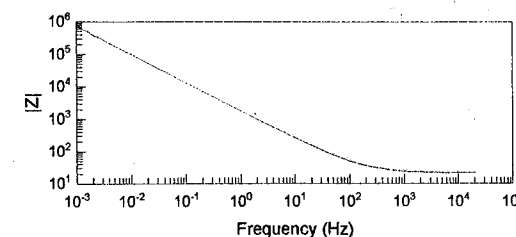
10 steps per decade

Scan 1/12/02

Integration time 5 seconds

Delay 2 seconds

Data: C22eis52

John Best
7/22/02

continued on pg 44

Witnessed & Understood by me,

Date

Invented by

Date

Recorded by

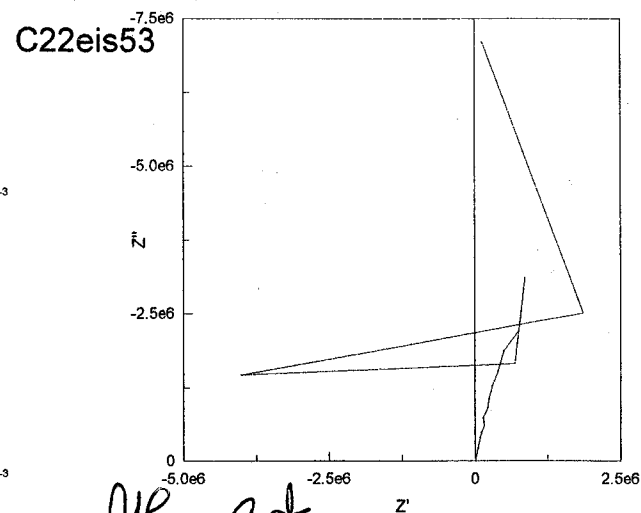
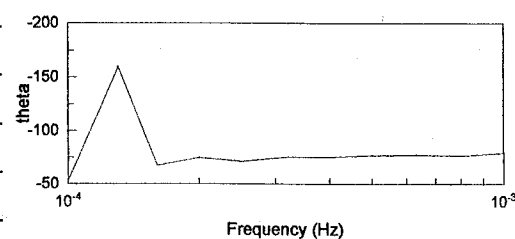
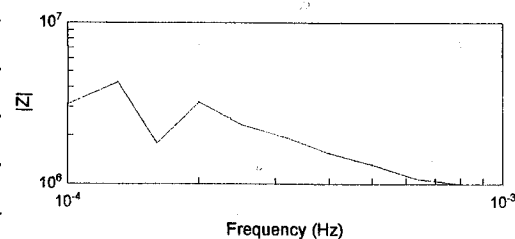
John Best

7/22/02

To Page No. _____

From Page No. _____ Electrochemical Impedance Test for Alloy C-22 (continued from pg 43)Test: C22eis53Integration time: 5 secondsDelay: 2 seconds

10 steps per Decade

Initial Frequency: 20000 HzFinal Frequency: 0.0001 Hz

John Boet
7/23/02

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Witnessed & Understood by me,

Date

Invented by

Date

Recorded by

John Boet

7/23/02

From Page No. _____

Witnessed & Understood by me,

Date

Invented by

Date

Recorded by

John Boet

8/8/02

To Page No. _____

From Page No. _____ Polarization Resistance Test for Alloy C-22

Objective: same as pg 1

Specimen: C-22 heat: 2277-8-3175 Thermally Aged at 870°C for 4 hours Polished to a 600 grit finish.

Start wt: 11.9394g Santorius Gerings S/N 12809099 cal 6/4/02

End wt: cal dw: 12/04/02

Solution: 0.028M NaCl
3.296 g NaCl Lot: 020814
+ DI H₂O up to 2000 ml

pH start: 5.592
3.296 g 7/29/02 Orion 720A S/N 005885 cal: 7/10/02 due: 7/10/03

pH End: pH probe # 13-620-296 S/N 1100208

Potentiostat: Solartron 1287

Counter electrode: Pt flag

Reference: Fisher 13-620-52 S/N 0052132

Temperature: 95°C H₂ Thermistor S/N H58-162 cal 7/26/02 due: 4/22/03

E_{open}: -314 mV Krithley 614 S/N 704931 cal 5/26/02 due: 5/26/03

E_{PR}: 23.4 mV

Solution Deaerated with 99.999% N₂

Specimen Examination: _____

continued on pg. 47

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Witnessed & Understood by me, _____

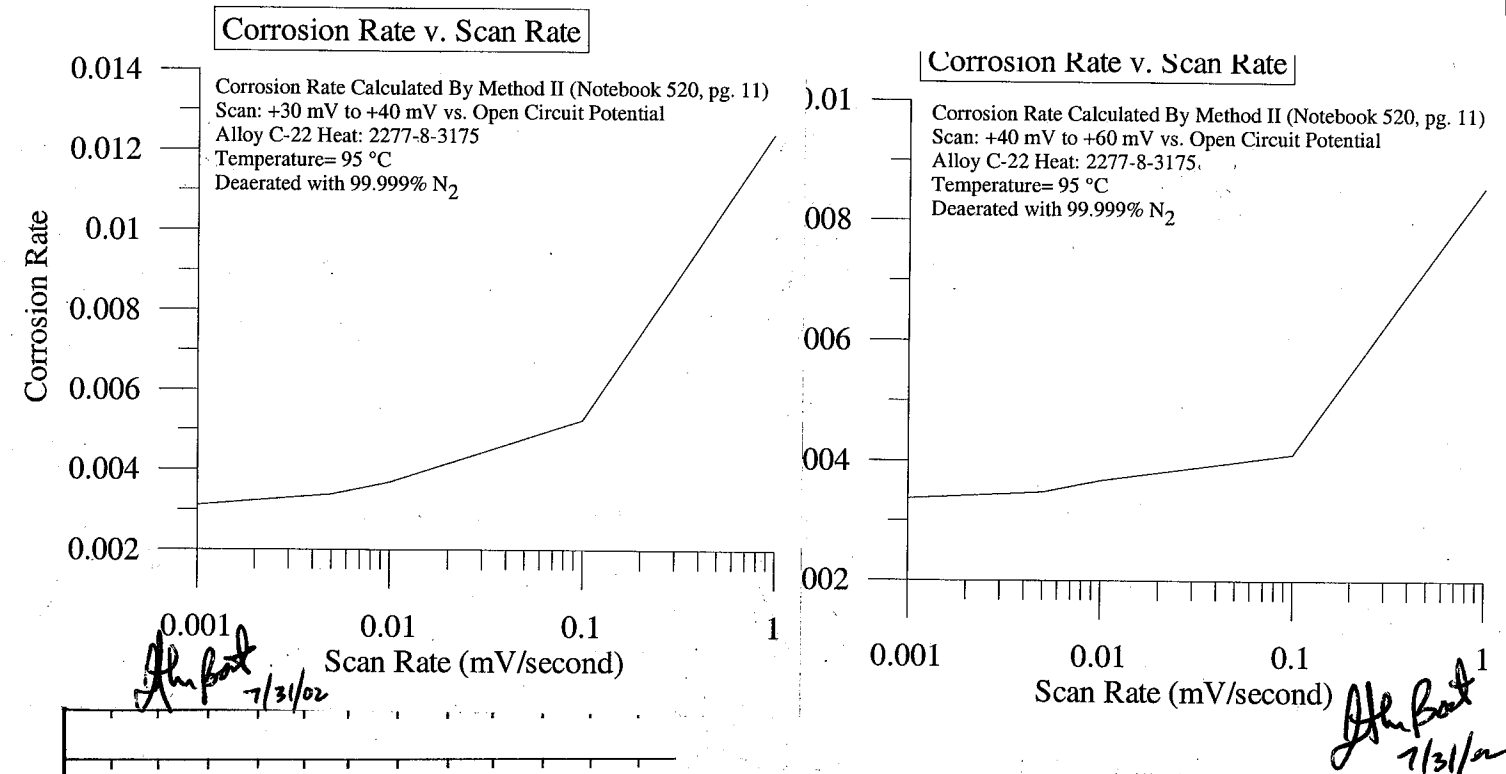
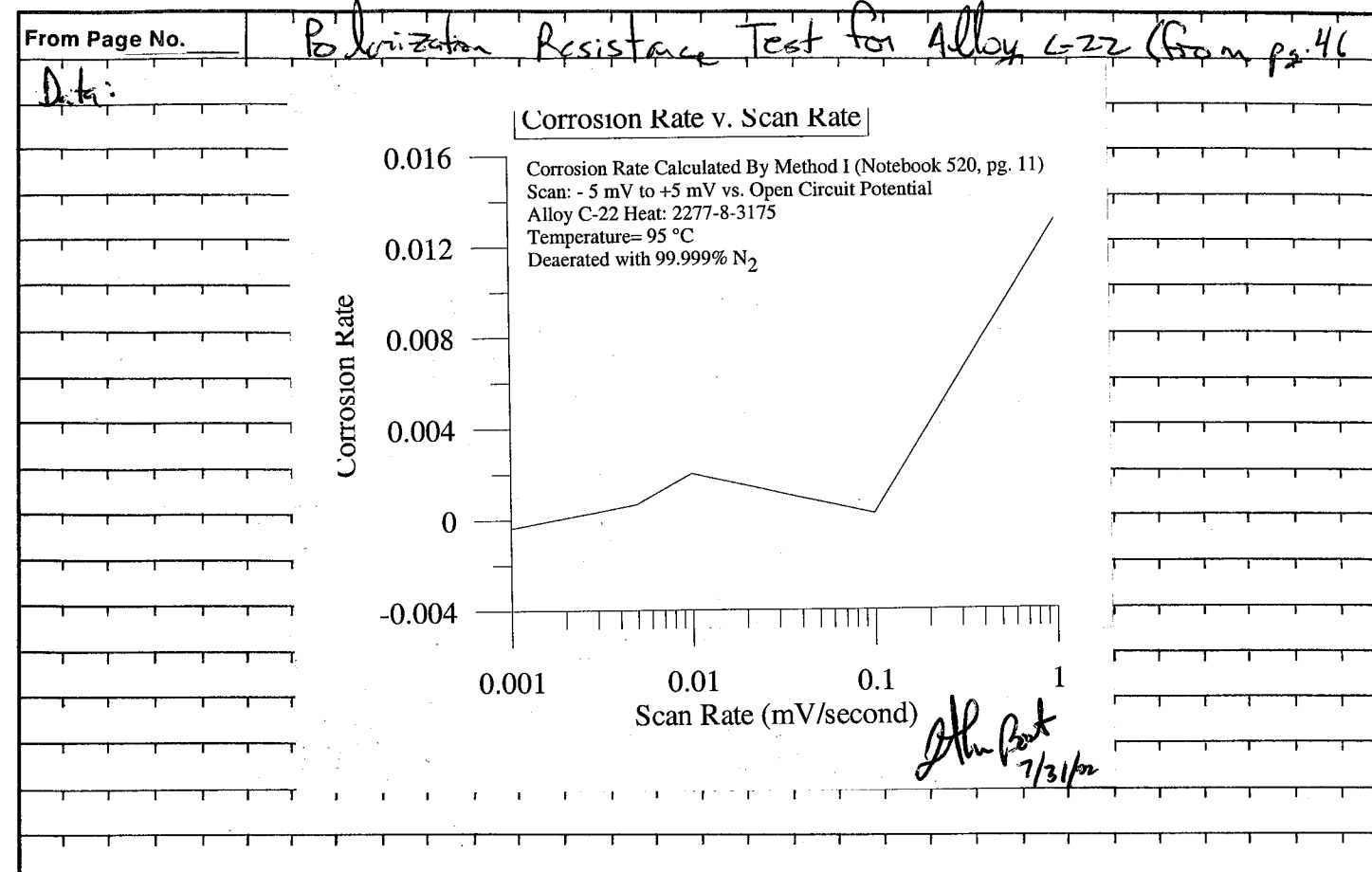
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Recorded by John Bat

7/29/02



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Witnessed & Understood by me, _____

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Date _____

Recorded by John Bat

7/31/02

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Polarization Resistance test for Alloy C-22 (from pg. 47)

Test: C22 Apr 76

Scan: -15mV to +60mV vs. open circuit potential

Scan Rate: 1 mV/second

 $E_{corr} = -0.381 \text{ V vs. SCE}$

Results: Method I (see formulas in Notebook 520, pg. 11)

$$(dE/dI)_{corr} = 2.56530 \times 10^{-5}$$

$$R_p = 3.8982 \times 10^4 \Omega \text{ cm}^2$$

$$i_{corr} = 1.3360 \times 10^{-6} \text{ A/cm}^2$$

$$C.R. = 0.0131 \text{ mm/yr}$$

Method II (see formulas in Notebook 520, pg. 11)

A. For Data: +30mV to +40mV vs. open circuit potential
($-0.288 < E < -0.278$)

$$b = 1.03975 \times 10^{-6}$$

$$n = -7.06448 \times 10^{-7}$$

$$i_{corr} = 1.26447 \times 10^{-6} \text{ A/cm}^2$$

$$C.R. = 0.0124 \text{ mm/yr}$$

B. For Data: +40mV to +60mV vs. open circuit potential
($E > -0.278$)

$$b = 3.923950 \times 10^{-6}$$

$$n = 9.58755 \times 10^{-6}$$

$$i_{corr} = 8.7370 \times 10^{-7}$$

$$C.R. = 0.00856 \text{ mm/yr}$$

Data: C22 Apr 76 (Method I) pg. 45

C22 Apr 76 (Method II) pg. 45

Continued on pg. 49

To Page No. _____

Witnessed & Understood by me, _____

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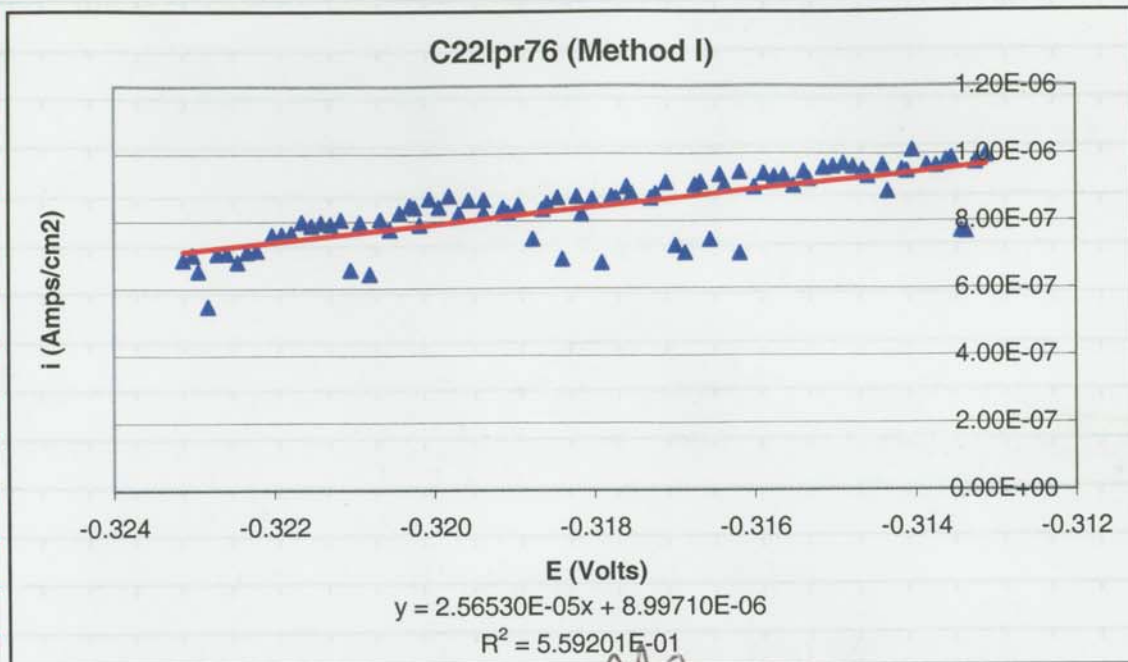
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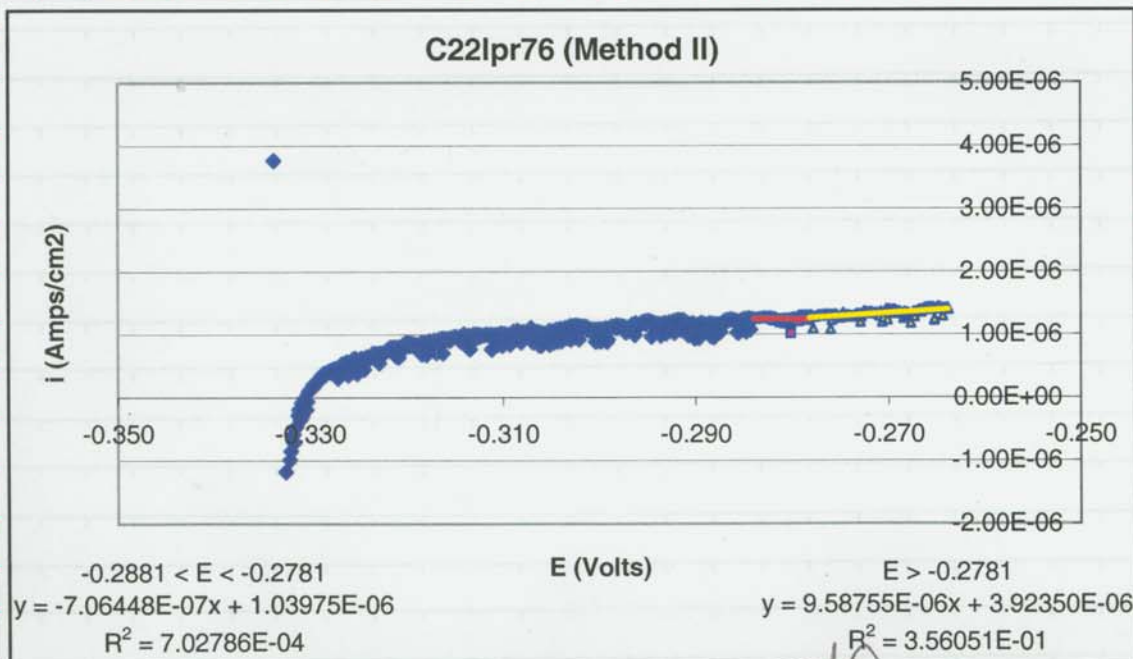
From Page No. _____

Polarization Resistance Test for Alloy C22 (from pg. 48)

Data



John Bat 7/29/02



John Bat 7/29/02

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Witnessed & Understood by me, _____

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John Bat

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Polarization Resistance Test for Alloy C-22 (From pg 45)

Test: C22 for 77

Scan: -15 mV to +60 mV vs. open circuit potential

Scan Rate: ~~0.01~~ ^{B 7/29/02} 0.1 mV/s $E_{\text{corr}} = -0.3355 \text{ V vs. SCE}$

Results: Method I (see formulas in Notebook 520, pg 11)

$$(dE/dI)_{E_{\text{corr}}} = 4.17211 \times 10^{-7}$$

$$R_p = 2.3969 \times 10^6 \Omega \cdot \text{cm}^2$$

$$i_{\text{corr}} = 2.1728 \times 10^{-8} \text{ A/cm}^2$$

$$\text{C.R.} = 0.000213 \text{ mm/yr}$$

Method II (see formulas in Notebook 520, pg 11)

A. For Data +30 mV to +40 mV vs. open circuit potential
($-0.3055 < E < -0.2955$)

$$b = 8.55227 \times 10^{-7}$$

$$m = 9.57419 \times 10^{-7}$$

$$i_{\text{corr}} = 5.5672 \times 10^{-7} \text{ A/cm}^2$$

$$\text{C.R.} = 0.00540 \text{ mm/yr}$$

$$0.00523 \text{ mm/yr}$$

B. For Data +40 mV to +60 mV vs. open circuit potential
($E > -0.2955$)

$$b = 1.77998 \times 10^{-6}$$

$$m = 4.05322 \times 10^{-6}$$

$$i_{\text{corr}} = 4.90651 \times 10^{-7} \text{ A/cm}^2$$

$$\text{C.R.} = 0.00481 \text{ mm/yr}$$

$$0.00412 \text{ mm/yr}$$

Data: C22 for 77 (Method I) pg 51

C22 for 77 (Method II) pg 51

continued on pg 51

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7/29/02

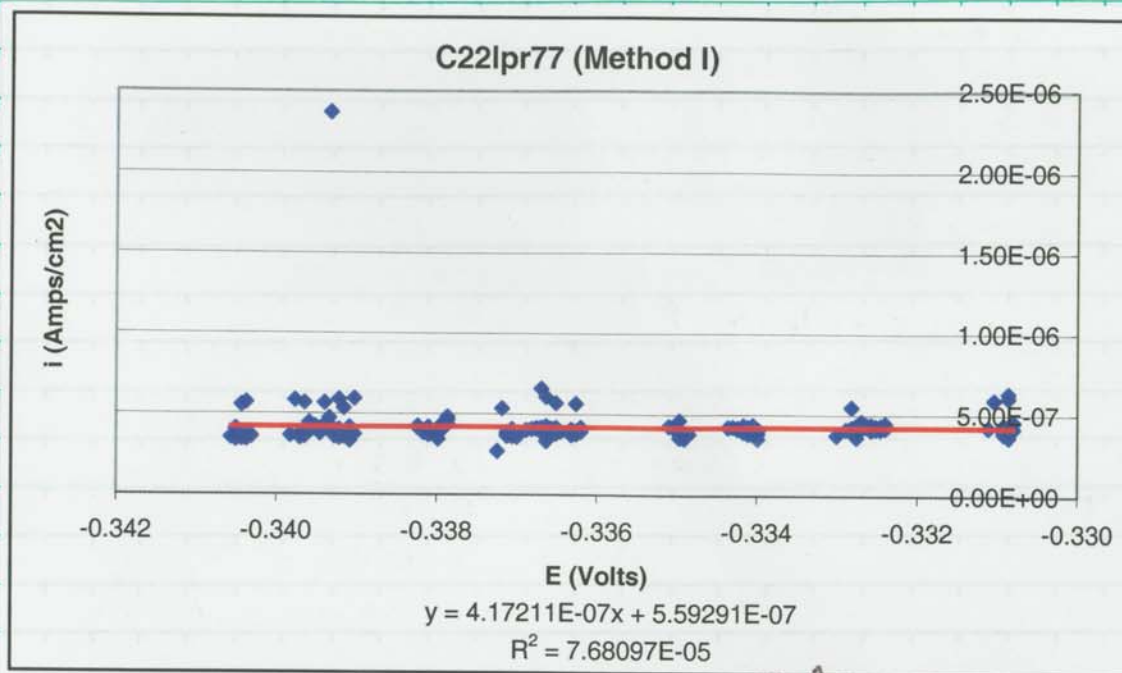
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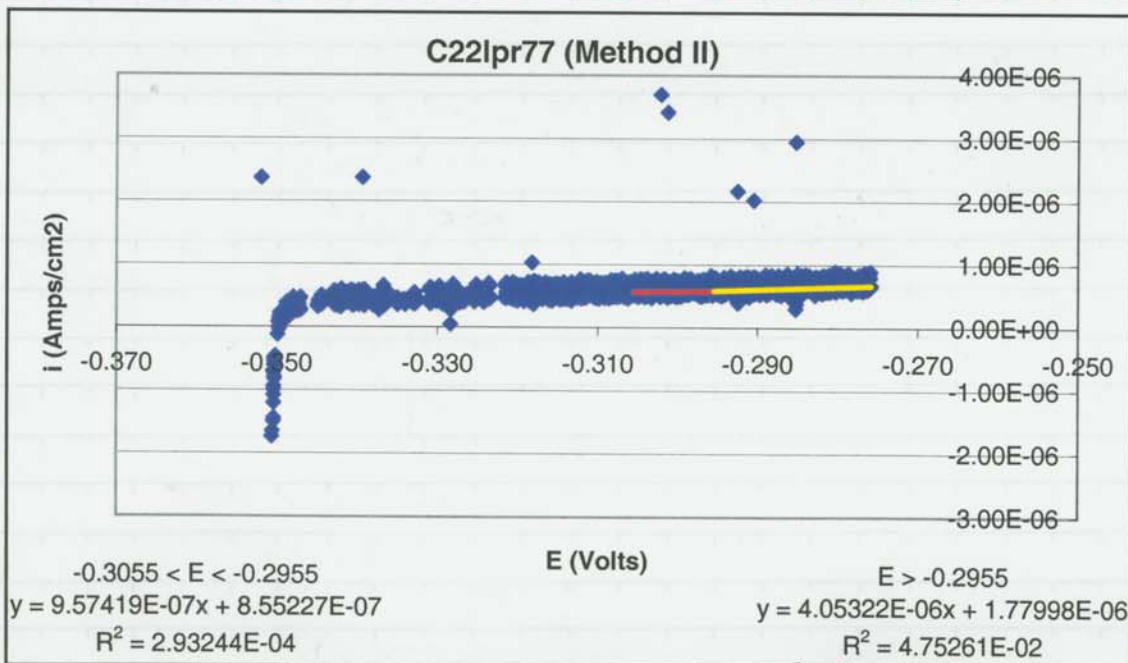
From Page No. _____

Polarization Resistance Test for Alloy C-22 (from pg. 50)

Data:



John Best 7/29/02



John Best 7/29/02

continuation pg. 52

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Witnessed & Understood by me, _____

Date _____

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Polarization Resistance Test for Alloy C-22 (from pg. 51)

Test: C22 lot 78

Scan: -15 mV to +60 mV vs. open circuit potential

Scan Rate: 0.01 mV/s

 $E_{\text{corr}} = -0.3457 \text{ V vs. SCE}$

Results: Method I (see formulas in Notebook 520, pg. 11)

$$\Delta E / \Delta I \quad E_{\text{corr}} = 3.93963 \times 10^{-6}$$

$$R_p = 2.5383 \times 10^5 \text{ } \Omega \cdot \text{cm}^2$$

$$i_{\text{corr}} = 2.0518 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00201 \text{ mm/yr}$$

Method II (see formulas in Notebook 520, pg. 11)

A. for Data +30 mV to +10 mV vs. open circuit potential
(-0.3157 V E < -0.3057)

$$b = 9.21699 \times 10^{-7}$$

$$m = 1.58122 \times 10^{-6}$$

$$i_{\text{corr}} = 3.75071 \times 10^{-7}$$

$$C.R. = 0.00368 \text{ mm/yr}$$

B. for Data +40 mV to +60 mV vs. open circuit potential
($E > -0.3057$)

$$b = 9.08265 \times 10^{-7}$$

$$m = 1.54279 \times 10^{-6}$$

$$i_{\text{corr}} = 3.74922 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00367 \text{ mm/yr}$$

Data: C22 lot 78 (Method I) pg. 53

C22 lot 78 (Method II) pg. 53

continued on pg. 53

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Witnessed & Understood by me, _____

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John Boet

7/30/02

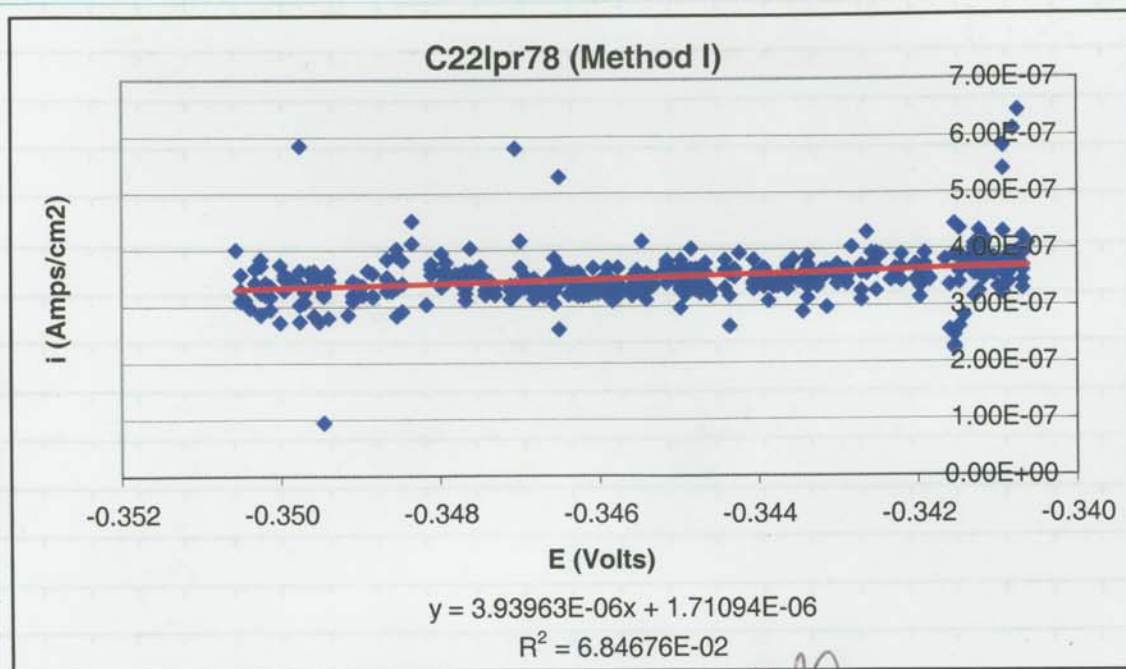
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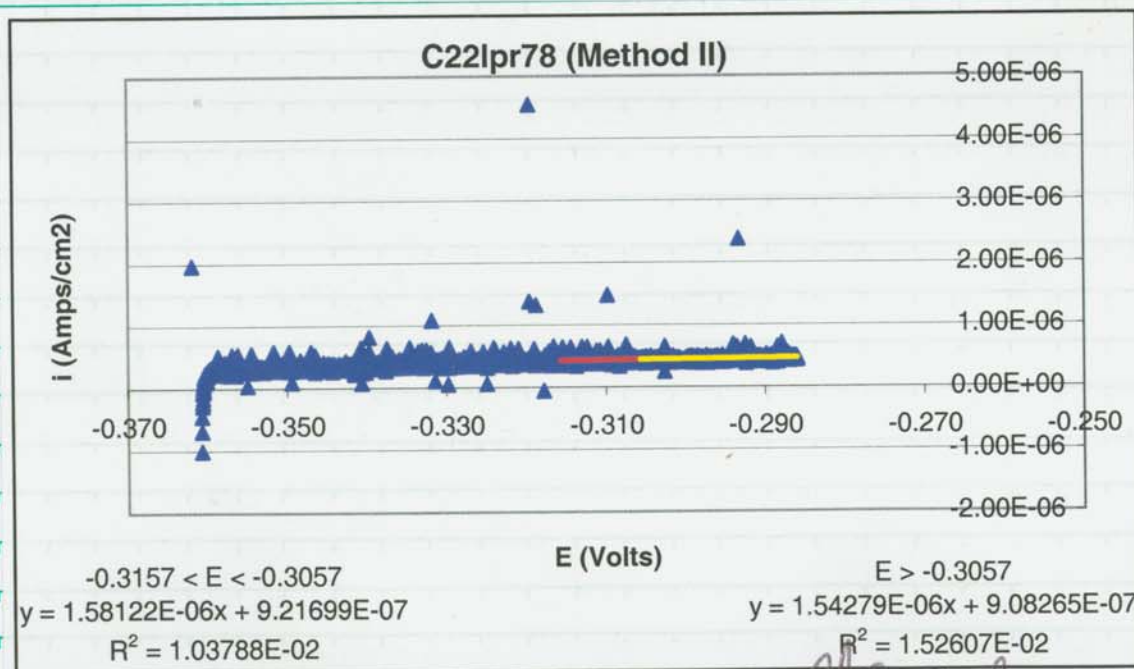
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Polarization Resistance Test for Alloy C-22 (from pg. 52)

Data:



JHBat 7/30/02



JHBat 7/30/02

continued on pg. 54

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Witnessed & Understood by me, _____

Date _____

Invented by _____

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7/30/02

From Page No. _____

Polarization Resistance for Alloy C22 (from pg 53)

Test: C22 p. 79

Scan: -15 mV to +60 mV vs. open circuit potential

Scan Rate: 0.005 mV/s

 $E_{corr} = -0.3485V$ vs. SCE

Results: Method I (see formulas in Notebook 520, pg. 11)

$$(\partial E / \partial I)_{E_{corr}} = 1.31323 \times 10^{-6}$$

$$R_p = 7.6148 \times 10^5 \Omega \cdot \text{cm}^2$$

$$i_{corr} = 6.8343 \times 10^{-8} \text{ A/cm}^2$$

$$C.R. = 0.000670 \text{ mm/yr}$$

Method II (see formulas in Notebook 520, pg. 11)

A. for Data +30 mV to +40 mV vs. open circuit potential
(E vs. SCE 7/29/02) (0.3185 V E < -0.3085)

$$b = 7.66353 \times 10^{-7}$$

$$m = 1.21151 \times 10^{-6}$$

$$i_{corr} = 3.44142 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00337 \text{ mm/yr}$$

B. for Data +40 mV to +60 mV vs. open circuit potential
(E > -0.3085)

$$b = 6.90480 \times 10^{-7}$$

$$m = 9.62518 \times 10^{-7}$$

$$i_{corr} = 3.55042 \times 10^{-7}$$

$$C.R. = 0.00348 \text{ mm/yr}$$

Data: C22 p. 79 (Method I) pg. 55

C22 p. 79 (Method II) pg. 55

continued on pg. 55

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Witnessed & Understood by me, _____

Date _____

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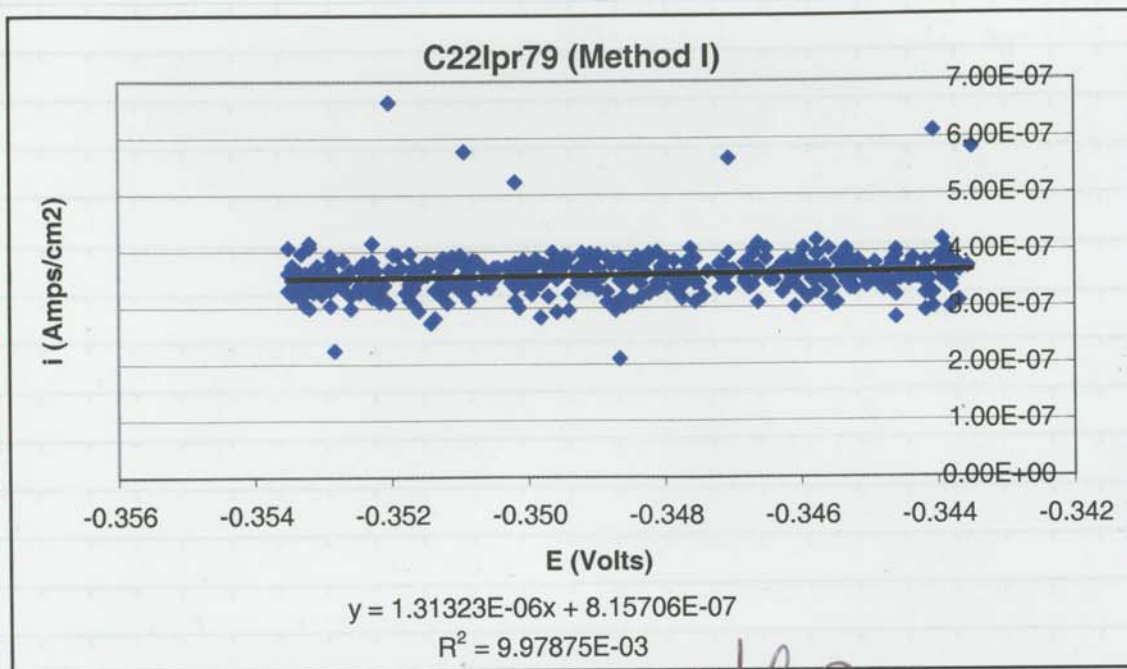
John Boett

7/30/02

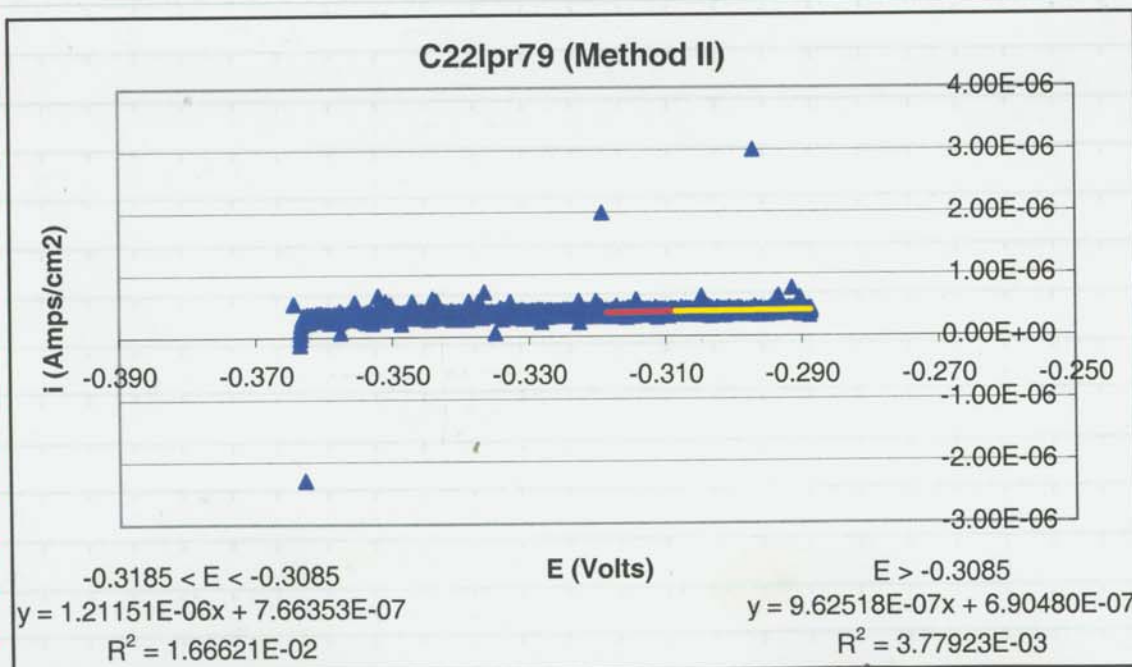
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Polarization Resistance for Alloy C22 (from pg. 54)

Data:



Jth Bart 7/30/02



Jth Bart 7/30/02

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Witnessed & Understood by me, _____

Date _____

Invented by _____

Date _____

Recorded by _____

7/30/02

Jth Bart

From Page No. _____

Polarization Resistance Test for Alloy C-22 (from pg. 55)

Tet: C22 pr 80

Scan: -15mV to +60mV vs. open circuit potential

Scan Rate: 0.001 mV/s

 $E_{corr} = -0.3380$ V vs. SCEResults: Method I (see ~~calc~~ ^{JB 7/24/02} formulas in Notebook 520, pg. 11)

$$(dE/dI)_{E_{corr}} = -7.26104 \times 10^{-7}$$

$$R_p = -1.3772 \times 10^6 \Omega \cdot \text{cm}^2$$

$$i_{corr} = -3.7815 \times 10^{-8} \text{ A/cm}^2$$

$$C.R. = -0.000371 \text{ mm/yr}$$

Method II (see formulas in Notebook 520, pg. 11)

A. for Data +30mV to +40mV vs. open circuit potential

$$(-0.3430 < E < -0.2880) \text{ }^{JB 7/31/02} (-0.3080 < E < -0.2980)$$

$$b = 6.49226 \times 10^{-7}$$

$$n = 9.85281 \times 10^{-7}$$

$$i_{corr} = 3.16201 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00310 \text{ mm/yr}$$

B. for Data +40mV to +60mV vs. open circuit potential

$$(E > -0.333) \text{ }^{JB 7/31/02} (-0.2980)$$

$$b = 3.97278 \times 10^{-7}$$

$$n = 1.56644 \times 10^{-7}$$

$$i_{corr} = 3.44332 \times 10^{-7}$$

$$C.R. = 0.00337 \text{ mm/yr}$$

Data: C22 pr 80 (Method I) pg. 57

C22 pr 80 (Method II) pg. 57

continued on pg. 57

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Witnessed & Understood by me, _____

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John Bat

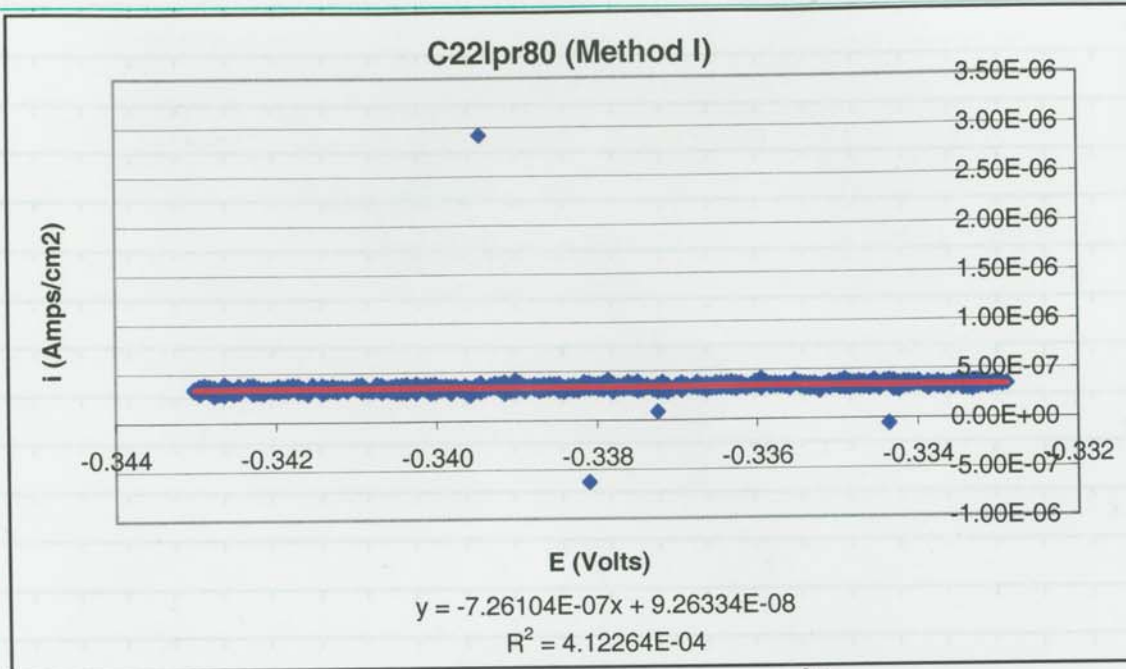
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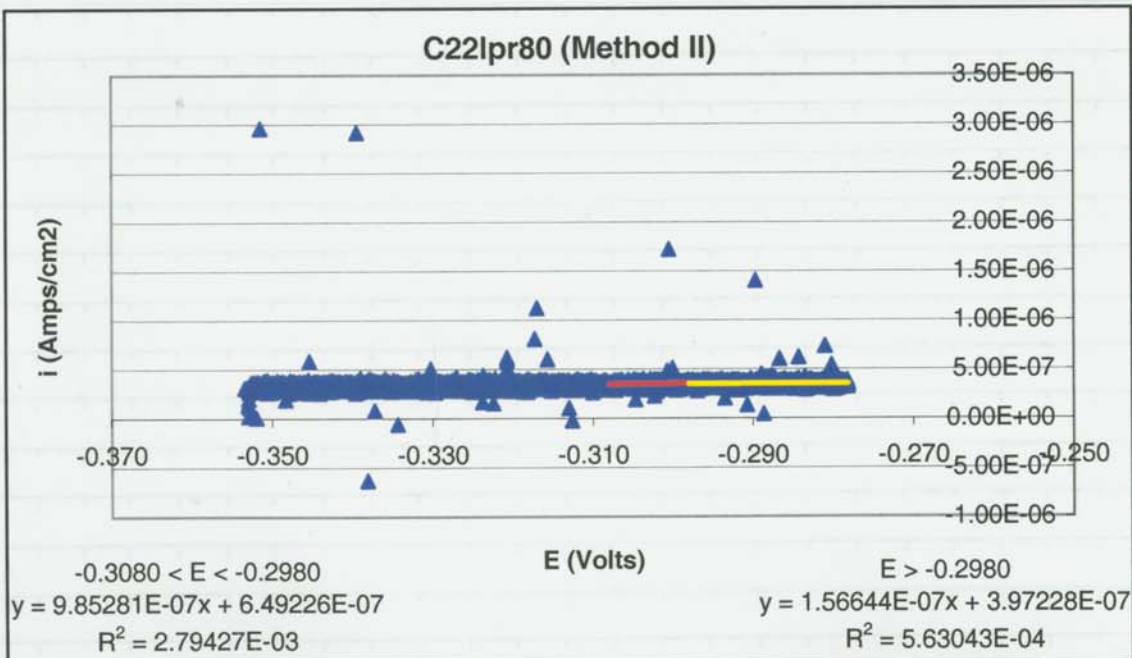
From Page No. _____

Polarization Resistance Test for Alloy C-22 (from pg. 56)

Data:



John Boat
7/21/02



John Boat
7/31/02

To Page No. _____

Witnessed & Understood by me, _____

Date _____

Invented by _____

Date _____

Recorded by _____

7/31/02

From Page No. _____ Electrochemical Impedance Test for Alloy C-22

Objective: same as pg 2

Specimen: Alloy C-22 heat: 22-77-8-3175 Thermally aged @ 870°C for 4 hours; polished to a 600 grit finish, same test specimen as pg. 46

start wt: 11.93949 g Sartorius gains S/N 12809099 cal: 6/4/02
End wt: due 12/01/02

Solution: 0.628M NaCl
3.296 g NaCl Lt: 020814
+DI H₂O up to 2000 ml

pH start: 5.592 Orion 720A S/N 005885 cal: 7/10/02 due: 7/10/03
pH end: pH probe # 13-620-296 S/N 1100208

cell info: Area: 8 cm²
density: 8.146 g/cm³
Equivalent wt: 26.04

Impedance Analyzer: Solartron 1260

Counter electrode: Pt wire

Reference: Fisher 13-620-52 S/N 0052132

Temperature: 95°C Hg Thermometer S/N H48-162 cal 4/22/02 due: 4/22/03

E_{corr}: -314 mV Keithley 614 S/N 704936 cal 5/21/02 due: 5/26/03
E_{ref}: 127.5 mV

Solution Deaerated with 99.999% N₂

Specimen examination:

continued on pg 59

Witnessed & Understood by me,	Date	Invented by	Date
		Recorded by John Best	8/1/02

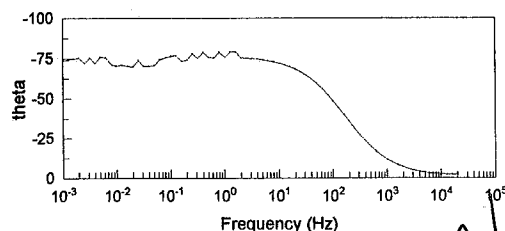
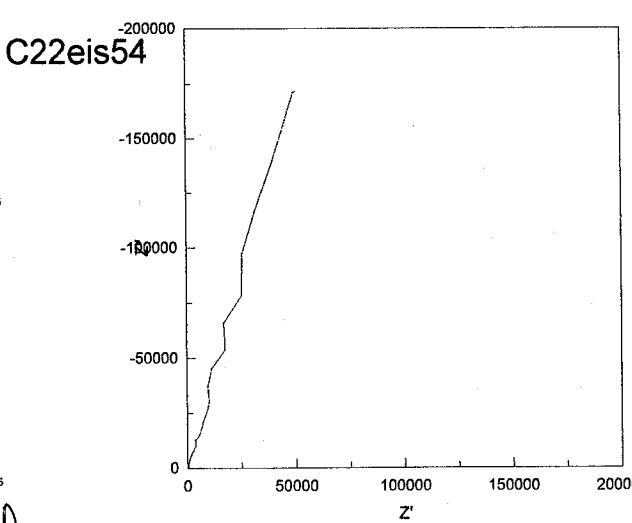
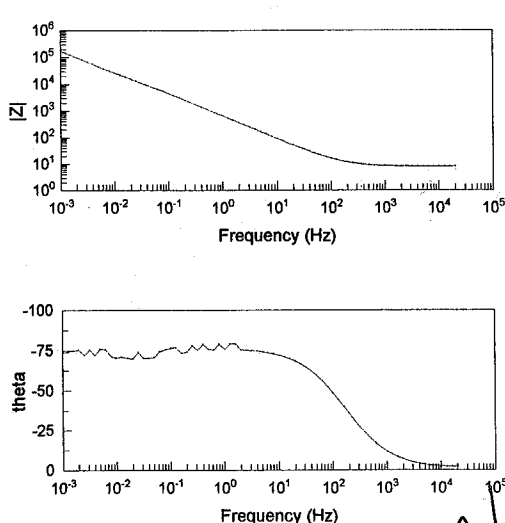
From Page No. _____ Electrochemical Impedance Test for Alloy C-22 (from pg. 58)

Test: C22eiz54

Initial frequency: 20000 Hz
Final frequency: 0.001 Hz
10 steps per decade

Integ. gradient time: 5 seconds
Delay: 2 seconds

Data: C22eiz54



John Best 8/1/02

continued on pg. 60

Witnessed & Understood by me,	Date	Invented by	Date
		Recorded by John Best	8/1/02

From Page No. _____

Electrochemical Impedance Test for Alloy C-22 (from pg. 59)

Test: C22 eis 55

Initial frequency: 20000 Hz

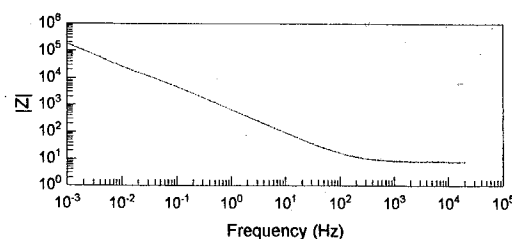
Final frequency: 0.001 Hz

10 steps per decade

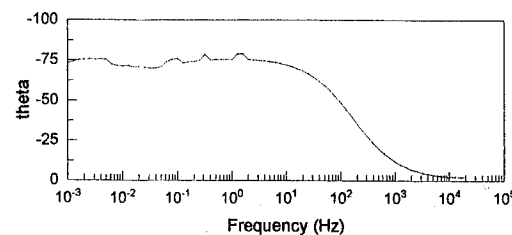
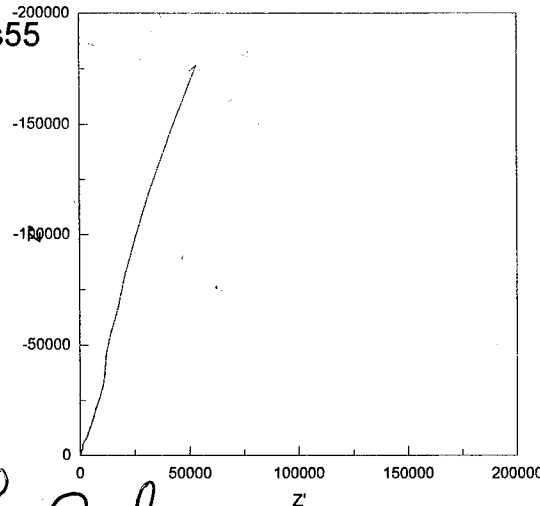
Integration time: 5 seconds

Delay: 2 seconds

Data: C22 eis 55



C22eis55



John Bost
8/1/02

continued on pg. 61

Witnessed & Understood by me, _____

Date _____

Invented by _____

Recorded by _____

John Bost
8/1/02

Date _____

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From Page No. _____

Electrochemical Impedance Test for Alloy C-22 (from pg. 60)

Test: C22 eis 56

Initial frequency: 20000 Hz

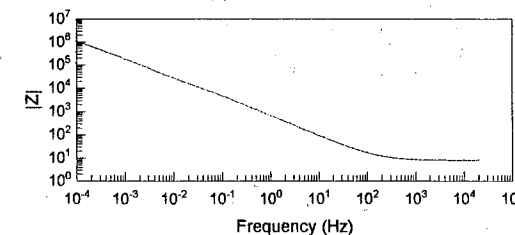
Final frequency: 0.001 Hz

10 steps per decade

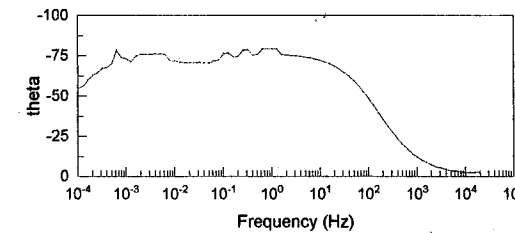
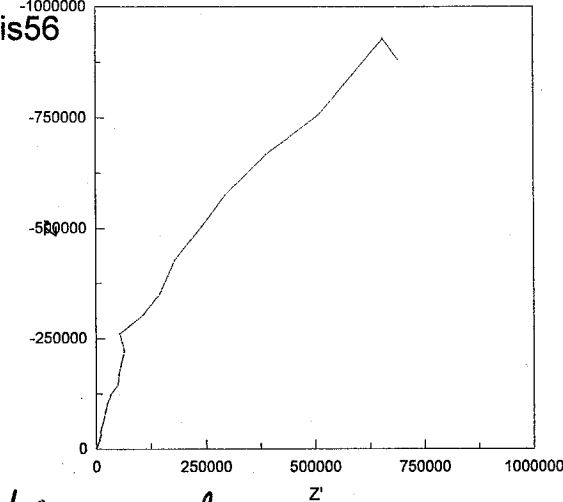
Integration time: 5 seconds

Delay: 2 seconds

Data: C22 eis 56



C22eis56



John Bost
8/1/02

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Date _____

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From Page No. _____ Polarization Resistance Test for Alloy C-22

Objectives: Same as pg. 1

Specimen: C-22 Heat: 2277-8-3175 Thermally Aged at 870°C for 4 hours
Polished to a 600 grit finish; same test specimen as pg. 41

Start wt: 11.93949 g Subbing genius S/N 12809095 cal: 6/4/02
End wt: 11.93943 g due: 12/4/02

Solution: 0.028M NaCl
3.296g NaCl Lit 020814
+DI H₂O up to 2000ml

pH start: 5.542 Orion 720A S/N 005285 cal 7/10/02 due 7/10/03
pH End: 6.108 pH probe # 13-620-294 S/N 1106208

Potentiostat: Solartron 1287

Counter electrode: Pt flag

Reference: Fisher 13-620-52 S/N 0052132

Temperature: 80°C Hg Thermometer S/N H48-162 cal 4/22/02 due: 4/22/03

E_{corr}: -314mV Keithley 614 S/N 709936 cal 5/21/02 due 5/26/03
E_{ref}: 23.4mV

Solution Deaerated with 99.999% N₂

Specimen examination: No staining on Any of Surface And No visible signs of corrosion on specimen

continued on pg 63

Witnessed & Understood by me, _____ Date _____
Invented by _____ Date _____
Recorded by *Jth Best* 8/1/02

From Page No. _____ Polarization Resistance Test for Alloy C-22 (from pg. 62)

Date: _____

Method I:

Corrosion Rate v. Scan Rate

Corrosion Rate Calculated By Method I (Notebook 520, pg. 11)
Scan: -5 mV to +5 mV vs. Open Circuit Potential
Alloy C-22 Heat: 2277-8-3175
Temperature= 80 °C
Deaerated with 99.999% N₂

Jth Best 8/6/02

Method II:

Corrosion Rate v. Scan Rate

Corrosion Rate Calculated By Method I (Notebook 520, pg. 11)
Scan: +30 mV to +40 mV vs. Open Circuit Potential
Alloy C-22 Heat: 2277-8-3175
Temperature= 80 °C
Deaerated with 99.999% N₂

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Corrosion Rate v. Scan Rate

Corrosion Rate Calculated By Method I (Notebook 520, pg. 11)
Data: +40 mV to +60 mV vs. Open Circuit Potential
Alloy C-22 Heat: 2277-8-3175
Temperature= 80 °C
Deaerated with 99.999% N₂

Jth Best 8/6/02

continued on pg 64

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Invented by _____ Date _____
Recorded by *Jth Best* 8/6/02

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Polarization Resistance Test for Alloy L22 (from pg. 63)

Test: L22 p. 81

Scan: -15 mV vs. open circuit potential to +60 mV vs. open circuit potential

Scan Rate: 1 mV/second

 $E_{cor} = -0.2106 \text{ V vs. SCE}$

Results: Method I (see formulas in Notebook 520, pg. 11)

$$(\partial E / \partial i)_{E_{cor}} = 4.04119 \times 10^{-6}$$

$$R_p = 2.4745 \times 10^5 \text{ } \Omega \cdot \text{cm}^2$$

$$i_{cor} = 2.1047 \times 10^{-7} \text{ A/cm}^2$$

$$CR = 0.00206 \text{ mm/yr}$$

Method II (see formulas in Notebook 520, pg. 11)

A. Data from +30 mV to +40 mV vs. open circuit potential
($-0.1806 < E < -0.1706$)

B 8/6/02

$$b = 9.69465 \times 10^{-6} \text{ } 2.47966 \times 10^{-6}$$

$$m = 9.69465 \times 10^{-6}$$

$$i_{cor} = 7.07967 \times 10^{-7} \text{ A/cm}^2$$

$$CR = 0.00694 \text{ mm/yr}$$

B. Data from +40 mV to +60 mV vs. open circuit potential
($E > -0.1706$)

$$b = 9.67308 \times 10^{-7}$$

$$m = 8.61269 \times 10^{-7}$$

$$i_{cor} = 7.84902 \times 10^{-7} \text{ A/cm}^2$$

$$CR = 0.06769 \text{ mm/yr}$$

Data: L22 p. 81 (Method I) pg. 65

L22 p. 81 (Method II) pg. 65

continued on pg. 65

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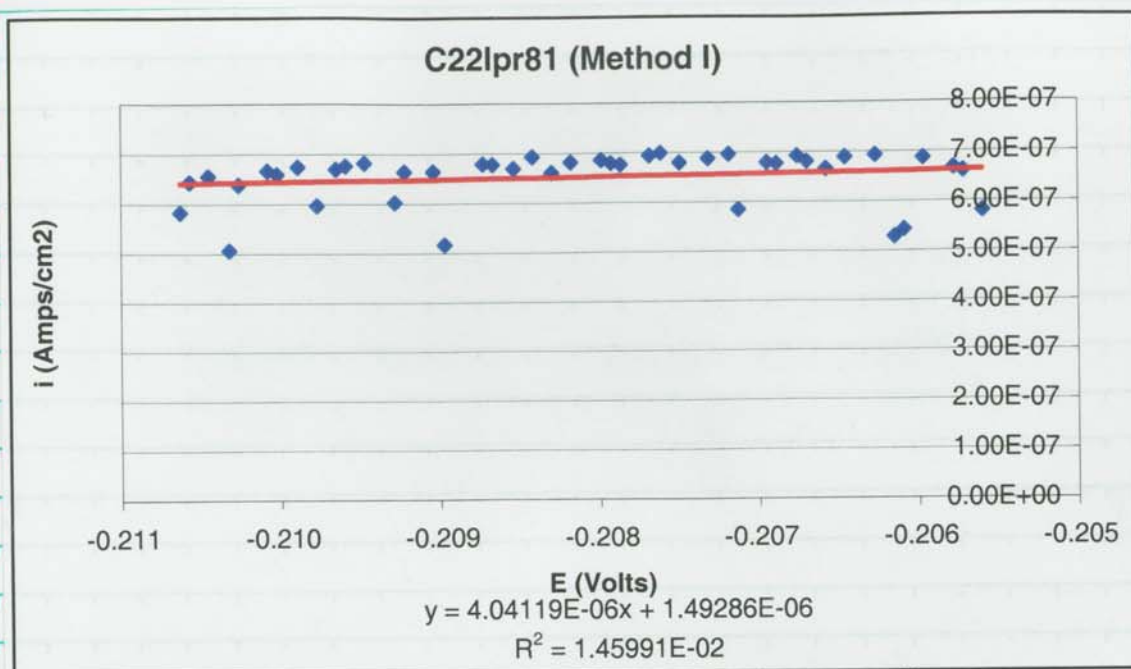
John Post

8/6/02

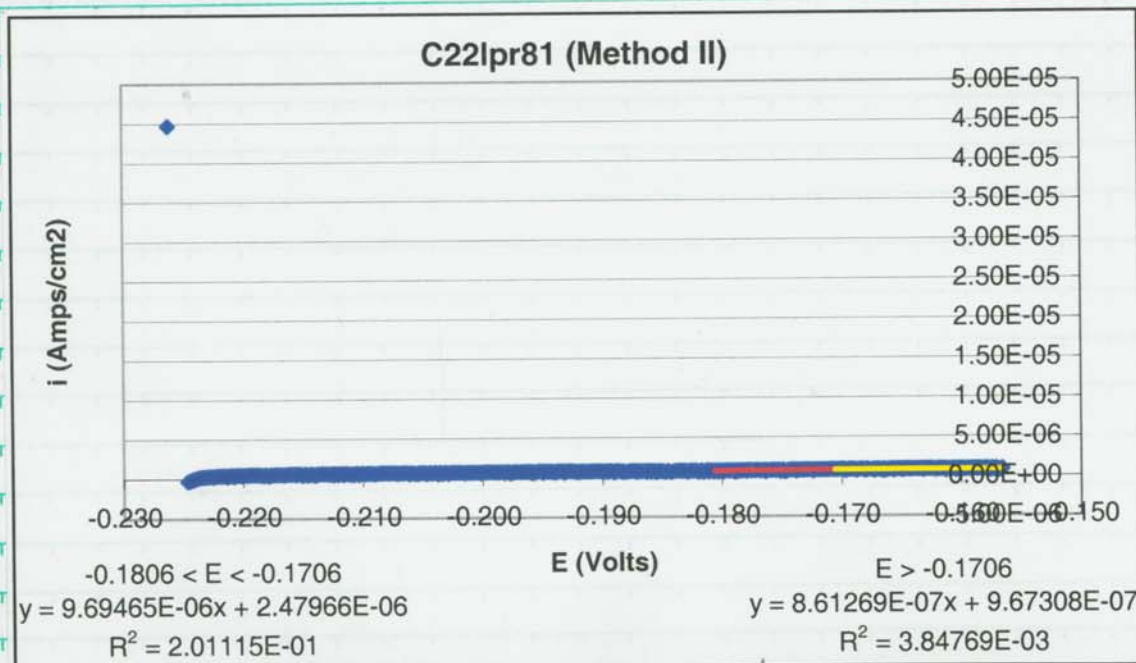
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Polarization Resistance Test for Alloy C-22 (from pg. 64)

Data:



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Polarization Resistance Test for Alloy C-22 (from pg. 65)

Test: C22 Apr 82

Scan: -15mV to +60mV vs. open circuit potential

Scan Rate: 0.1mV/second

E_{corr}: -0.1802 V vs. SLE

Results: Method I (see formulas in Notebook 520, pg. 11)

$$\begin{aligned}
 (dE/dI)_{E_{corr}} &= 1.95874 \times 10^{-6} \\
 R_p &= 5.1053 \times 10^5 \Omega \cdot \text{cm}^2 \\
 i_{corr} &= 1.6201 \times 10^{-7} \text{ A/cm}^2 \\
 C.R. &= 0.00100 \text{ mm/yr}
 \end{aligned}$$

Method II (see formulas in Notebook 520 pg. 11)

A Data from +30mV to +40mV vs. open circuit potential
 (-0.1502 < E < -0.1402)

$$\begin{aligned}
 b &= 9.62963 \times 10^{-7} \\
 m &= 3.69939 \times 10^{-6} \\
 i_{corr} &= 2.96333 \times 10^{-7} \text{ A/cm}^2 \\
 C.R. &= 2.90 \times 10^{-3} \text{ mm/yr} = 0.00290 \text{ mm/yr}
 \end{aligned}$$

B Data from +40mV to +60mV vs. open circuit potential
 (E > -0.1402)

$$\begin{aligned}
 b &= 8.83082 \times 10^{-7} \\
 m &= 3.2149 \times 10^{-6} \\
 i_{corr} &= 3.03831 \times 10^{-7} \text{ A/cm}^2 \\
 C.R. &= 0.00298 \text{ mm/yr}
 \end{aligned}$$

Data: C22 Apr 82 (Method I) pg. 67

C22 Apr 82 (Method II) pg. 67

Continued on pg. 67

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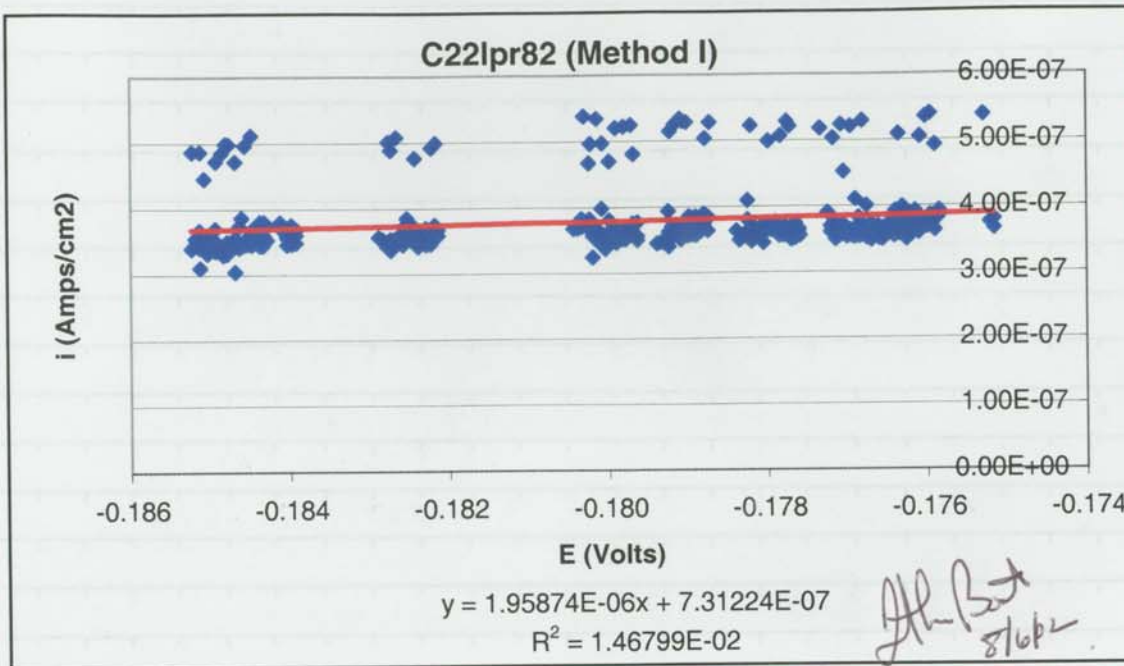
John Best

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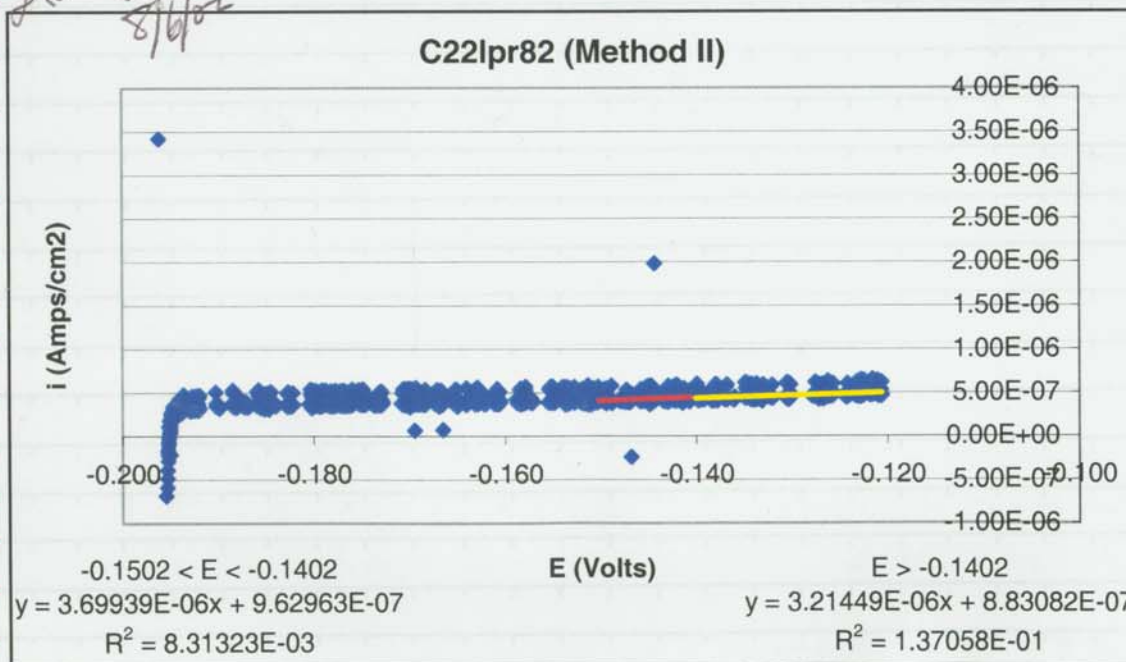
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Polarization Resistance Test for Alloy C22 (from pg. 66)

Data:



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John Boock

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Polarization Resistance Test Pen Alloy C-22 (from pg. 67)

Test: C22 Apr 83

Scan: -15 V to +60 mV vs. open circuit potential

Scan rate: 0.01 mV/second

 $E_{corr} = -0.1640 \text{ V vs. SCE}$

Results: Method I (see formulas in Notebook 520, pg. 11)

$$\left(\frac{\partial E}{\partial I}\right)_{E_{corr}} = -2.41537 \times 10^{-7}$$

$$R_p = -4.1402 \times 10^6 \Omega \cdot \text{cm}^2$$

$$i_{corr} = -1.2579 \times 10^{-8} \text{ A/cm}^2$$

$$C.R. = -0.000123 \text{ mm/yr}$$

Method II (see formulas in Notebook 520, pg. 11)

J3 8/1/82

A. Data from +30 mV to +40 mV vs. open circuit potential
(-0.1390 < E < -0.1240)

$$b = 4.77718 \times 10^{-7}$$

$$m = 9.29141 \times 10^{-7}$$

$$i_{corr} = 3.25339 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00319 \text{ mm/yr}$$

B. Data from +40 mV to +60 mV vs. open circuit potential
(E > -0.1240)

$$b = 5.89216 \times 10^{-7}$$

$$m = 1.88044 \times 10^{-6}$$

$$i_{corr} = 2.80821 \times 10^{-7}$$

$$C.R. = 0.00275 \text{ mm/yr}$$

Data: C22 Apr 83 (Method I) pg 69

C22 Apr 83 (Method II) pg 69

continued on pg. 69

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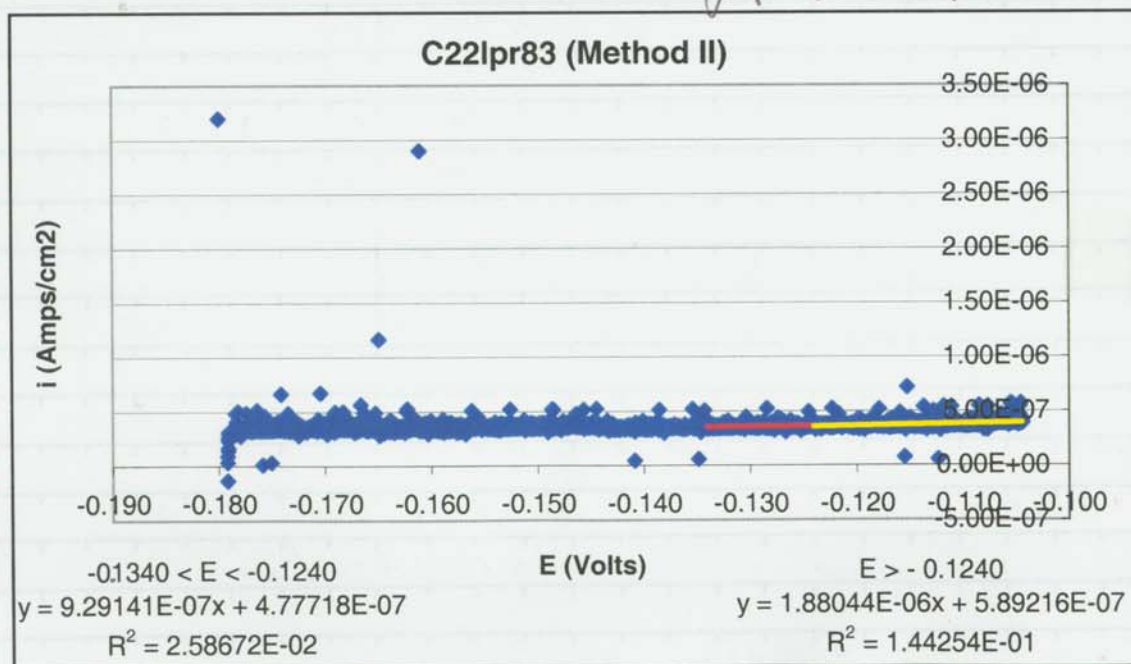
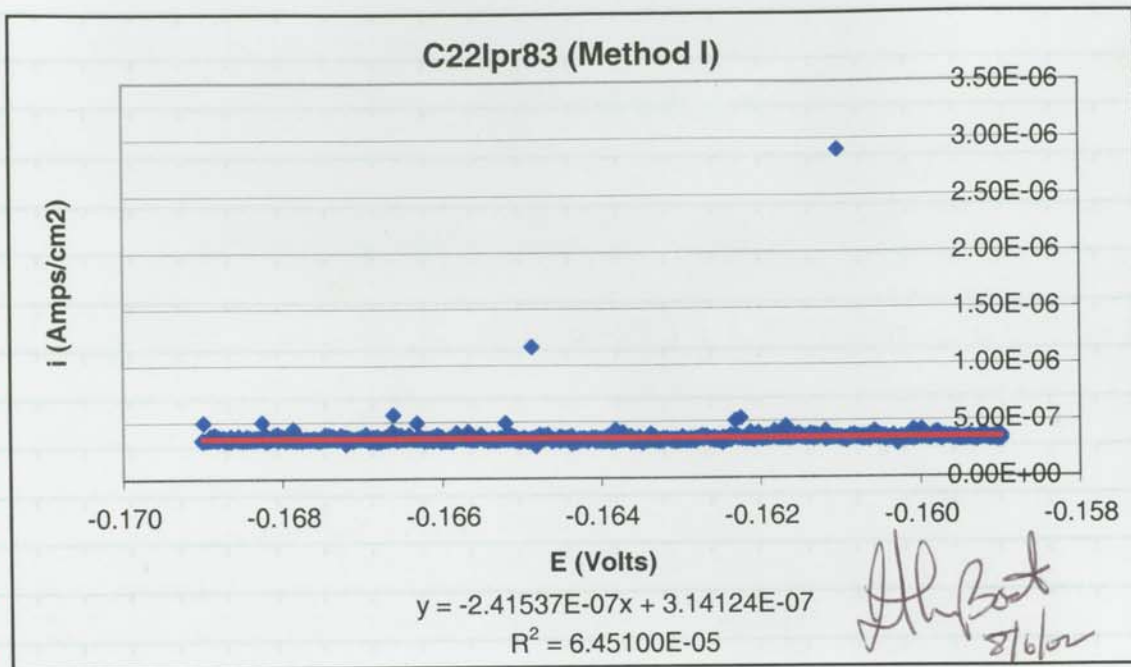
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Polarization Resistance Test for Alloy C-22 (from pg. 68)

Data:



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Polarization Resistance Test for Alloy 622 (From pg. 69)

Test:

B 8/1/82
~~C22 Apr 83~~ C22 Apr 84

Scan: -15 mV to +60 mV vs. open circuit potential

Scan rate: 0.005 mV/second

 $E_{corr} = -0.1410$ V vs. SCE

Results: Method I (see formulas in Notebook 520, pg. 11)

$$(OE/AF)_{E_{corr}} = 8.18437 \times 10^{-7}$$

$$R_p = 1.2218 \times 10^6 \Omega \text{ cm}^2$$

$$i_{corr} = 4.2624 \times 10^{-8} \text{ A/cm}^2$$

$$C.R. = 0.000418 \text{ mm/yr}$$

Method II (see formulas in Notebook 520, pg. 11)

A Data from +30 mV to +40 mV vs. open circuit potential
($-0.1110 < E < -0.1010$)

$$b = 3.73563 \times 10^{-7}$$

$$m = 3.73192 \times 10^{-8}$$

$$i_{corr} = 3.68301 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00361 \text{ mm/yr}$$

B. Data from +40 mV to +60 mV vs. open circuit potential
($E > -0.1010$)

$$b = 4.16351 \times 10^{-7}$$

$$m = 4.21257 \times 10^{-8}$$

$$i_{corr} = 3.56934 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00350 \text{ mm/yr}$$

Data: C22 Apr 84 (Method I) pg. 71

C22 Apr 84 (Method II) pg. 71

continued on pg. 71

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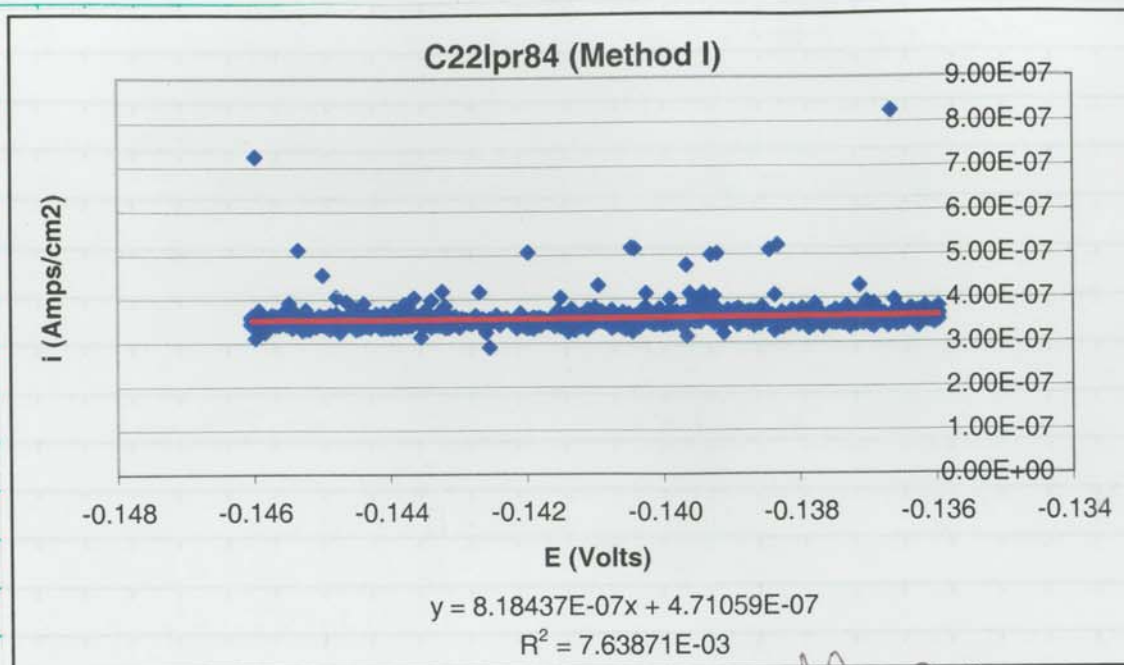
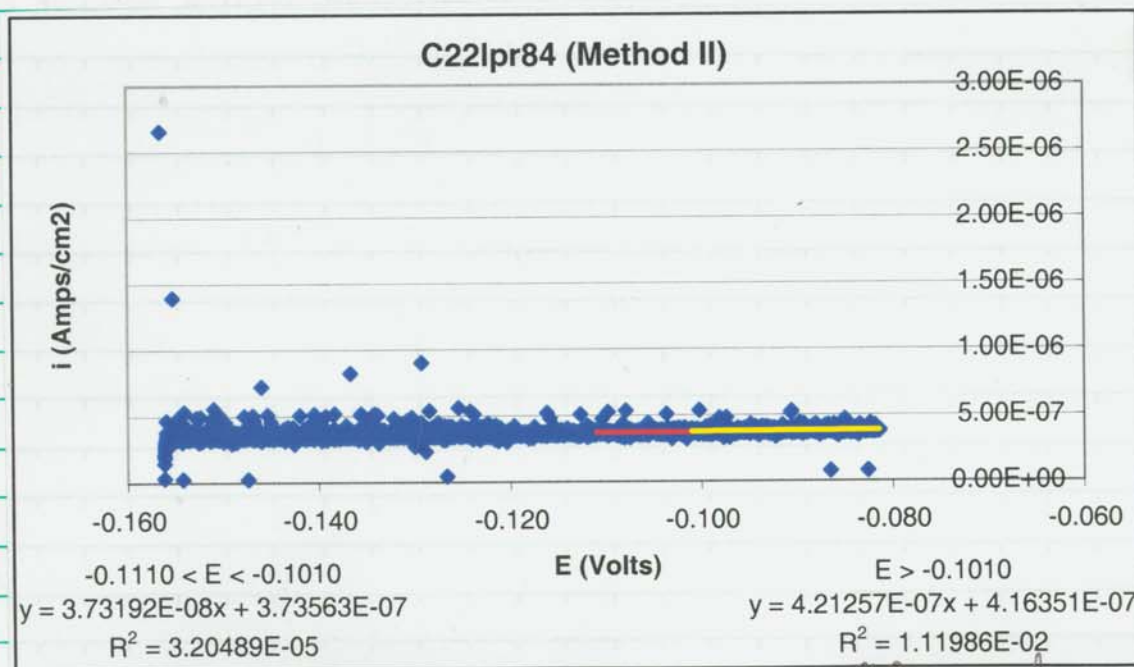
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Polarization Resistance Test for Alloy C-22 (from pg. 70)

Date: _____

John Boett
8/6/02John Boett
8/6/02

continued on pg. 72

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Polarization Resistance Test For Alloy C-22 (From pg 71)

Test:

JB 8/16/2
~~C22 Apr 84~~ C22 Apr 85Scan: -15 mV to ~~+60~~ +60 mV vs. open circuit potential

Scan rate: 0.001 mV/second

 $E_{\text{corr}} = -0.1103$

Results: Method I (See Formulas in Notebook 520, pg. 11)

$$(dE/dI)_{E_{\text{corr}}} = -7.15925 \times 10^{-7}$$

$$R_p = -1.3968 \times 10^6 \Omega \text{ cm}^2$$

$$i_{\text{corr}} = -3.7285 \times 10^{-8} \text{ A/cm}^2$$

$$C.R. = -0.000365 \text{ mm/yr}$$

Method II (see Formulas in Notebook 520, pg. 11)

A. Scan Data +30 mV to +40 mV vs. open circuit potential
($E = -0.0703$)

$$b = 4.05205 \times 10^{-7}$$

$$m = 7.54481 \times 10^{-7}$$

$$i_{\text{corr}} = 3.21986 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00316 \text{ mm/yr}$$

B. Scan Data +40 mV to +60 mV vs. open circuit potential
($E = -0.0703$)

$$b = 3.80672 \times 10^{-7}$$

$$m = 4.62587 \times 10^{-7}$$

$$i_{\text{corr}} = 3.29645 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00323 \text{ mm/yr}$$

Data: C22 Apr 85 (Method I) pg 73

C22 Apr 85 (Method II) pg 73

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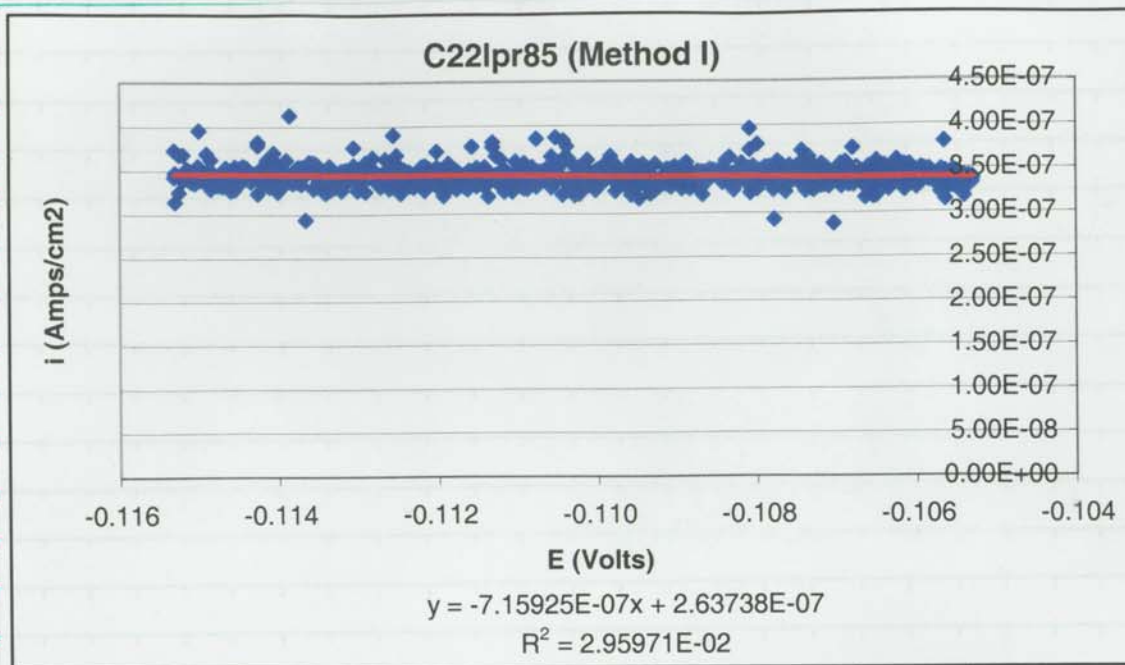
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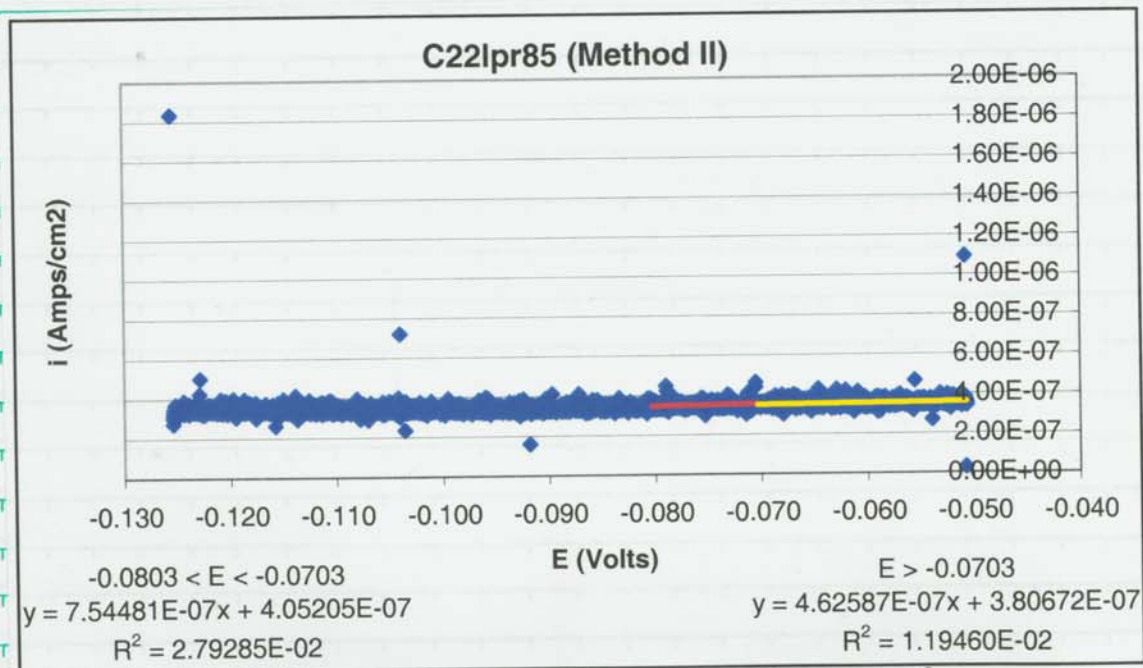
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Polarization Resistance Test for Alloy C-22 (from pg. 72)

Data:



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~~Polarization Resistance Test for Alloy C-22 (from pg 73)~~ JS 8/1/02
Electrochemical Impedance Test for alloy C-22

Test: C-22 for JS 8/1/02 Objective: same as pg 73

Specimen: C-22 heat: 22 77-8-3175 Thermally Aged @ 870°C for 4 hours;
polished to a 600 grit finish; same specimen as pg 48

start wt: 11.9314g Sartorius Genie S/N 12881055 cal 6/4/02 due: 12/4/02
End wt: 11.93943g

Solution: 0.028M NaCl
3.296g NaCl Lot: 020814
+ DI H₂O up to 2000ml

pH start: 5.592 Orion 720 A S/N 005885 cal: 7/10/02 due: 7/10/03
pH End: 6.108 pH Probe #13-620-296 S/N 1100208

cell info: Area: 8cm²
density: 8.69 g/cm³
Equivalent: 26.04

Impedance Analyzer: Solartron 1260

Counter Electrode: Pt fly
Fisher QD 4/3/03

Reference: Fisher 13-620-52 S/N 0052132

Temperature: 80°C Hg thermometer S/N H98-102 cal 4/22/02 due: 4/22/03

E_{corr}: -319mV Keithley 614 S/N 704936 cal 5/26/02 due: 5/26/03
E_{ref}: 127.5mV

Solution Deaerated with 99.999% N₂

Specimen Examination: No staining on surface. No visible signs of corrosion on specimen

Continued on pg 75

Witnessed & Understood by me,

Date

Invented by

Date

Recorded by

John Post 8/1/02

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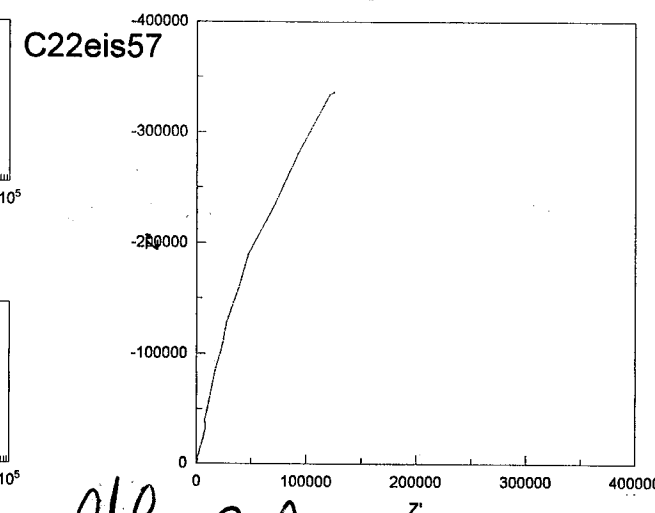
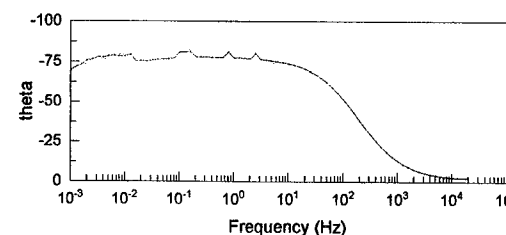
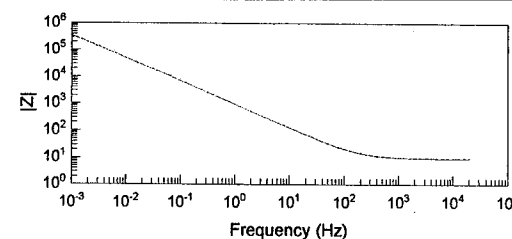
~~Polarization Resistance Test for Alloy C-22 (from pg 74)~~ JS 8/1/02
Electrochemical Impedance Test for Alloy C-22

Test: C-22 eis 77

JS 8/1/02
Scan: Initial Frequency: 20000 Hz
Final Frequency: 0.001 Hz
JS 8/1/02
10 steps per decade

Integration Time: 5 seconds
Delay: 2 seconds

Data: JS 8/1/02 C-22 eis 77



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Continued on pg 76

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Date

Invented by

Date

Recorded by

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From Page No. _____ Electrochemical Impedance Test for Alloy C-22 (from pg. 75)

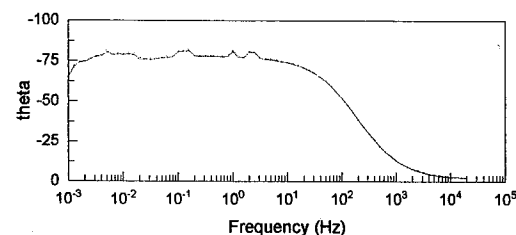
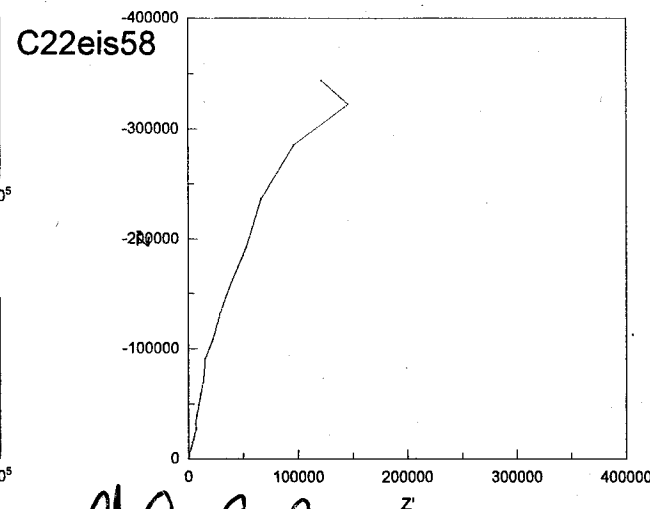
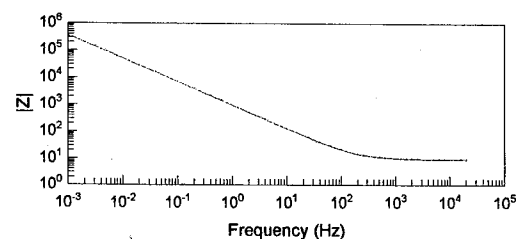
Test: C22eis 78

Initial Frequency: 20000 Hz
Final Frequency: 0.001 Hz

10 steps per decade

Integration time: 5 seconds
Delay: 2 seconds

Date: C22eis 78



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Invented by _____

Date _____

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8/6/02

From Page No. _____ Electrochemical Impedance Test for Alloy C-22 (from pg. 76)

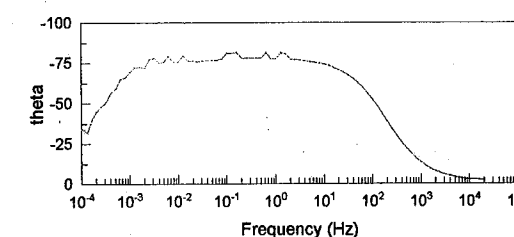
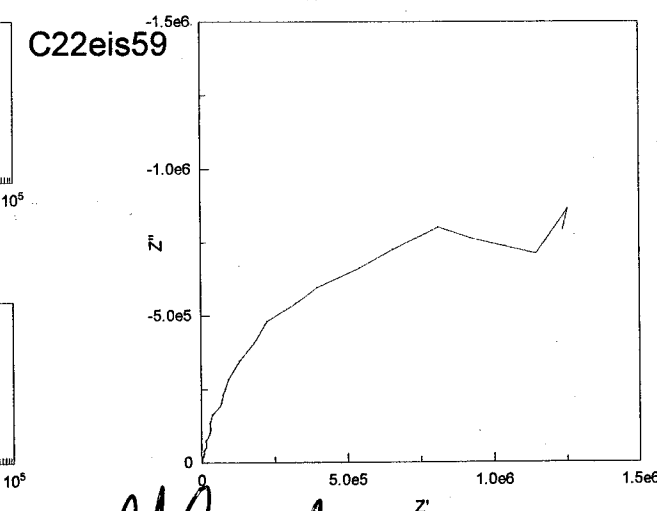
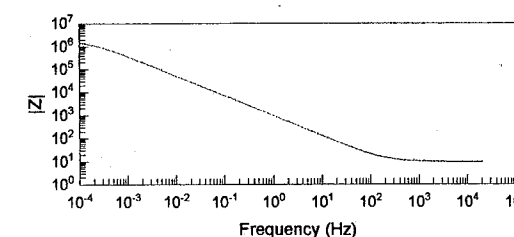
Test: C22eis 79

Initial Frequency: 20000 Hz
Final Frequency: 0.0001 Hz

10 steps per decade.

Integration time: 5 seconds
Delay: 2 seconds

Date: C22eis 79



Jhr Bat 8/6/02

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Witnessed & Understood by me, _____

Date _____

Invented by _____

Date _____

Recorded by _____

Jhr Bat

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Polarization Resistance Test for Alloy 22

Objectize: same as pg. 1

Specimen: C-22 Heat: 2277-8-3175 Thermally Aged at 870°C for 4 hours
Polished to a 600 grit finish same test specimen as pg. 46
Start wt: 11.93949 g Sartorius grains S/N 12809059 cal 6/4/02
End wt: 11.93943 g due 12/4/02

Solution: 0.028M NaCl
3.296 g NaCl Lot: 020814
+ DI H₂O up to 2000ml

pH start: 5.552 Oyster 720A S/N 205885 cal 7/10/02 due 7/10/03
pH End: 6.108 pH probe # 13620-246 S/N 1100208

Potentiostat: Solartron 1287

Counter electrode: Pt flag

Reference: Fisher 13-620-52 S/N 0052132

Temperature: 60°C Hg Thermometer S/N H98-162 cal 1/22/02 due 1/22/03

E_{corr} = -314mV Keithley 617 S/N 704936 cal 5/26/02 due 5/26/03
E_{pb} = 23.7mV

Solution Deaerated with 99.999% N₂

Specimen Examination: No staining on specimen - No signs of visible corrosion on specimen

continued on pg 79

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Polarization Resistance Test for Alloy 22 (Cont pg 78)

Corrosion Rate v. Scan Rate

Corrosion Rate Calculated By Method I (Notebook 520, pg. 11)
Scan: -5 mV to +5 mV vs. Open Circuit Potential
Alloy C-22 Heat: 2277-8-3175
Temperature= 60 °C
Deaerated with 99.999% N₂

Scan Rate (mV/second)	Corrosion Rate
0.003	0.0003
0.01	0.0000
0.1	0.0004
1	0.0011

Corrosion Rate v. Scan Rate

Corrosion Rate Calculated By Method I (Notebook 520, pg. 11)
Scan: +30 mV to +40 mV vs. Open Circuit Potential
Alloy C-22 Heat: 2277-8-3175
Temperature= 60 °C
Deaerated with 99.999% N₂

Scan Rate (mV/second)	Corrosion Rate
0.003	0.0028
0.01	0.0022
0.1	0.0036
1	0.0048

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8/8/02

Corrosion Rate v. Scan Rate

Corrosion Rate Calculated By Method I (Notebook 520, pg. 11)
Data: +40 mV to +60 mV vs. Open Circuit Potential
Alloy C-22 Heat: 2277-8-3175
Temperature= 60 °C
Deaerated with 99.999% N₂

Scan Rate (mV/second)	Corrosion Rate
0.003	0.0035
0.01	0.0035
0.1	0.0036
1	0.0056

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Polarization Resistance Test La Alloy 22 (from pg 78)

Test: C22 Apr 86

Scan: -15 mV to +60 mV vs. open circuit potential

Scan Rate: 1 mV/second

E_{corr}: 0.0751 V vs. SCE

Results: Method I (see Formulas in Notebook 520, pg. 11)

$$i_{corr} = 2.31172 \times 10^{-7} \text{ A/cm}^2$$

$$R_p = 4.3258 \times 10^5 \text{ } \Omega \cdot \text{cm}^2$$

$$i_{corr} = 1.2039 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00118 \text{ mm/yr}$$

Method II (see Formulas in Notebook 520, pg. 11)

A. For Data: +30 mV to +40 mV vs. open circuit potential
(0.1051 < E < 0.1151)

$$b = 3.49454 \times 10^{-7}$$

$$m = 2.02754 \times 10^{-6}$$

$$i_{corr} = 5.01752 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00462 \text{ mm/yr}$$

B. For Data: +40 mV to +60 mV vs. open circuit potential
(E > 0.1151)

$$b = 5.34023 \times 10^{-7}$$

$$m = 4.91354 \times 10^{-7}$$

$$i_{corr} = 5.70924 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00559 \text{ mm/yr}$$

Data: C22 Apr 86 (Method I) pg. 81

C22 Apr 86 (Method II) pg. 81

continued on pg. 81

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J. H. Bart

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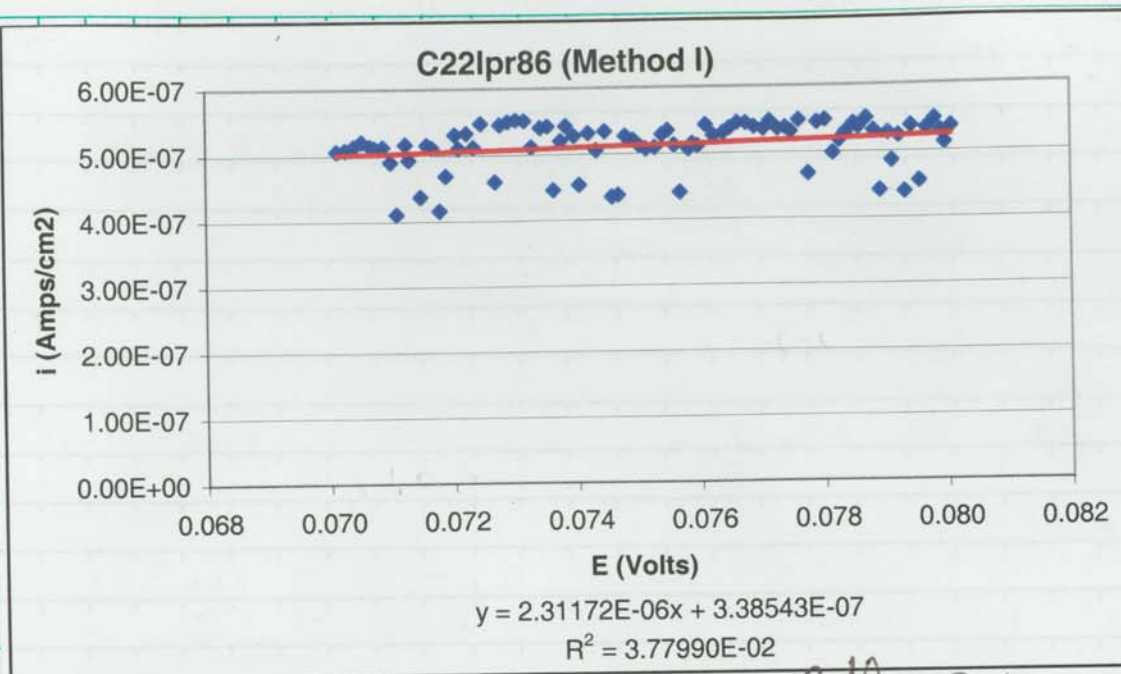
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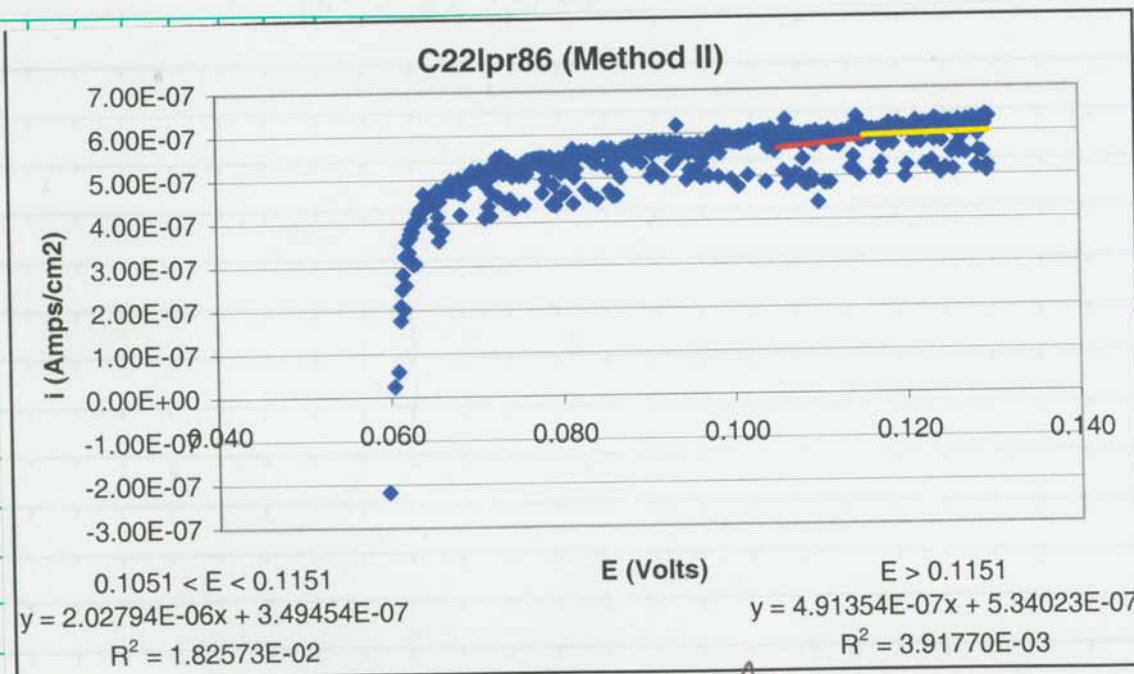
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Polarization Resistance Test for Alloy 22 (from pg. 88)

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John Boet 8/6/02



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continuation pg. 82

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Polarization Resistance test on Alloy 22 (from pg 81)

Test: C22 Apr 87

Scan: -15mV to +60mV vs. open circuit potential

scan rate: 0.1 mV/second

 $E_{\text{corr}} = 0.0807 \text{ V vs. SCE}$

Results: Method I (see formulas in Notebook C22, pg 11)

$$(dE/dI)_{E_{\text{corr}}} = 7.21921 \times 10^{-7}$$

$$R_p = 1.3852 \times 10^6$$

$$i_{\text{corr}} = 3.7598 \times 10^{-8} \text{ A/cm}^2$$

$$\text{C.R.} = 0.000368 \text{ mm/yr}$$

Method II (see formulas in Notebook C22, pg 11)

A. For Data: +30mV to +40mV vs. open circuit potential
($0.1107 < E < 0.1207$)

$$b = 3.41328 \times 10^{-7}$$

DD 4/3/03

$$m = 3.99250 \times 10^{-7} \quad 3.99250 \times 10^{-7}$$

$$i_{\text{corr}} = 3.73547 \times 10^{-8} \text{ A/cm}^2$$

$$\text{C.R.} = 0.00366 \times 10^{-3} \text{ mm/yr}$$

B. For Data: +40mV to +60mV vs open circuit potential
($E > 0.1207$)

$$b = 3.24353 \times 10^{-7}$$

$$m = 5.44036 \times 10^{-7}$$

$$i_{\text{corr}} = 3.68257 \times 10^{-8}$$

$$\text{C.R.} = 0.00361 \text{ mm/yr}$$

Date: C22 Apr 87 (Method I) pg 83

C22 Apr 87 (Method II) pg 83

continued on pg 83

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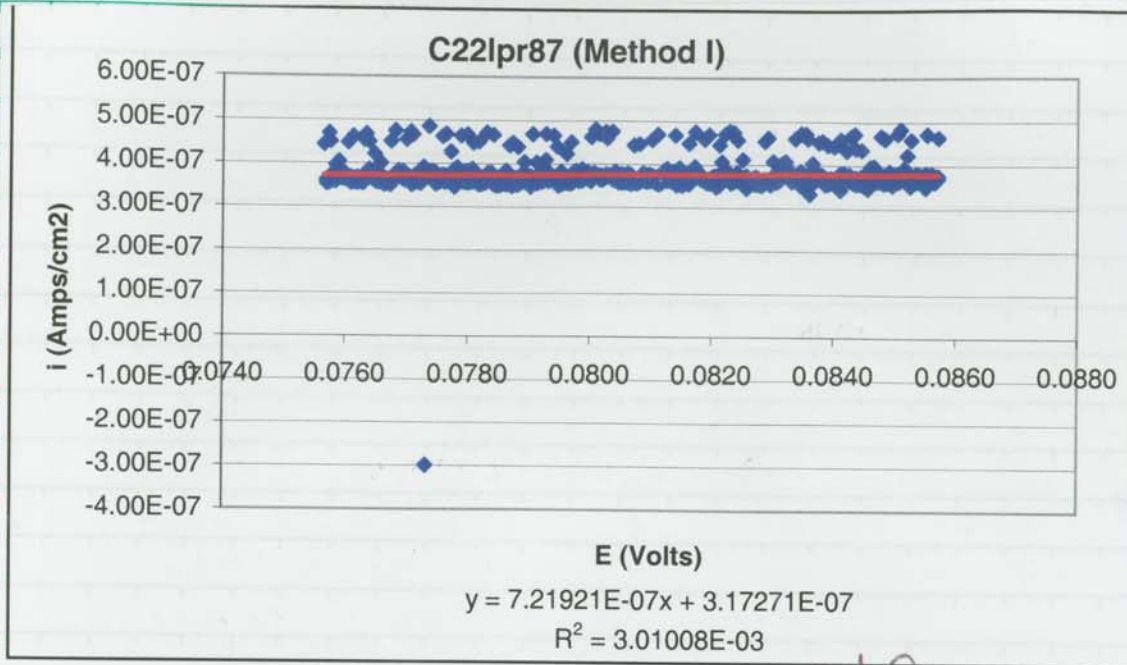
Alan Bond

4/6/02

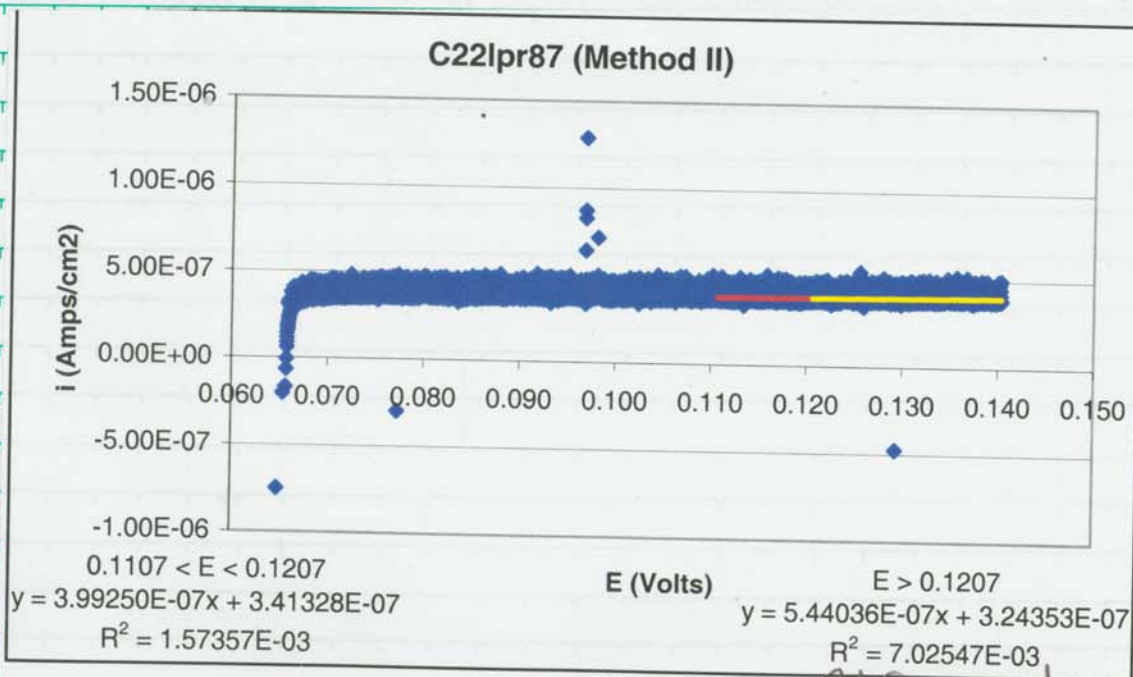
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Polarization Resistance Test for Alloy 22 (from pg. 82)

Date:



John Bost 8/6/02



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Polarization Resistance Test On Alloy 22 (From pg. 83)

Test: C22 Apr 88

Scan: -15mV to +60mV vs open circuit potential

Scan Rate: 0.01 mV/second

E_{corr}: 0.0840V vs. SCE

Results: Method I (see formulas in Notebook 520, pg. 11)

$$Q_{B/A} = -6.52494 \times 10^{-8}$$

$$R_p = -1.5326 \times 10^{17} \Omega \cdot \text{cm}^2$$

$$i_{corr} = -3.3982 \times 10^{-9} \text{ A/cm}^2$$

$$C.R. = 0.000333 \text{ mm/yr}$$

Method II (see formulas in Notebook 520, pg. 11)

A. For Data: +30mV to +40mV vs open circuit potential
(0.1140 < E < 0.1240)

$$b = \frac{8.1746 \times 10^{-7}}{2.63693 \times 10^{-7}} = 3.099$$

$$m = \frac{2.63693 \times 10^{-7}}{8.1746 \times 10^{-7}} = 0.323$$

$$i_{corr} = \frac{8.1746 \times 10^{-7}}{3.3231 \times 10^{-7}} = 2.46 \text{ A/cm}^2$$

$$C.R. = 0.00326 \text{ mm/yr}$$

B. For Data: +40mV to +60mV vs open circuit potential
(E > 0.1240)

$$b = 3.4158 \times 10^{-7}$$

$$m = 1.71335 \times 10^{-7}$$

$$i_{corr} = \frac{0.00326 \text{ mV}}{3.55976 \times 10^{-7} \text{ A/cm}^2} = 9.16 \times 10^{-4} \text{ A/cm}^2$$

$$C.R. = 0.00349 \text{ mm/yr}$$

Data: C22 Apr 88 (Method I) pg. 85

C22 Apr 88 (Method II) pg. 85

continued on pg. 85

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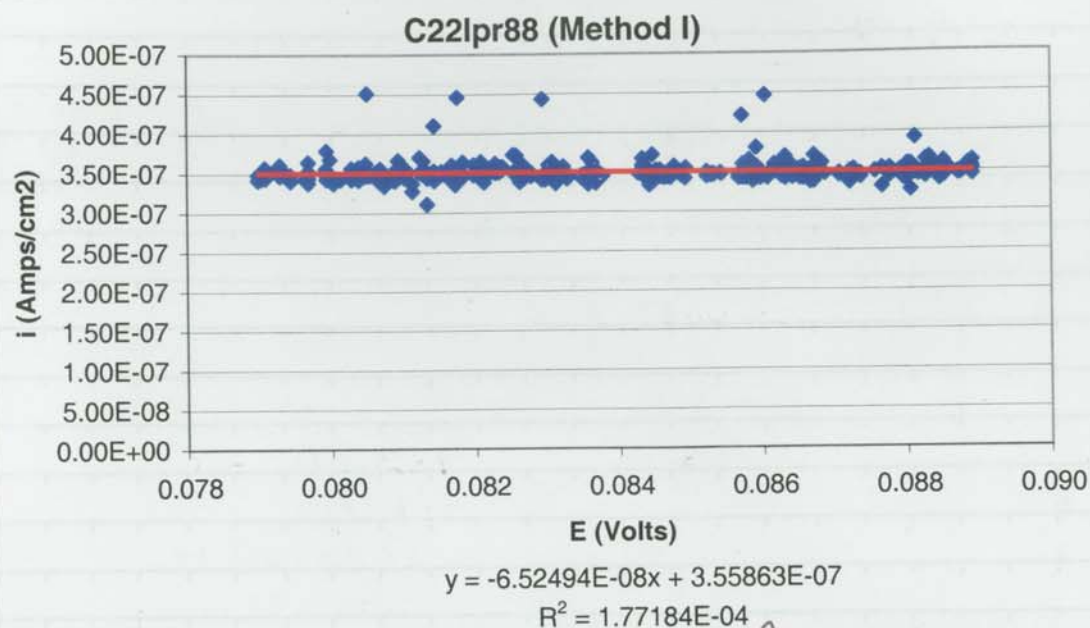
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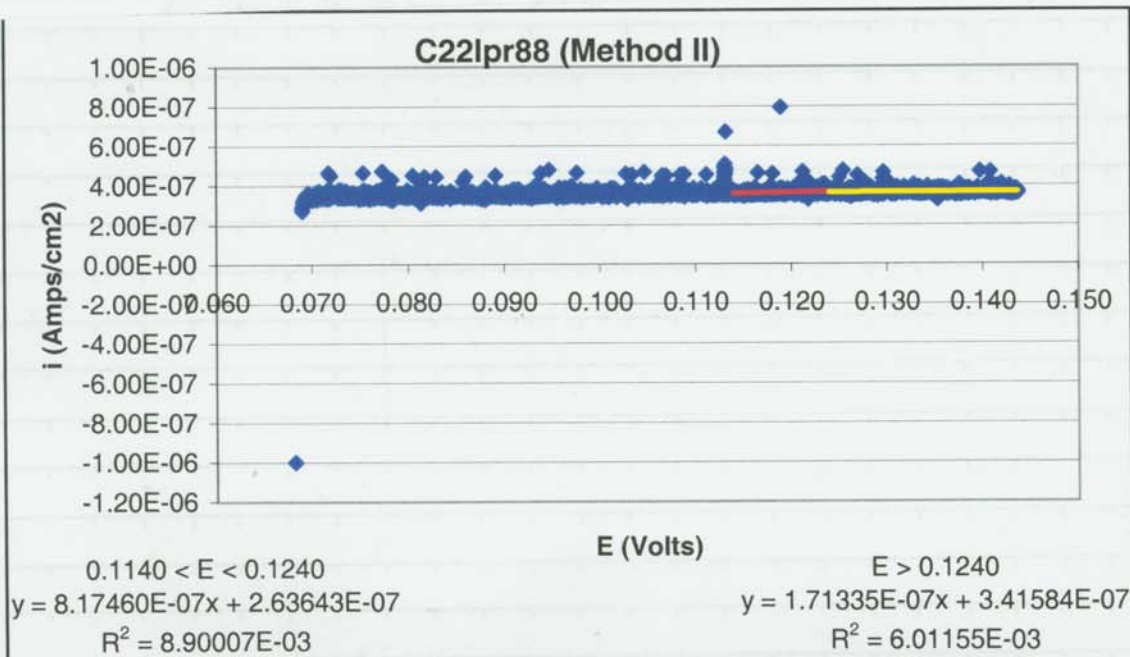
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Polarization Resistance Test for Alloy 22 (from pg. 84)

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JAL Bot 8/6/02



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Polarization Resistance Test on Alloy 22 (from pg. 85)

Test: C22 for 89

Scan: -15mV to +60mV vs. open circuit potential

Scan Rate: 0.005 mV/second

 $E_{corr} = 0.0881 \text{ V vs. SCE}$

Results: Method I (see formula in Notebook 522, pg. 11)

$$\left(\frac{dE}{dI}\right)_{E_{corr}} = 2.3 \frac{RT}{nF} = 5.63600 \times 10^{-2}$$

$$R_p = 1.7743 \times 10^6 \Omega \cdot \text{cm}^2$$

$$i_{corr} = 2.9352 \times 10^{-8} \text{ A/cm}^2$$

$$CR = 0.000288 \text{ mm/yr}$$

Method II (see formula in Notebook 522, pg. 11)

A. Log Data: +30mV to +40mV vs. open circuit potential
($0.1181 < E < 0.1281$)

$$b = 3.13740 \times 10^{-7}$$

$$m = 4.15513 \times 10^{-7}$$

$$i_{corr} = 2.3 \frac{RT}{nF} = 3.58247 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00343 \text{ mm/yr}$$

B. Log Data: +40mV to +60mV vs. open circuit potential
($E > 0.1281$)

$$b = 3.56105 \times 10^{-7}$$

$$m = 7.80664 \times 10^{-8}$$

$$i_{corr} = 3.62983 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00352 \text{ mm/yr}$$

Date: C22 for 89 (Method I) pg. 87

C22 for 89 (Method II) pg. 87

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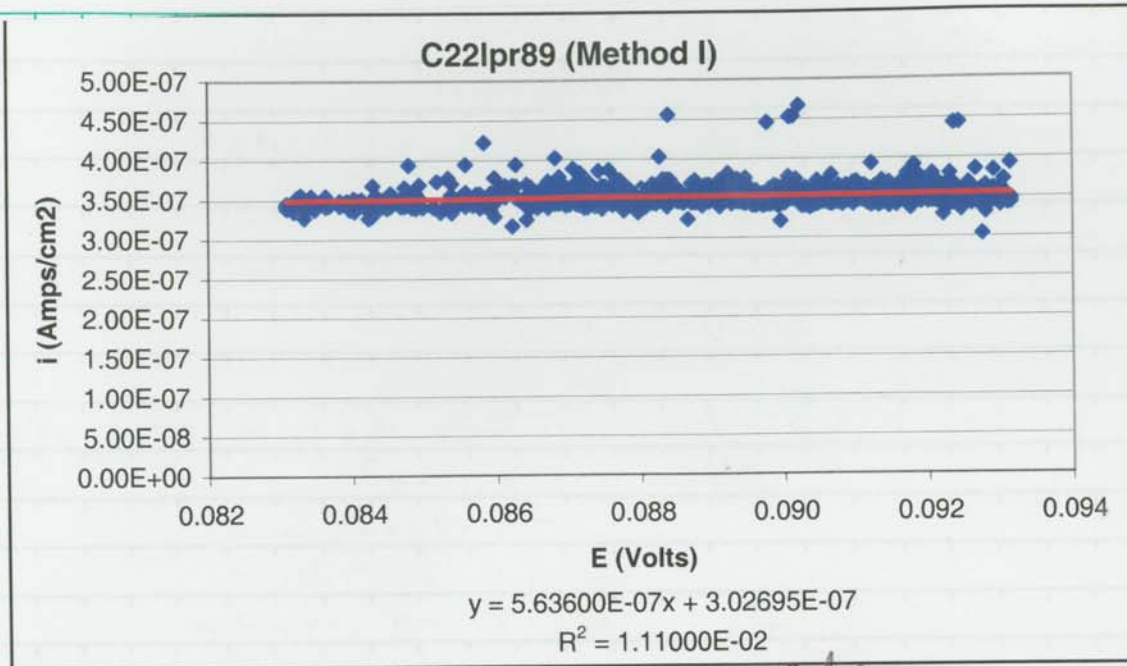
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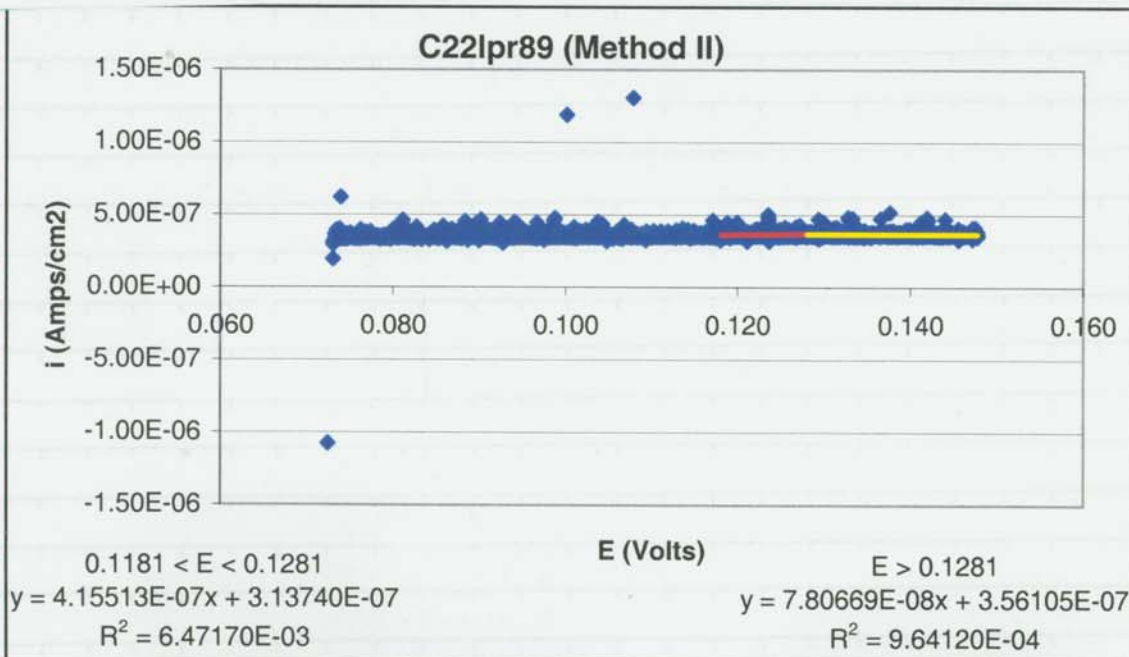
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Polarization Resistance Test On Alloy 22 (from pg. 86)

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JH Bat



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Polarization Resistance Test Cor Alloy C22 (From pg 87)

Test: C22 Apr 90

Scan: -15mV to +60mV vs. open circuit potential

Scan Rate: 0.001 mV/second

E_{corr}: 0.0915 V vs. SCE

Results: Method I (see Formulas in Notebook 520, pg. 11)

$$(dE/dI)_{corr} = 1.26210 \times 10^{-8}$$

$$R_p = 7.9233 \times 10^7 \Omega \cdot \text{cm}^2$$

$$i_{corr} = 6.57 \times 10^{-10} \text{ A/cm}^2$$

$$C.R. = 0.00000 \text{ mm/yr}$$

Method II (see Formulas in Notebook 520, pg. 11)

A. Scan Data: +30mV to +40mV vs. open circuit potential
(0.1215 < E < 0.1315)

$$b = 2.41148 \times 10^{-7}$$

$$m = 9.06622 \times 10^{-7}$$

$$i_{corr} = 3.24104 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.00318 \text{ mm/yr}$$

B. Scan Data +40mV to +60mV vs. open circuit potential
(E > 0.1315)

$$b = 2.90263 \times 10^{-7}$$

$$m = 4.89318 \times 10^{-7}$$

$$i_{corr} = 3.35043 \times 10^{-7} \text{ A/cm}^2$$

$$C.R. = 0.06328 \text{ mm/yr}$$

Date: C22 Apr 90 (Method I) pg. 87

C22 Apr 90 (Method II) pg. 88 JS 8/6/02

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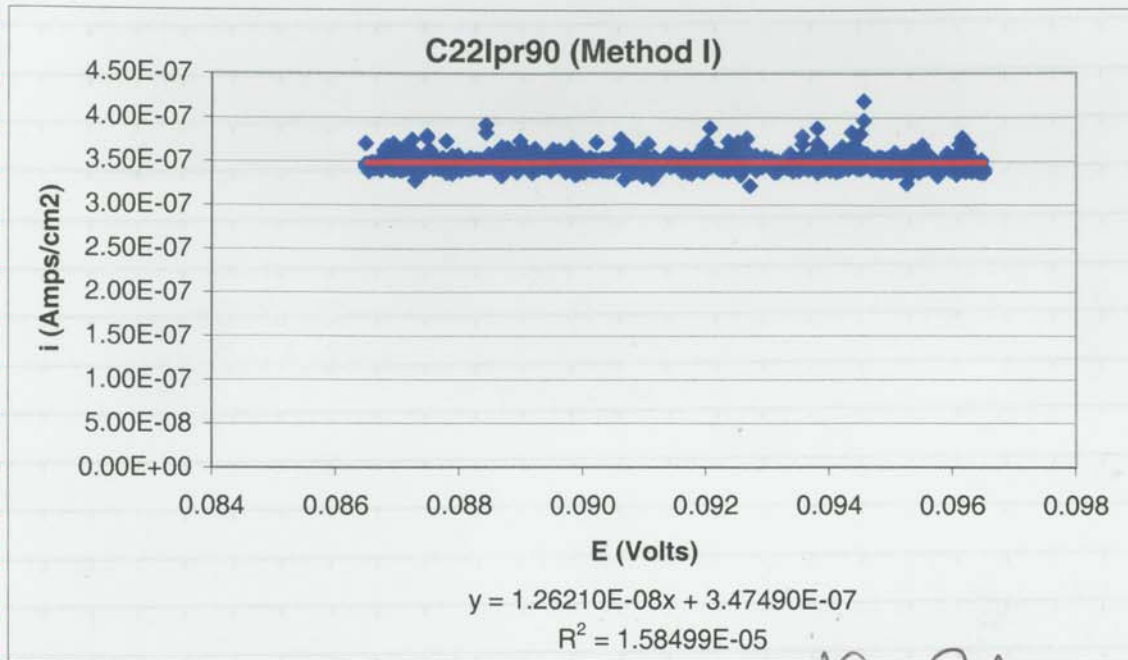
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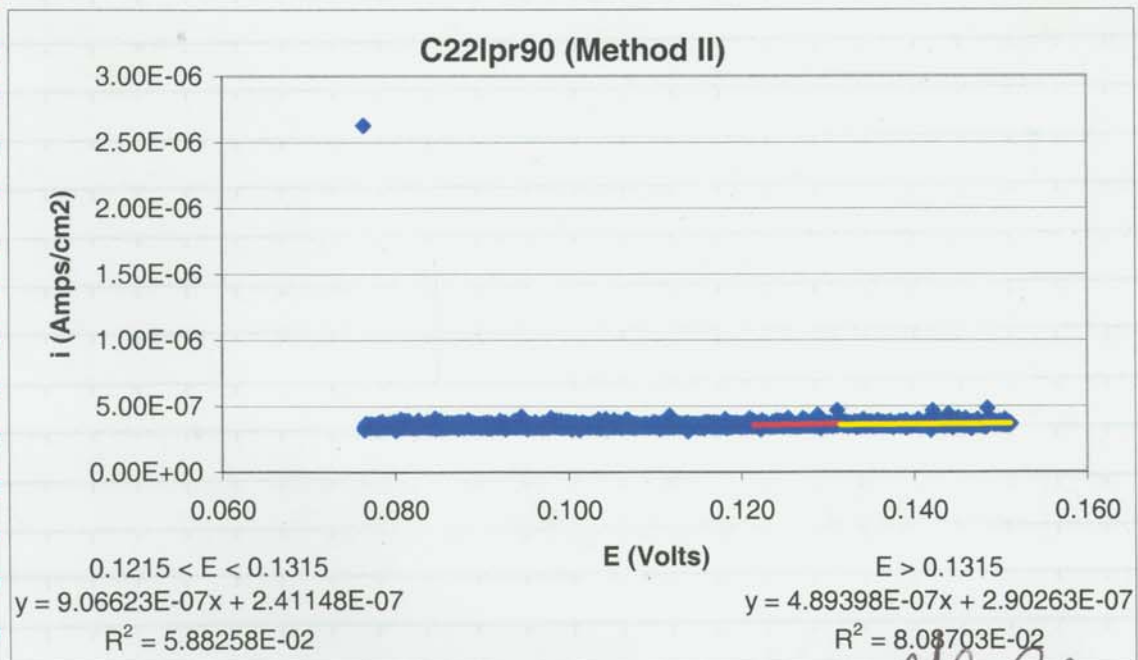
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Polarization Resistance Test for Alloy C22 (from pg. 88)



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8/8/02



JH Bat
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JH Bat

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Electrochemical Impedance Test for Alloy 22

Objective: same as pg 2

Specimen: Alloy 22 Lot: 2271-8-3175 Thermally aged @ 870°C for 4 hours; polished to a 600 grit finish; same test specimen as pg. 46

Start wt: 11.93945g Sartorius Gering S/N 12889 099 cal 6/4/02
End wt: 11.93943g due 12/4/02

Solution: 0.028 M NaCl
3.2965g NaCl Lot 020814
+ DI H₂O up to 200ml

pH start: 5.592 Orion 720A S/N 805 885 cal: 7/10/02 due 7/10/03
pH End: 6.108 pH probe #13-620-246 S/N 1100208

Cell area: Area: 8cm²
Density: 8.69 g/cm³
Equivalent: 26.04

Impedance Analyzer: Solartron 1260

Counter Electrode: Pt Plug

Reference: Fisher 13-620-52 S/N 805232

Temperature: 60°C H₂ Thermometer S/N H98-162 cal 4/22/02 due 4/22/03

E_{corr}: -319mV Keithley 614 S/N 704936 cal 5/28/02 due 5/26/03
E_{pk}: 127.5mV

Solution Deaerated with 99.999% N₂

Specimen Examination? No staining on specimen: No visible signs of corrosion on specimen

continued on pg. 91

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John Bart

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Electrochemical Impedance Test for Alloy 22 (from pg 90)

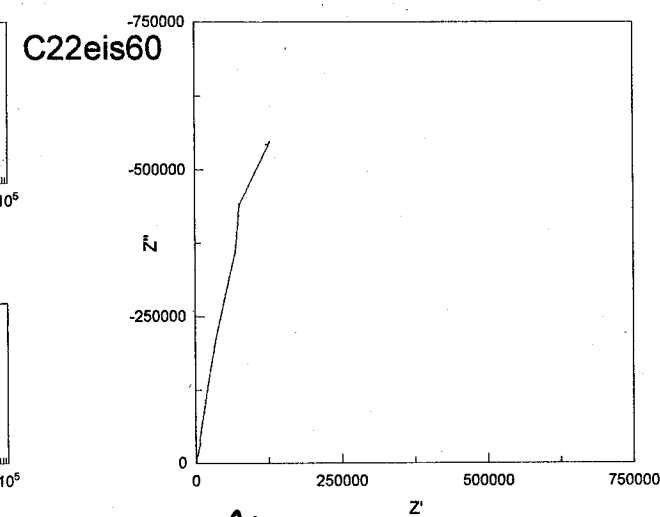
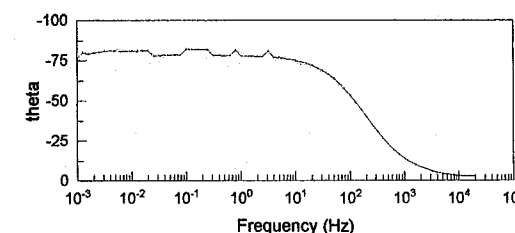
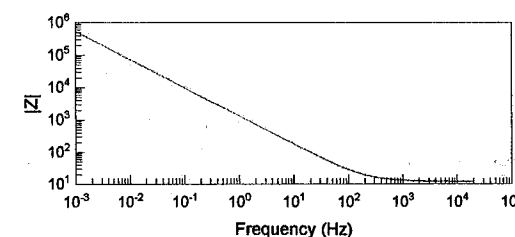
Test: C22eis60

Initial frequency: 20000 Hz
Final frequency: 0.001 Hz

10 steps per Decade

Integration time: 5 seconds
Delay: 2 seconds

Data: C22eis60



John Bart
8/7/02

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Electrochemical Impedance Test for Alloy 22 (From pg. 91)

JB 8/6/02
Object 70

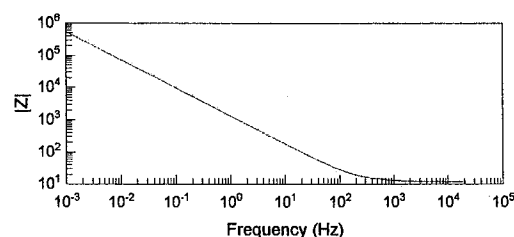
Test: C22e3 61

Initial Frequency: 20000 Hz
Final Frequency: 0.001 Hz

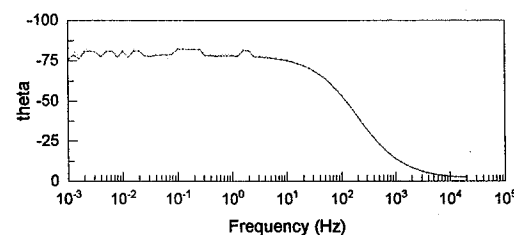
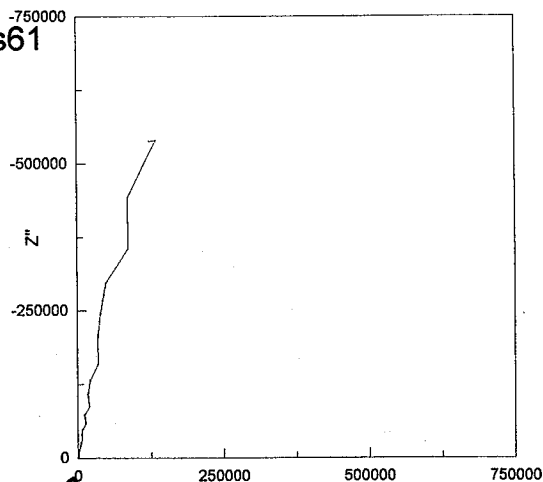
10 steps per decade

Integration time 5 seconds
Delay: 2 seconds

Data: C22e3 61



C22e3 61

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Electrochemical Impedance Test for Alloy 22 (From pg. 92)

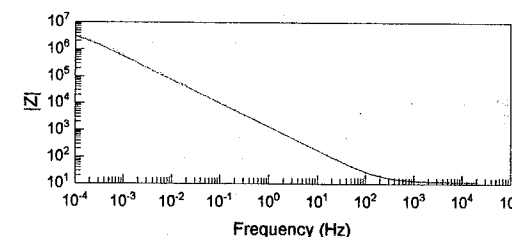
Test: C22e3 62

Initial Frequency: 20000 Hz
Final Frequency: 0.001 Hz

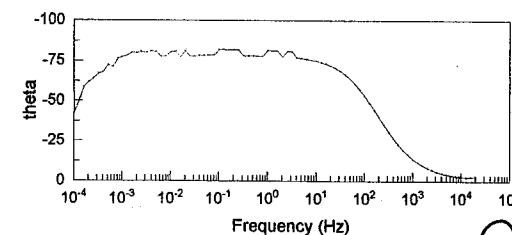
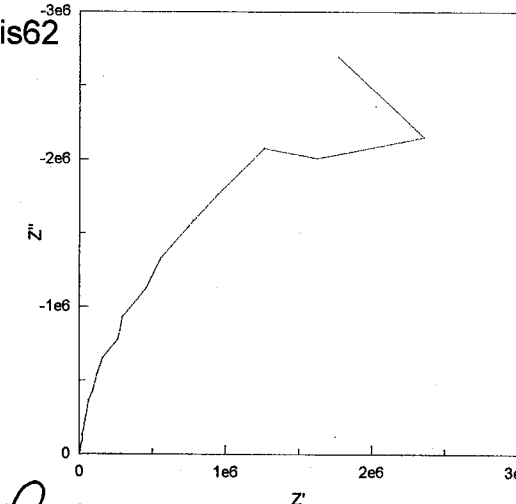
10 steps per decade

Integration time 5 seconds
Delay: 2 seconds

Data: C22e3 62



C22e3 62

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Continued Testing in Notebook 541

I have reviewed this scientific notebook and find it in compliance with QAP-001. There is sufficient information regarding procedures used for conducting tests, acquiring and analyzing data so that another qualified individual could repeat the activity.

W. J. Ryan 4/3/03

To Page No. _____

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John Boer

8/8/02